

RL78/G11

R01DS0282EJ0110

RENESAS MCU

Rev. 1.10

Dec 28, 2016

True Low Power Platform (as low as 58.3  $\mu$ A/MHz, and 0.64  $\mu$ A for LVD), 1.6 V to 5.5 V operation, 16 Kbyte Flash, 33 DMIPS at 24 MHz, for General Purpose Applications

## 1. OUTLINE

### 1.1 Features

Ultra-low power consumption technology

- V<sub>DD</sub> = 1.6 V to 5.5 V
- HALT mode
- STOP mode
- SNOOZE mode

RL78 CPU core

- CISC architecture with 3-stage pipeline
- Minimum instruction execution time: Can be changed from high speed (0.04167  $\mu$ s: @ 24 MHz operation with high-speed on-chip oscillator) to ultra-low speed (66.6  $\mu$ s: @ 15 kHz operation with low-speed on-chip oscillator clock)
- Multiply/divide/multiply & accumulate instructions are supported.
- Address space: 1 Mbytes
- General-purpose registers: (8-bit register  $\times$  8)  $\times$  4 banks
- On-chip RAM: 1.5 Kbytes

Code flash memory

- Code flash memory: 16 Kbytes
- Block size: 1 Kbytes
- On-chip debug function
- Self-programming (with boot swap function/flash shield window function)

Data flash memory

- Data flash memory: 2 Kbytes
- Back ground operation (BGO): Instructions can be executed from the program memory while rewriting the data flash memory.
- Number of rewrites: 1,000,000 times (TYP.)
- Voltage of rewrites: V<sub>DD</sub> = 1.8 to 5.5 V

High-speed on-chip oscillator

- Select from 48 MHz, 24 MHz, 16 MHz, 12 MHz, 8 MHz, 6 MHz, 4 MHz, 3 MHz, 2 MHz, and 1 MHz
- High accuracy:  $\pm$ 1.0% (V<sub>DD</sub> = 1.8 to 5.5 V, T<sub>A</sub> = -20 to +85°C)

Middle-speed on-chip oscillator

- Selectable from 4 MHz, 2 MHz, and 1 MHz.

Operating ambient temperature

- T<sub>A</sub> = -40 to +85°C (A: Consumer applications)
- T<sub>A</sub> = -40 to +105°C (G: Industrial applications)

Power management and reset function

- On-chip power-on-reset (POR) circuit
- On-chip voltage detector (LVD) (Select interrupt and reset from 14 levels)

Data transfer controller (DTC)

- Transfer modes: Normal transfer mode, repeat transfer mode, block transfer mode
- Activation sources: Activated by interrupt sources.
- Chain transfer function

Event link controller (ELC)

- Event signals of 18 types can be linked to the specified peripheral function.

Serial interfaces

- CSI: 4 channels
- UART: 2 channel
- I<sup>2</sup>C/simplified I<sup>2</sup>C: 4 channels
- Multimaster I<sup>2</sup>C: 2 channels

Timers

- 16-bit timer (TAU): 4 channels
- TKB: 1 channel
- 12-bit interval timer: 1 channel
- 8-bit interval timer: 2 channels
- Watchdog timer: 1 channel

## A/D converter

- 8/10-bit resolution A/D converter ( $V_{DD} = 1.6$  to  $5.5$  V)
- Analog input: 10 to 11 channels
- Internal reference voltage ( $1.45$  V) and temperature sensor

## D/A converter

- 8/10-bit resolution D/A converter ( $V_{DD} = 1.6$  to  $5.5$  V)
- Analog input: 2 channels (channel 1: output to the ANO1 pin, channel 0: output to the comparator)
- Output voltage:  $0$  V to  $V_{DD}$
- Real-time output function

## Comparator

- 2 channels
- Operating modes: Comparator high-speed mode, comparator low-speed mode, window mode

## PGA

- 1 channels

## I/O ports

- I/O port: 17 to 21 (N-ch open drain I/O [ $V_{DD}$  withstand voltage]: 9 to 14)
- Can be set to N-ch open drain, TTL input buffer, and on-chip pull-up resistor
- Different potential interface: Can connect to a  $1.8/2.5/3.0$  V device
- On-chip key interrupt function
- On-chip clock output/buzzer output controller

## Others

- On-chip BCD (binary-coded decimal) correction circuit
- On-chip data operation circuit

**Remark** The functions mounted depend on the product. See **1.6 Outline of Functions**.

## ○ ROM, RAM capacities

Flash ROM	Data flash	RAM	RL78/G11		
			20 pins	24 pins	25 pins
16 KB	2 KB	1.5 KB	R5F1056A	R5F1057A	R5F1058A

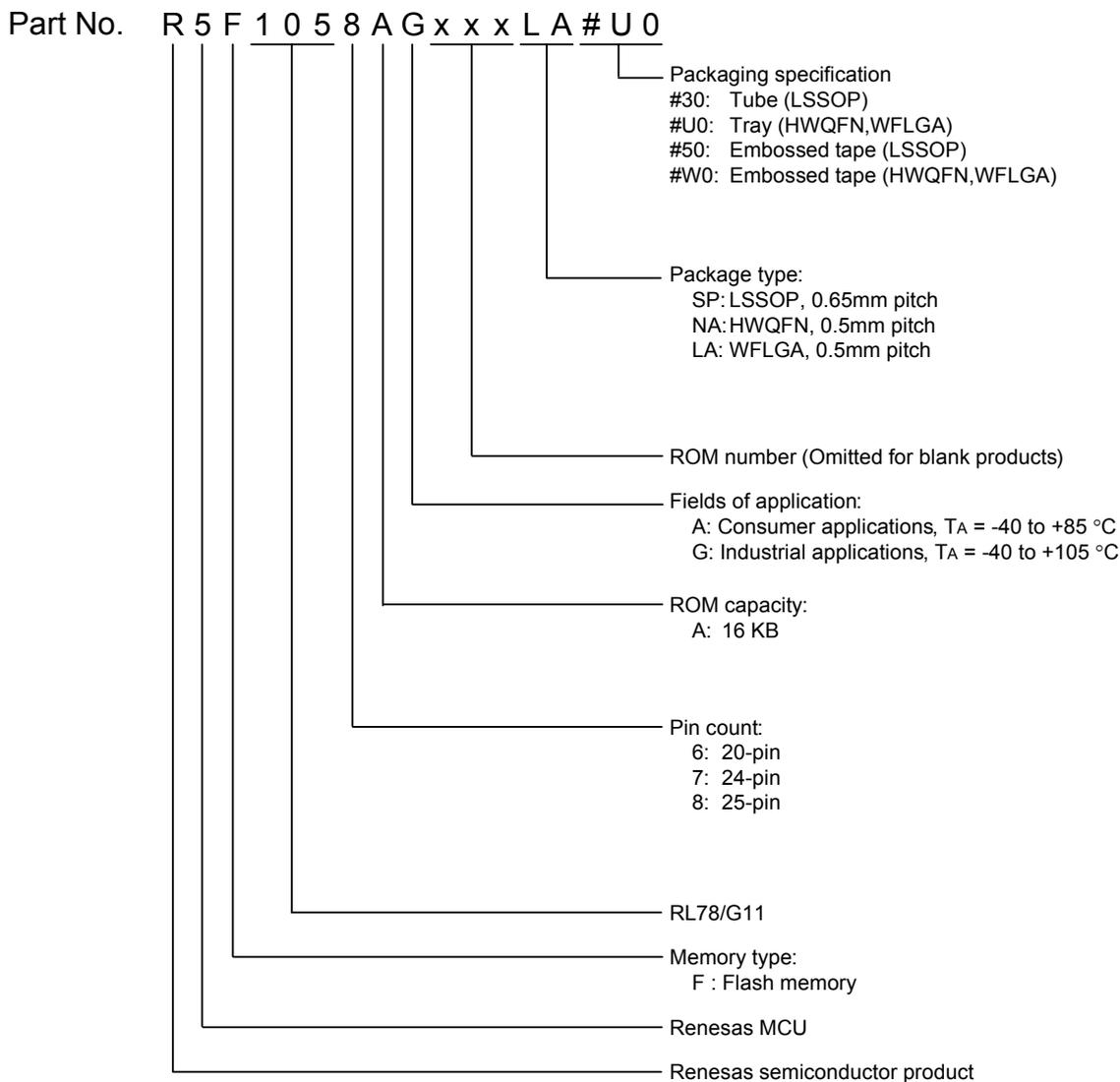
**Remark** The flash library uses RAM in self-programming and rewriting of the data flash memory. The target products and start address of the RAM areas used by the flash library are shown below.

R5F105xA (x = 6, 7, 8): Start address FF900H

For the RAM areas used by the flash library, see **Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944)**.

## 1.2 Ordering Information

Figure 1 - 1 Part Number, Memory Size, and Package of RL78/G11



Pin count	Package	Ordering Part Number
20 pins	20-pin plastic LSSOP (4.4 × 6.5 mm, 0.65 mm pitch)	R5F1056AGSP#30,R5F1056AASP#30 R5F1056AGSP#50,R5F1056AASP#50
24 pins	24-pin plastic HWQFN (4 × 4 mm, 0.50 mm pitch)	R5F1057AGNA#U0,R5F1057AANA#U0 R5F1057AGNA#W0,R5F1057AANA#W0
25 pins	25-pin plastic WFLGA (3 × 3 mm, 0.50 mm pitch)	R5F1058AGLA#U0,R5F1058AALA#U0 R5F1058AGLA#W0,R5F1058AALA#W0

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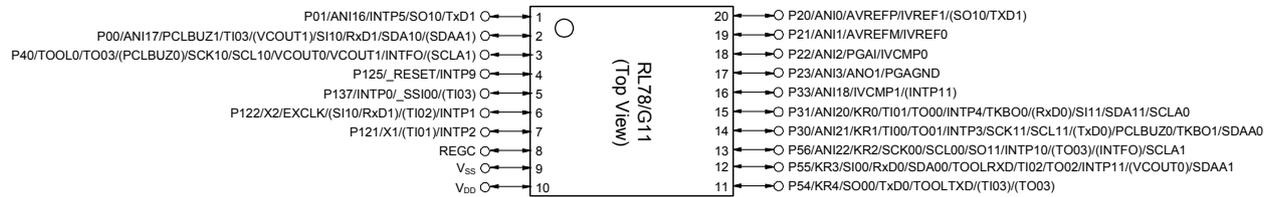
**Caution 1.** For the fields of application, refer to Figure 1 - 1 Part Number, Memory Size, and Package of RL78/G11.

**Caution 2.** The ordering part numbers represent the numbers at the time of publication. For the latest ordering part numbers, refer to the target product page of the Renesas Electronics website.

## 1.3 Pin Configuration (Top View)

### 1.3.1 20-pin products

- 20-pin plastic LSSOP (4.4 × 6.5 mm, 0.65 mm pitch)



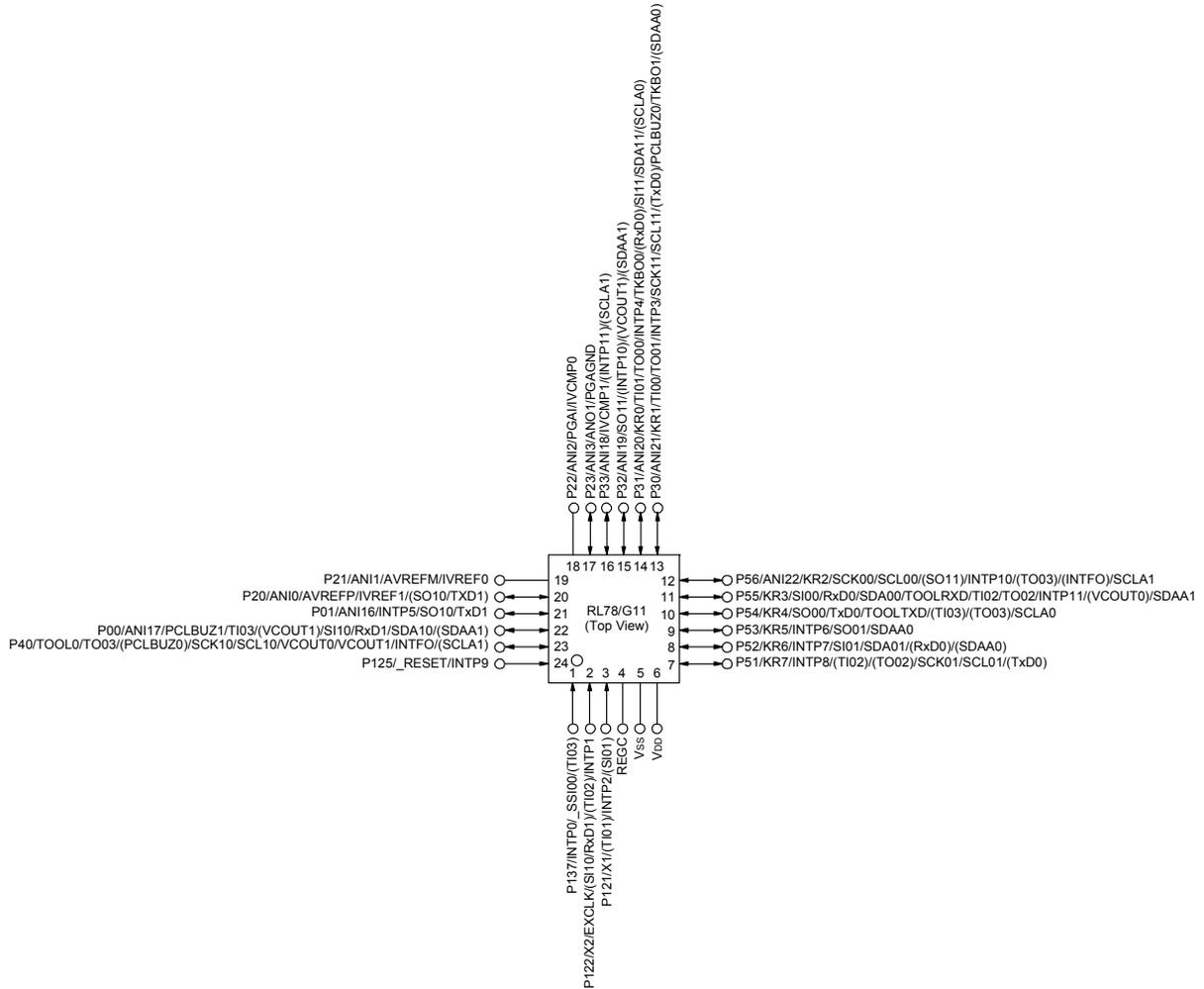
**Caution** Connect the REGC pin to V<sub>SS</sub> pin via a capacitor (0.47 to 1 μF).

**Remark 1.** For pin identification, see 1.4 Pin Identification.

**Remark 2.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0 to 3 (PIOR0 to PIOR3).

### 1.3.2 24-pin products

- 24-pin plastic HWQFN (4 × 4 mm, 0.5 mm pitch)



**Caution** Connect the REGC pin to Vss pin via a capacitor (0.47 to 1 μF).

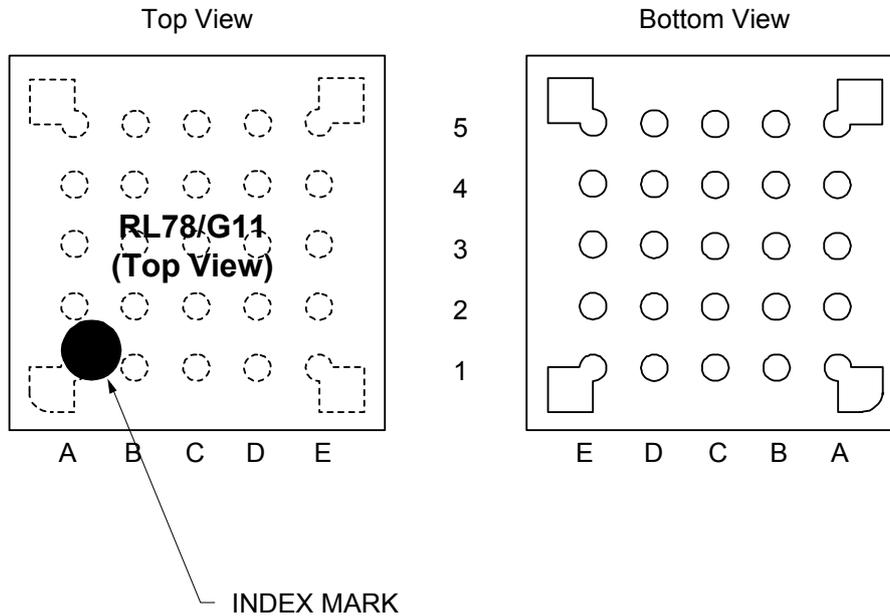
**Remark 1.** For pin identification, see 1.4 Pin Identification.

**Remark 2.** It is recommended to connect an exposed die pad to Vss.

**Remark 3.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0 to 3 (PIOR0 to PIOR3).

### 1.3.3 25-pin products

- 25-pin plastic WFLGA (3 × 3 mm, 0.5 mm pitch)



	A	B	C	D	E	
5	P40/TOOL0/TO03/(PC LBUZ0)/SCK10/SCL10 /VCOUT0/VCOUT1/INTFO/(SCLA1)	P125/RESET/INTP9	P01/ANI16/INTP5/SO10/TxD1	P20/ANI0/AVREFP/IVREF1/(SO10/TXD1)	P21/ANI1/AVREFM/IVREF0	5
4	P122/X2/EXCLK/(SI10 /RxD1)/(TI02)/INTP1	P137/INTP0/SSI00/(TI03)	P00/ANI17/PCLBUZ1/TI03/(VCOUT1)/SI10/RxD1/SDA10/(SDAA1)	P22/ANI2/PGAI/IVCMP0	P23/ANI3/ANO1/PGA GND	4
3	P121/X1/(TI01)/INTP2/(SI01)	V <sub>DD</sub>	EV <sub>DD</sub>	P33/ANI18/IVCMP1/(INTP11)/(SCLA1)	P32/ANI19/SO11/(INTP10)/(VCOUT1)/(SDAA1)	3
2	REGC	V <sub>SS</sub>	P30/ANI21/KR1/TI00/TO01/INTP3/SCK11/SCL11/(TxD0)/PCLBUZ0/TKBO1/(SDAA0)	P31/ANI20/KR0/TI01/TO00/INTP4/TKBO0/(RxD0)/SI11/SDA11/(SCLA0)	P56/ANI22/KR2/SCK00/SCL00/(SO11)/INTP10/(TO03)/(INTFO)/SCLA1	2
1	P51/KR7/INTP8/(TI02)/(TO02)/SCK01/SCL01/(TxD0)	P52/KR6/INTP7/SI01/SDA01/(RxD0)/(SDAA0)	P53/KR5/INTP6/SO01/SDAA0	P54/KR4/SO00/TxD0/TOOLTxD/(TI03)/(TO03)/SCLA0	P55/KR3/SI00/RxD0/SDA00/TOOLRXD/TI02/TO02/INTP11/(VCOUT0)/SDAA1	1
	A	B	C	D	E	

**Caution** Connect the REGC pin to V<sub>SS</sub> pin via a capacitor (0.47 to 1 μF).

**Remark 1.** For pin identification, see 1.4 Pin Identification.

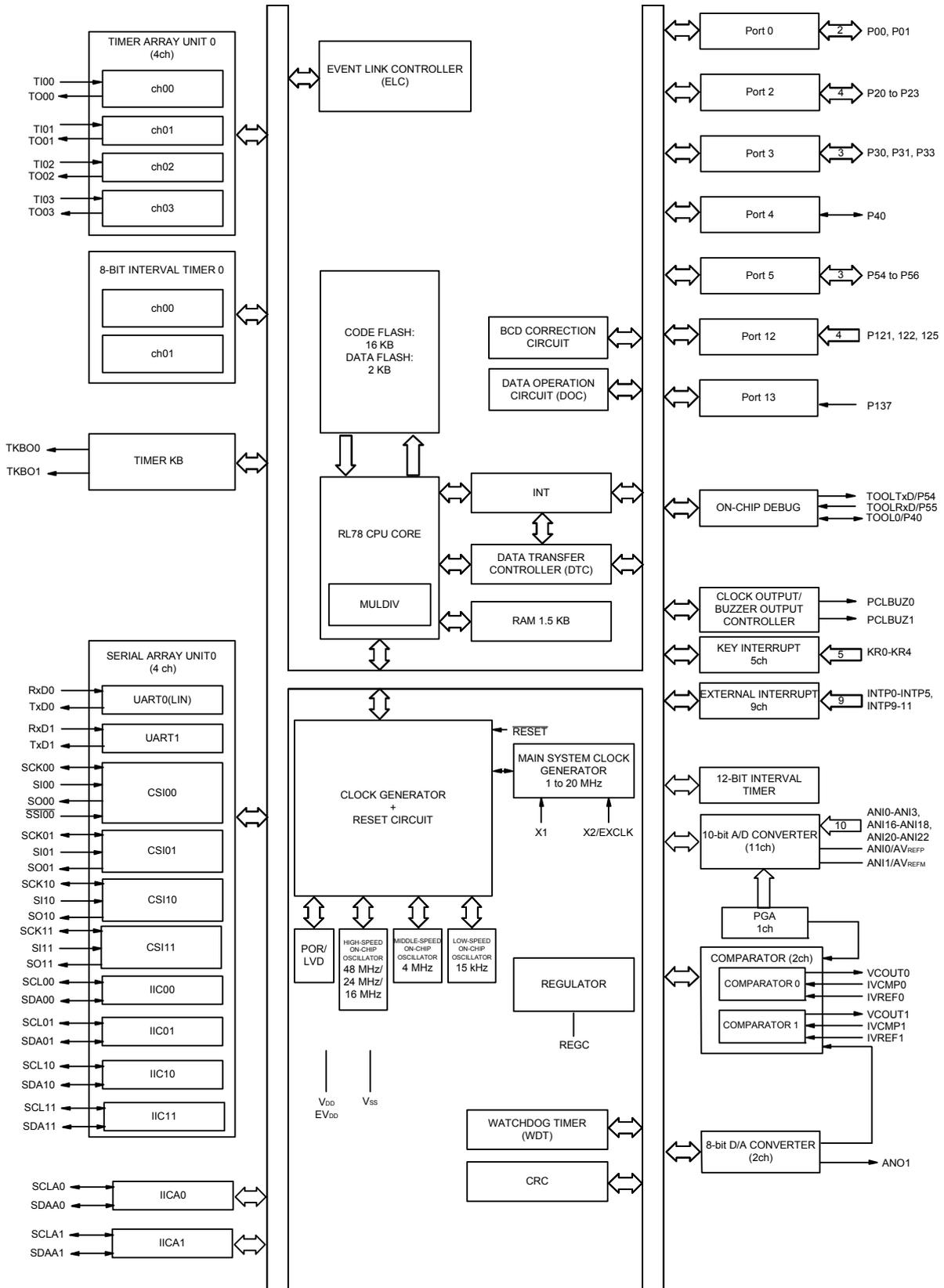
**Remark 2.** Functions in parentheses in the above figure can be assigned via settings in the peripheral I/O redirection register 0 to 3 (PIOR0 to PIOR3).

## 1.4 Pin Identification

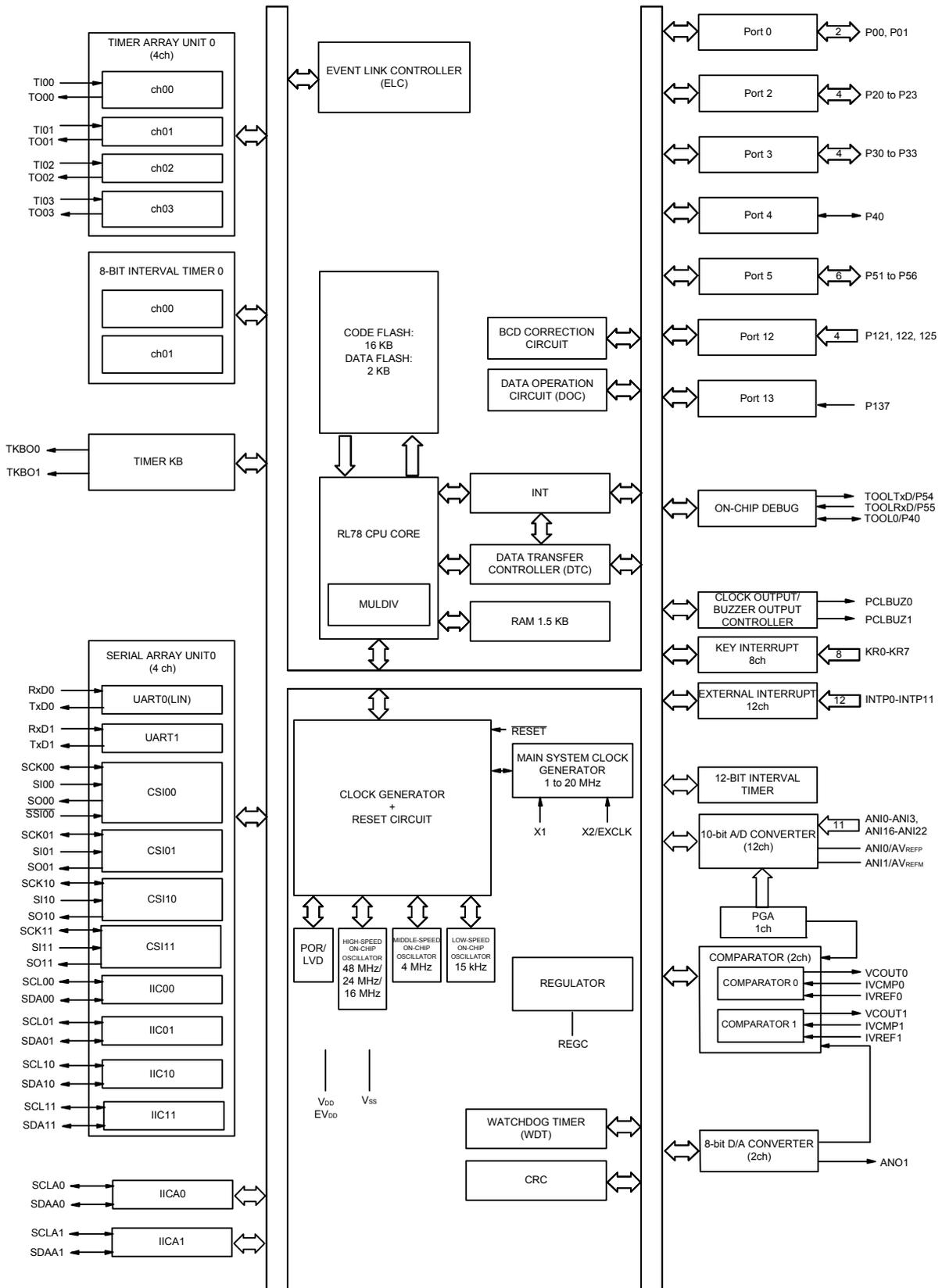
ANI0 to ANI3,	: Analog input	PCLBUZ0, PCLBUZ1	: Programmable clock output/buzzer output
ANI16 to ANI22		REGC	: Regulator capacitance
ANO1	: Analog output	$\overline{\text{RESET}}$	: Reset
AVREFM	: A/D converter reference potential (- side) input	RxD0, RxD1	: Receive data
AVREFP	: A/D converter reference potential (+ side) input	SCK00, SCK01	: Serial clock input/output
EVDD	: Power supply	SCK10, SCK11	
EXCLK	: External clock input (main system clock)	SCLA0, SCLA1	: Serial clock input/output
INTP0 to INTP11	: External interrupt input	SCL00, SCL01	: Serial clock output
INTFO	: Interrupt Flag output	SCL10, SCL11	
IVCMP0, IVCMP1	: Comparator input	SDAA0, SDAA1	: Serial data input/output
IVREF0, IVREF1	: Comparator reference input	SDA00, SDA01	: Serial data input/output
KR0 to KR7	: Key return	SDA10, SDA11	
PGAI, PGAGND	: PGA Input	SI00, SI01	: Serial data input
P00 to P01	: Port 0	SI10, SI11	
P20 to P23	: Port 2	SO00, SO01	: Serial data output
P30 to P33	: Port 3	SO10, SO11	
P40	: Port 4	$\overline{\text{SSI00}}$	: Serial interface chip select input
P51 to P56	: Port 5	TI00 to TI03	: Timer input
P121, P122, P125	: Port 12	TKBO0, TKBO1	: TMKB output
P137	: Port 13	TO00 to TO03	: Timer output
		TOOL0	: Data input/output for tool
		TOOLRXD, TOOLTXD	: Data input/output for external device
		TxD0, TxD1	: Transmit data
		VCOUT0, VCOUT1	: Comparator output
		VDD	: Power supply
		VSS	: Ground
		X1, X2	: Crystal oscillator (main system clock)

## 1.5 Block Diagram

### 1.5.1 20-pin products



1.5.2 24-pin, 25-pin products



## 1.6 Outline of Functions

This outline describes the functions at the time when Peripheral I/O redirection register 0 to 3 (PIOR0 to PIOR3) are set to 00H.

(1/2)

Item		20-pin	24-pin	25-pin
		R5F1056A	R5F1057A	R5F1058A
Code flash memory (KB)		16 Kbytes		
Data flash memory (KB)		2 Kbytes		
RAM		1.5 Kbytes		
Address space		1 Mbytes		
Main system clock	High-speed system clock (f <sub>MX</sub> )	X1 (crystal/ceramic) oscillation, external main system clock input (EXCLK) 1 to 20 MHz: V <sub>DD</sub> = 2.7 to 5.5 V, 1 to 16 MHz: V <sub>DD</sub> = 2.4 to 2.7 V, 1 to 8 MHz: V <sub>DD</sub> = 1.8 to 2.4 V, 1 to 4 MHz: V <sub>DD</sub> = 1.6 to 1.8 V		
	High-speed on-chip oscillator clock (f <sub>IH</sub> ) Max: 24 MHz	HS (High-speed main) mode: 1 to 24 MHz (V <sub>DD</sub> = 2.7 to 5.5 V), HS (High-speed main) mode: 1 to 16 MHz (V <sub>DD</sub> = 2.4 to 5.5 V), LS (Low-speed main) mode: 1 to 8 MHz (V <sub>DD</sub> = 1.8 to 5.5 V), LV (Low-voltage main) mode: 1 to 4 MHz (V <sub>DD</sub> = 1.6 to 5.5 V), LP (Low-power main) mode: 1 MHz (V <sub>DD</sub> = 1.8 to 5.5 V)		
	Middle-speed on-chip oscillator clock (f <sub>IM</sub> ) Max: 4 MHz	LS (Low-speed main) mode: 1 to 8 MHz (V <sub>DD</sub> = 1.8 to 5.5 V), LV (Low-voltage main) mode: 1 to 4 MHz (V <sub>DD</sub> = 1.6 to 5.5 V), LP (Low-power main) mode: 1 MHz (V <sub>DD</sub> = 1.8 to 5.5 V)		
General-purpose register		8 bits × 32 registers (8 bits × 8 registers × 4 banks)		
Minimum instruction execution time		0.04167 μs (High-speed on-chip oscillator clock: f <sub>IH</sub> = 24 MHz operation)		
		0.05 μs (High-speed system clock: f <sub>MX</sub> = 20 MHz operation)		
Instruction set		<ul style="list-style-type: none"> <li>• Data transfer (8/16 bits)</li> <li>• Adder and subtractor/logical operation (8/16 bits)</li> <li>• Multiplication (8 bits × 8 bits, 16 bits × 16 bits), Division (16 bits ÷ 16 bits, 32 bits ÷ 32 bits)</li> <li>• Multiplication and Accumulation (16 bits × 16 bits + 32 bits)</li> <li>• Rotate, barrel shift, and bit manipulation (Set, reset, test, and Boolean operation), etc.</li> </ul>		
I/O port	Total	17	21	
	CMOS I/O	13	17	
	CMOS input		4	
Timer	16-bit timer	4 channels		
	Watchdog timer	1 channel		
	Timer KB	1 channel		
	12-bit interval timer	1 channel		
	8/16-bit interval timer	2 channels (8 bit)/1 channel (16 bit)		
	Timer output	6		

**Caution** The flash library uses RAM in self-programming and rewriting of the data flash memory. The target products and start address of the RAM areas used by the flash library are shown below.

**R5F105xA (x = 6, 7, 8): Start address FF900H**

**For the RAM areas used by the flash library, see Self RAM list of Flash Self-Programming Library for RL78 Family (R20UT2944).**

(2/2)

Item	20-pin		24-pin		25-pin	
	R5F1056A		R5F1057A		R5F1058A	
Clock output/buzzer output		2				
		• 2.44 kHz, 4.88 kHz, 9.76 kHz, 1.25 MHz, 2.5 MHz, 5 MHz, 10 MHz (Main system clock: f <sub>MAIN</sub> = 20 MHz operation)				
10-bit resolution A/D converter	External	10 channels		11 channels		
	Internal	1 channel		1 channel		
8-bit D/A converter		2 channels				
Comparator (Window Comparator)		2 channels				
PGA		1 channel				
Data Operation Circuit (DOC)		Comparison, addition, and subtraction of 16-bit data				
Serial interface		[20-pin products] • CSI: 3 channel/UART: 2 channel/simplified I <sup>2</sup> C: 3 channel [24-pin, 25-pin products] • CSI: 4 channels/UART: 2 channel/simplified I <sup>2</sup> C: 4 channels				
	I <sup>2</sup> C bus	2 channels		2 channels		2 channels
Data transfer controller (DTC)		23 sources		24 sources		
Event link controller (ELC)		Event input: 17 Event trigger output: 4		Event input: 18 Event trigger output: 4		
Vectored interrupt sources	Internal	25				
	External	10		13		
Key interrupt		5		8		
Reset		<ul style="list-style-type: none"> <li>• Reset by <math>\overline{\text{RESET}}</math> pin</li> <li>• Internal reset by watchdog timer</li> <li>• Internal reset by power-on-reset</li> <li>• Internal reset by voltage detector</li> <li>• Internal reset by illegal instruction execution</li> <li>• Internal reset by RAM parity error</li> <li>• Internal reset by illegal-memory access</li> </ul>				
Power-on-reset circuit		<ul style="list-style-type: none"> <li>• Power-on-reset: 1.51 ± 0.04V (T<sub>A</sub> = -40 to +85°C) 1.51 ± 0.06V (T<sub>A</sub> = +85 to +105°C)</li> <li>• Power-down-reset: 1.50 ± 0.04 V (T<sub>A</sub> = -40 to +85°C) 1.51 ± 0.06V (T<sub>A</sub> = +85 to +105°C)</li> </ul>				
Voltage detector	Power on	1.67 V to 4.06 V (14 stages)				
	Power down	1.63 V to 3.98 V (14 stages)				
On-chip debug function		Provided (Disable to tracing)				
Power supply voltage		V <sub>DD</sub> = 1.6 to 5.5 V				
Operating ambient temperature		T <sub>A</sub> = -40 to +85°C (Consumer applications) T <sub>A</sub> = -40 to +105°C (Industrial applications)				

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## 2. ELECTRICAL SPECIFICATIONS (TA = -40 to +85°C)

This chapter describes the following electrical specifications.

Target products A: Consumer applications (TA = -40 to +85 °C)

R5F105xxAxx

G: When the products "G: Industrial applications (TA = -40 to +105°C)" is used in the range of TA = -40 to +85°C

R5F105xxGxx

**Caution 1.** The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.

**Caution 2.** The pins mounted depend on the product. Refer to 2.1 Port Functions to 2.2.1 Functions for each product in the RL78/G11 User's Manual.

**Caution 3.** The EVDD pin is not present on products with 24 or less pins. Accordingly, replace EVDD with VDD and the voltage condition  $1.6 \leq EVDD \leq VDD \leq 5.5 \text{ V}$  with  $1.6 \leq VDD \leq 5.5 \text{ V}$ .

## 2.1 Absolute Maximum Ratings

(1/2)

Parameter	Symbols	Conditions	Ratings	Unit
Supply voltage	V <sub>DD</sub> , EV <sub>DD</sub>	V <sub>DD</sub> ≤ EV <sub>DD</sub>	-0.5 to + 6.5	V
	AV <sub>REFP</sub>		0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	AV <sub>REFM</sub>		-0.3 to V <sub>DD</sub> + 0.3 Note 2 and AV <sub>REFM</sub> ≤ AV <sub>REFP</sub>	V
REGC pin input voltage	V <sub>I</sub> REGC	REGC	-0.3 to + 2.8 and -0.3 to V <sub>DD</sub> + 0.3 Note 1	V
Input voltage	V <sub>I1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	V <sub>I2</sub>	P20 to P23, P121, P122, P125, P137, EXCLK, RESET	-0.3 to V <sub>DD</sub> + 0.3 Note 2	V
Output voltage	V <sub>O1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	V <sub>O2</sub>	P20 to P23	-0.3 to V <sub>DD</sub> + 0.3 Note 2	V
Analog input voltage	V <sub>AI1</sub>	ANI16 to ANI22	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to AV <sub>REF</sub> (+) + 0.3 Notes 2, 3	V
	V <sub>AI2</sub>	ANI0 to ANI3	-0.3 to V <sub>DD</sub> + 0.3 and -0.3 to AV <sub>REF</sub> (+) + 0.3 Notes 2, 3	V

**Note 1.** Connect the REGC pin to V<sub>SS</sub> via a capacitor (0.47 to 1 μF). This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

**Note 2.** Must be 6.5 V or lower.

**Note 3.** Do not exceed AV<sub>REF</sub> (+) + 0.3 V in case of A/D conversion target pin.

**Caution** Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

**Remark 1.** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

**Remark 2.** AV<sub>REF</sub> (+): + side reference voltage of the A/D converter.

**Remark 3.** V<sub>SS</sub>: Reference voltage

(2/2)

Parameter	Symbols	Conditions		Ratings	Unit
Output current, high	IOH1	Per pin		-40	mA
		Total of all pins -170 mA	P00, P01, P40	-70	mA
			P30 to P33, P51 to P56	-100	mA
	IOH2	Per pin	P20 to P23	-0.5	mA
		Total of all pins		-2	mA
Output current, low	IOL1	Per pin		40	mA
		Total of all pins 170 mA	P00, P01, P40	70	mA
			P30 to P33, P51 to P56	100	mA
	IOL2	Per pin	P20 to P23	1	mA
		Total of all pins		4	mA
Operating ambient temperature	TA	In normal operation mode		-40 to +85	°C
		In flash memory programming mode			
Storage temperature	Tstg			-65 to +150	°C

**Caution** Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

## 2.2 Oscillator Characteristics

### 2.2.1 X1 characteristics

(TA = -40 to +85°C, 1.6 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Resonator	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (fx) <sup>Note</sup>	Ceramic resonator/ crystal resonator	2.7 V ≤ VDD ≤ 5.5 V	1.0		20.0	MHz
		2.4 V ≤ VDD < 2.7 V	1.0		16.0	
		1.8 V ≤ VDD < 2.4 V	1.0		8.0	
		1.6 V ≤ VDD < 1.8 V	1.0		4.0	

**Note** Indicates only permissible oscillator frequency ranges. Refer to **2.4 AC Characteristics** for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

**Caution** Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

**Remark** When using the X1 oscillator, refer to **6.4 System Clock Oscillator** in the RL78/G11 User's Manual.

### 2.2.2 On-chip oscillator characteristics

(TA = -40 to +85°C, 1.6 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Oscillators	Parameters	Conditions	MIN.	TYP.	MAX.	Unit	
High-speed on-chip oscillator clock frequency <sup>Notes 1, 2</sup>	f <sub>IH</sub>	2.7 V ≤ VDD ≤ 5.5 V	1		24	MHz	
		2.4 V ≤ VDD ≤ 5.5 V	1		16		
		1.8 V ≤ VDD ≤ 5.5 V	1		8		
		1.6 V ≤ VDD ≤ 5.5 V	1		4		
High-speed on-chip oscillator clock frequency accuracy		TA = -20 to +85°C	1.8 V ≤ VDD ≤ 5.5 V	-1		1	%
			1.6 V ≤ VDD < 1.8 V	-5		5	
		TA = -40 to -20°C	1.8 V ≤ VDD ≤ 5.5 V	-1.5		1.5	%
			1.6 V ≤ VDD < 1.8 V	-5.5		5.5	
Middle-speed on-chip oscillator oscillation frequency <sup>Note 2</sup>	f <sub>IM</sub>		1		4	MHz	
Middle-speed on-chip oscillator oscillation frequency accuracy			-12		+12	%	
Temperature drift of Middle-speed on-chip oscillator oscillation frequency accuracy	DIMT	2.4 V ≤ VDD		± 0.05		%/°C	
		1.8 V ≤ VDD < 2.4 V		± 0.075			
Voltage drift of Middle-speed on-chip oscillator oscillation frequency accuracy	DIMV	TA = 25°C	2.4 V ≤ VDD		0.1	%/V	
			1.8 V ≤ VDD < 2.4 V		16		
Low-speed on-chip oscillator clock frequency <sup>Note 2</sup>	f <sub>IL</sub>			15		kHz	
Low-speed on-chip oscillator clock frequency accuracy			-15		+15	%	

**Note 1.** High-speed on-chip oscillator frequency is selected with bits 0 to 3 of the option byte (000C2H) and bits 0 to 2 of the HOCODIV register.

**Note 2.** This only indicates the oscillator characteristics. Refer to **2.4 AC Characteristics** for instruction execution time.

## 2.3 DC Characteristics

### 2.3.1 Pin characteristics

(TA = -40 to +85°C, 1.6 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(1/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output current, high Note 1	IOH1	Per pin for P00, P01, P30 to P33, P40, and P51 to P56			-10.0 Note 2	mA
		Total of P00, P01, and P40 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		-55.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		-10.0	mA
			1.8 V ≤ EVDD < 2.7 V		-5.0	mA
			1.6 V ≤ EVDD < 1.8 V		-2.5	mA
		Total of P30 to P33, and P51 to P56 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		-80.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		-19.0	mA
			1.8 V ≤ EVDD < 2.7 V		-10.0	mA
			1.6 V ≤ EVDD < 1.8 V		-5.0	mA
		Total of all pins (When duty ≤ 70% Note 3)			-135.0	mA
IOH2	Per pin for P20 to P23			-0.1 Note 2	mA	
	Total of all pins (When duty ≤ 70% Note 3)	1.6 V ≤ VDD ≤ 5.5 V		-0.4	mA	

**Note 1.** Value of current at which the device operation is guaranteed even if the current flows from the VDD pin to an output pin.

**Note 2.** Do not exceed the total current value.

**Note 3.** Specification under conditions where the duty factor ≤ 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins =  $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where n = 80% and IOH = -10.0 mA

$$\text{Total output current of pins} = (-10.0 \times 0.7)/(80 \times 0.01) \approx -8.7 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

**Caution** P00, P01, P20, P30 to P33, P40 and P51 to P56 do not output high level in N-ch open-drain mode.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Output current, low Note 1	IOL1	Per pin for P00, P01, P30 to P33, P40, and P51 to P56			20.0 Note 2	mA	
		Total of P00, P01, and P40 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V			70.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V			15.0	mA
			1.8 V ≤ EVDD < 2.7 V			9.0	mA
			1.6 V ≤ EVDD < 1.8 V			4.5	mA
		Total of P30 to P33, and P51 to P56 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V			80.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V			35.0	mA
			1.8 V ≤ EVDD < 2.7 V			20.0	mA
			1.6 V ≤ EVDD < 1.8 V			10.0	mA
	Total of all pins (When duty ≤ 70% Note 3)				150.0	mA	
	IOL2	Per pin for P20 to P23			0.4 Note 2	mA	
1.6 V ≤ VDD ≤ 5.5 V					1.6	mA	
Total of all pins (When duty ≤ 70% Note 3)							

**Note 1.** Value of current at which the device operation is guaranteed even if the current flows from an output pin to the VSS pin.

**Note 2.** Do not exceed the total current value.

**Note 3.** Specification under conditions where the duty factor ≤ 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

$$\bullet \text{ Total output current of pins} = (I_{OL} \times 0.7)/(n \times 0.01)$$

<Example> Where n = 80% and IOL = 10.0 mA

$$\text{Total output current of pins} = (10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(3/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input voltage, high	V <sub>IH1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	Normal mode	0.8 EV <sub>DD</sub>		EV <sub>DD</sub>	V
	V <sub>IH2</sub>	P00, P30 to P32, P40, P51 to P56	TTL mode 4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V	2.2		EV <sub>DD</sub>	V
			TTL mode 3.3 V ≤ EV <sub>DD</sub> < 4.0 V	2.0		EV <sub>DD</sub>	V
			TTL mode 1.6 V ≤ EV <sub>DD</sub> < 3.3 V	1.5		EV <sub>DD</sub>	V
	V <sub>IH3</sub>	P20 to P23 (digital input)		0.7 V <sub>DD</sub>		V <sub>DD</sub>	V
	V <sub>IH4</sub>	P20 (SDAA0 input), P121, P122, P125, P137, EXCLK, RESET		0.8 V <sub>DD</sub>		V <sub>DD</sub>	V
Input voltage, low	V <sub>IL1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	Normal mode	0		0.2 EV <sub>DD</sub>	V
	V <sub>IL2</sub>	P00, P30 to P32, P40, P51 to P56	TTL mode 4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V	0		0.8	V
			TTL mode 3.3 V ≤ EV <sub>DD</sub> < 4.0 V	0		0.5	V
			TTL mode 1.6 V ≤ EV <sub>DD</sub> < 3.3 V	0		0.32	V
	V <sub>IL3</sub>	P20 to P23 (digital input)		0		0.3 V <sub>DD</sub>	V
	V <sub>IL4</sub>	P20 (SDAA0 input), P121, P122, P125, P137, EXCLK, RESET		0		0.2 V <sub>DD</sub>	V

**Caution** The maximum value of V<sub>IH</sub> of pins P00, P01, P20, P30 to P33, P40 and P51 to P56 is V<sub>DD</sub> or EV<sub>DD</sub>, even in the N-ch open-drain mode.

(P20: V<sub>DD</sub>)

(P00, P01, P30-P33, P40, P51-P56: EV<sub>DD</sub>)

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +85°C, 1.6 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(4/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Output voltage, high	VOH1	P00, P01, P30 to P33, P40, and P51 to P56	4.0 V ≤ EVDD ≤ 5.5 V, IOH = -10.0 mA	EVDD - 1.5			V
			4.0 V ≤ EVDD ≤ 5.5 V, IOH = -3.0 mA	EVDD - 0.7			V
			2.7 V ≤ EVDD ≤ 5.5 V, IOH = -2.0 mA	EVDD - 0.6			V
			1.8 V ≤ EVDD ≤ 5.5 V IOH = -1.5 mA	EVDD - 0.5			V
			1.6 V ≤ EVDD ≤ 5.5 V, IOH = -1.0 mA	EVDD - 0.5			V
	VOH2	P20 to P23	1.6 V ≤ VDD ≤ 5.5 V, IOH = -100 μA	VDD - 0.5			V
Output voltage, low	VOL1	P00, P01, P30 to P33, P40, and P51 to P56	4.0 V ≤ EVDD ≤ 5.5 V, IOL = 20.0 mA			1.3	V
			4.0 V ≤ EVDD ≤ 5.5 V, IOL = 8.5 mA			0.7	V
			2.7 V ≤ EVDD ≤ 5.5 V, IOL = 3.0 mA			0.6	V
			2.7 V ≤ EVDD ≤ 5.5 V, IOL = 1.5 mA			0.4	V
			1.8 V ≤ EVDD ≤ 5.5 V, IOL = 0.6 mA			0.4	V
			1.6 V ≤ EVDD ≤ 5.5 V, IOL = 0.3 mA			0.4	V
	VOL2	P20 to P23	1.6 V ≤ VDD ≤ 5.5 V, IOL = 400 μA			0.4	V

**Caution** P00, P01, P20, P30 to P33, P40 and P51 to P56 do not output high level in N-ch open-drain mode.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(5/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit		
Input leakage current, high	ILI1	P00, P01, P30 to P33, P40, and P51 to P56	VI = EVDD		1	μA		
	ILI2	P20 to P23, P125, P137, RESET	VI = VDD		1	μA		
	ILI3	P121, P122, X1, X2, EXCLK	VI = VDD	In input port or external clock input	1	μA		
				In resonator connection	10	μA		
Input leakage current, low	ILIL1	P00, P01, P30 to P33, P40, and P51 to P56	VI = VSS		-1	μA		
	ILIL2	P20 to P23, P125, P137, RESET	VI = VSS		-1	μA		
	ILIL3	P121, P122, X1, X2, EXCLK	VI = VSS	In input port or external clock input	-1	μA		
				In resonator connection	-10	μA		
On-chip pull-up resistance	Ru	P00, P01, P30 to P33, P40, P51 to P56, P125	VI = VSS, In input port		10	20	100	kΩ

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

2.3.2 Supply current characteristics

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(1/4)

Parameter	Symbol	Conditions				MIN.	TYP.	MAX.	Unit		
Supply current Note 1	IDD1	Operating mode	Basic operation	HS (high-speed main) mode	fHOCO = 48 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		1.7		mA	
						VDD = 3.0 V		1.7			
					fHOCO = 24 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		1.4			
						VDD = 3.0 V		1.4			
						VDD = 5.0 V		3.5	6.9		
						VDD = 3.0 V		3.5	6.9		
			Normal operation	HS (high-speed main) mode	fHOCO = 48 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		3.2	6.3		
						VDD = 3.0 V		3.2	6.3		
					fHOCO = 24 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		2.4	4.6		
						VDD = 3.0 V		2.4	4.6		
					fHOCO = 16 MHz <sup>Note 3</sup> fIH = 16 MHz <sup>Note 3</sup>	VDD = 5.0 V		1.1	2.0		
						VDD = 2.0 V		1.1	2.0		
			Normal operation	LS (low-speed main) mode (MCSEL = 0)	fIH = 4 MHz <sup>Note 3</sup>	VDD = 3.0 V		0.72	1.3		
						VDD = 2.0 V		0.72	1.3		
					fIM = 4 MHz <sup>Note 6</sup>	VDD = 3.3 V		0.58	1.1		
						VDD = 3.0 V		0.58	1.1		
			Normal operation	LV (low-voltage main) mode	fIH = 4 MHz <sup>Note 3</sup>	VDD = 3.0 V		1.2	1.8		
						VDD = 2.0 V		1.2	1.8		
			Normal operation	LP (low-power main) mode (MCSEL = 1)	fIH = 1 MHz <sup>Note 3</sup>	VDD = 3.0 V		290	480		
						VDD = 2.0 V		290	480		
					fIM = 1 MHz <sup>Note 6</sup>	VDD = 3.0 V		124	230		
						VDD = 2.0 V		124	230		
			Normal operation	HS (high-speed main) mode	fMX = 20 MHz <sup>Note 2</sup>	VDD = 5.0 V	Square wave input		2.7	5.3	
							Resonator connection		2.8	5.5	
						VDD = 3.0 V	Square wave input		2.7	5.3	
							Resonator connection		2.8	5.5	
						fMX = 10 MHz <sup>Note 2</sup>	VDD = 5.0 V	Square wave input		1.8	3.1
								Resonator connection		1.9	3.2
VDD = 3.0 V	Square wave input				1.8		3.1				
	Resonator connection				1.9		3.2				
Normal operation	LS (low-speed main) mode (MCSEL = 0)	fMX = 8 MHz <sup>Note 2</sup>			VDD = 3.0 V	Square wave input		0.9	1.9		
						Resonator connection		1.0	2.0		
		fMX = 8 MHz <sup>Note 2</sup>			VDD = 2.0 V	Square wave input		0.9	1.9		
						Resonator connection		1.0	2.0		
Normal operation	LS (low-speed main) mode (MCSEL = 1)	fMX = 4 MHz <sup>Note 2</sup>	VDD = 3.0 V	Square wave input		0.6	1.1				
				Resonator connection		0.6	1.2				
		fMX = 4 MHz <sup>Note 2</sup>	VDD = 2.0 V	Square wave input		0.6	1.1				
				Resonator connection		0.6	1.2				
Normal operation	LP (low-power main) mode (MCSEL = 1)	fMX = 1 MHz <sup>Note 2</sup>	VDD = 3.0 V	Square wave input		100	190				
				Resonator connection		145	250				
		fMX = 1 MHz <sup>Note 2</sup>	VDD = 2.0 V	Square wave input		100	190				
				Resonator connection		145	250				

(Notes and Remarks are listed on the next page.)

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/4)

Parameter	Symbol	Conditions					MIN.	TYP.	MAX.	Unit
Supply current Note 1	I <sub>DD1</sub>	Operating mode	Normal operation	Subsystem clock operation	f <sub>IL</sub> = 15 kHz, TA = -40°C Note 5	Normal operation		1.8	5.9	μA
					f <sub>IL</sub> = 15 kHz, TA = +25°C Note 5	Normal operation		1.9	5.9	
					f <sub>IL</sub> = 15 kHz, TA = +85°C Note 5	Normal operation		2.3	8.7	

**Note 1.** Total current flowing into V<sub>DD</sub> and EV<sub>DD</sub>, including the input leakage current flowing when the level of the input pin is fixed to V<sub>DD</sub> or V<sub>SS</sub>. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.

**Note 2.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Note 3.** When the high-speed system clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Note 4.** When the high-speed system clock is stopped.

**Note 5.** When the high-speed system clock, high-speed on-chip oscillator clock and middle-speed on-chip oscillator clock are stopped.

**Note 6.** When the high-speed system clock, high-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Remark 1.** f<sub>MX</sub>: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)

**Remark 2.** f<sub>IH</sub>: High-speed on-chip oscillator clock frequency (24 MHz max.)

**Remark 3.** f<sub>IM</sub>: Middle-speed on-chip oscillator clock frequency (4 MHz max.)

**Remark 4.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency

**Remark 5.** f<sub>SUB</sub>: Subsystem clock frequency (Low-speed on-chip oscillator clock frequency)

**Remark 6.** Except subsystem clock operation, temperature condition of the TYP. value is TA = 25°C

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(3/4)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit				
Supply current Note 1	I <sub>DD2</sub> Note 2	HALT mode	HS (high-speed main) mode	f <sub>HOCO</sub> = 48 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 5.0 V	0.59	2.43	mA			
				f <sub>IH</sub> = 24 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	0.59	2.43				
				f <sub>HOCO</sub> = 24 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 5.0 V	0.41	1.83				
				f <sub>IH</sub> = 24 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	0.41	1.83				
				f <sub>HOCO</sub> = 16 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 5.0 V	0.39	1.38				
				f <sub>IH</sub> = 16 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	0.39	1.38				
			LS (low-speed main) mode (MCSEL = 0)	f <sub>IH</sub> = 8 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	250	710	μA			
					V <sub>DD</sub> = 2.0 V	250	710				
			LS (low-speed main) mode (MCSEL = 1)	f <sub>IH</sub> = 4 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	204	400	μA			
					V <sub>DD</sub> = 2.0 V	204	400				
				f <sub>IM</sub> = 4 MHz <sup>Note 6</sup>	V <sub>DD</sub> = 3.0 V	43	250				
					V <sub>DD</sub> = 2.0 V	43	250				
			LV (low-voltage main) mode	f <sub>IH</sub> = 4 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	450	700	mA			
					V <sub>DD</sub> = 2.0 V	450	700				
			LP (low-power main) mode (MCSEL = 1)	f <sub>IH</sub> = 1 MHz <sup>Note 4</sup>	V <sub>DD</sub> = 3.0 V	192	400	μA			
					V <sub>DD</sub> = 2.0 V	192	400				
				f <sub>IM</sub> = 1 MHz <sup>Note 6</sup>	V <sub>DD</sub> = 3.0 V	28	100				
					V <sub>DD</sub> = 2.0 V	28	100				
			HS (high-speed main) mode	f <sub>MX</sub> = 20 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 5.0 V	Square wave input	0.20	1.55	mA		
						Resonator connection	0.40	1.74			
					V <sub>DD</sub> = 3.0 V	Square wave input	0.20	1.55			
						Resonator connection	0.40	1.74			
					f <sub>MX</sub> = 10 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 5.0 V	Square wave input	0.15		0.86	
							Resonator connection	0.30		0.93	
				V <sub>DD</sub> = 3.0 V		Square wave input	0.15	0.86			
						Resonator connection	0.30	0.93			
				LS (low-speed main) mode (MCSEL = 0)	f <sub>MX</sub> = 8 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 3.0 V	Square wave input	68		550	μA
							Resonator connection	125		590	
					f <sub>MX</sub> = 8 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 2.0 V	Square wave input	68		550	
							Resonator connection	125		590	
			LS (low-speed main) mode (MCSEL = 1)	f <sub>MX</sub> = 4 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 3.0 V	Square wave input	23	128	μA		
						Resonator connection	65	200			
				f <sub>MX</sub> = 1 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 2.0 V	Square wave input	23	128			
Resonator connection	65	200									
LP (low-power main) mode (MCSEL = 1)	f <sub>MX</sub> = 4 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 3.0 V	Square wave input	10	64	μA					
			Resonator connection	59	150						
	f <sub>MX</sub> = 1 MHz <sup>Note 3</sup>	V <sub>DD</sub> = 2.0 V	Square wave input	10	64						
			Resonator connection	59	150						
Subsystem clock operation	f <sub>IL</sub> = 15 kHz, TA = -40°C <sup>Note 5</sup>			0.48	1.22	μA					
	f <sub>IL</sub> = 15 kHz, TA = +25°C <sup>Note 5</sup>			0.55	1.22						
	f <sub>IL</sub> = 15 kHz, TA = +85°C <sup>Note 5</sup>			0.80	3.30						

(Notes and Remarks are listed on the next page.)

- Note 1.** Total current flowing into V<sub>DD</sub> and EV<sub>DD</sub>, including the input leakage current flowing when the level of the input pin is fixed to V<sub>DD</sub> or V<sub>SS</sub>. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.
- Note 2.** When the HALT instruction is executed in the flash memory.
- Note 3.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, and low-speed on-chip oscillator clock are stopped.
- Note 4.** When the high-speed system clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.
- Note 5.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock and high-speed system clock are stopped.
- Note 6.** When the high-speed system clock, high-speed on-chip oscillator clock, and low-speed on-chip oscillator clock are stopped.

**Remark 1.** f<sub>MX</sub>: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)

**Remark 2.** f<sub>IH</sub>: High-speed on-chip oscillator clock frequency (24 MHz max.)

**Remark 3.** f<sub>IM</sub>: Middle-speed on-chip oscillator clock frequency (4 MHz max.)

**Remark 4.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency

**Remark 5.** f<sub>SUB</sub>: Subsystem clock frequency (Low-speed on-chip oscillator clock frequency)

**Remark 6.** Except subsystem clock operation, temperature condition of the TYP. value is TA = 25°C

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(4/4)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Supply current Note 1	IDD3 Note 2	STOP mode Note 3	TA = -40°C		0.19	0.51	μA
			TA = +25°C		0.25	0.51	
			TA = +50°C		0.28	1.10	
			TA = +70°C		0.38	1.90	
			TA = +85°C		0.60	3.30	

**Note 1.** Total current flowing into VDD and EVDD, including the input leakage current flowing when the level of the input pin is fixed to VDD or VSS. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.

**Note 2.** The values do not include the current flowing into the 12-bit interval timer and watchdog timer.

**Note 3.** For the setting of the current values when operating the subsystem clock in STOP mode, see the current values when operating the subsystem clock in HALT mode.

## Peripheral Functions (Common to all products)

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Low-speed on-chip oscillator operating current	IFIL Note 1				0.20		μA
12-bit interval timer operating current	ITMKA Notes 1, 3, 4	fIL = 15 kHz fMAIN stopped (per unit)			0.02		μA
8-bit interval timer operating current Notes 1, 9	ITMT	fIL = 15 kHz fMAIN stopped (per unit)	8-bit counter mode × 2-channel operation		0.04		μA
			16-bit counter mode operation		0.03		μA
Watchdog timer operating current	IWD <sub>T</sub> Notes 1, 3, 5	fIL = 15 kHz fMAIN stopped (per unit)			0.22		μA
A/D converter operating current	IADC Notes 1, 6	During maximum-speed conversion	Normal mode, AVREFP = VDD = 5.0 V		1.3	1.7	mA
			Low voltage mode, AVREFP = VDD = 3.0 V		0.5	0.7	mA
Internal reference voltage (1.45 V) current Notes 1, 10	IADREF				85.0		μA
Temperature sensor operating current	ITMPS Note 1				85.0		μA
D/A converter operating current	IDAC Note 1	Per channel				1.5	mA
PGA operating current	IPGA Notes 1, 2				480	700	μA
Comparator operating current	ICMP Note 8	VDD = 5.0 V, Regulator output voltage = 2.1 V	Comparator high-speed mode Window mode		12.5		μA
			Comparator low-speed mode Window mode		3.0		
			Comparator high-speed mode Standard mode		6.5		
			Comparator low-speed mode Standard mode		1.9		
		VDD = 5.0 V, Regulator output voltage = 1.8 V	Comparator high-speed mode Window mode		8.0		
			Comparator low-speed mode Window mode		2.2		
			Comparator high-speed mode Standard mode		4.0		
			Comparator low-speed mode Standard mode		1.3		
LVD operating current	ILVD Notes 1, 7				0.10		μA
Self-programming operating current	IFSP Notes 1, 12				2.0	12.20	mA
BGO current	IBGO Notes 1, 11				2.0	12.20	mA
SNOOZE operating current	ISNOZ Note 1	ADC operation fIH = 24 MHz, AVREFP = VDD = 3.0 V	Mode transition Note 13		0.50	0.60	mA
			The A/D conversion operations are performed		1.20	1.44	mA
		CSI/UART operation fIH = 24 MHz		0.70	0.84	mA	
	ISNOZM Note 1	ADC operation fIM = 4 MHz, AVREFP = VDD = 3.0 V	Mode transition Note 13		0.05	0.08	mA
			The A/D conversion operations are performed		0.67	0.78	mA
		CSI operation, fIM = 4 MHz		0.06	0.08	mA	

(Notes and Remarks are listed on the next page.)

- Note 1.** Current flowing to V<sub>DD</sub>.
- Note 2.** Operable range is 2.7 to 5.5 V.
- Note 3.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, and high-speed system clock are stopped.
- Note 4.** Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either I<sub>DD1</sub> or I<sub>DD2</sub>, and I<sub>IT</sub>, when the 12-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, I<sub>FIL</sub> should be added.
- Note 5.** Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of I<sub>DD1</sub>, I<sub>DD2</sub> or I<sub>DD3</sub> and I<sub>WDT</sub> when the watchdog timer is in operation.
- Note 6.** Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of I<sub>DD1</sub> or I<sub>DD2</sub> and I<sub>ADC</sub> when the A/D converter operates in an operation mode or the HALT mode.
- Note 7.** Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of I<sub>DD1</sub>, I<sub>DD2</sub> or I<sub>DD3</sub> and I<sub>LVD</sub> when the LVD circuit is in operation.
- Note 8.** Current flowing only to the comparator circuit. The supply current of the RL78 microcontrollers is the sum of I<sub>DD1</sub>, I<sub>DD2</sub>, or I<sub>DD3</sub> and I<sub>COMP</sub> when the comparator circuit is in operation.
- Note 9.** Current flowing only to the 8-bit interval timer (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either I<sub>DD1</sub> or I<sub>DD2</sub>, and I<sub>IT</sub>, when the 8-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, I<sub>FIL</sub> should be added.
- Note 10.** Current consumed by generating the internal reference voltage (1.45 V).
- Note 11.** Current flowing during programming of the data flash.
- Note 12.** Current flowing during self-programming.
- Note 13.** For transition time to the SNOOZE mode, see **24.3.3 SNOOZE mode** in the RL78/G11 User's Manual.

**Remark 1.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency

**Remark 2.** f<sub>CLK</sub>: CPU/peripheral hardware clock frequency

**Remark 3.** Temperature condition of the TYP. value is T<sub>A</sub> = 25°C

## 2.4 AC Characteristics

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(1/2)

Items	Symbol	Conditions		MIN.	TYP.	MAX.	Unit	
Instruction cycle (minimum instruction execution time)	TCY	Main system clock (fMAIN) operation	HS (high-speed main) mode	2.7 V ≤ VDD ≤ 5.5 V	0.04167		1	μs
				2.4 V ≤ VDD < 2.7 V	0.0625		1	μs
			LS (low-speed main) mode	1.8 V ≤ VDD ≤ 5.5 V PMMC. MCSEL = 0	0.125		1	μs
				1.8 V ≤ VDD ≤ 5.5 V PMMC. MCSEL = 1	0.25		1	μs
			LP (low-power main) mode	1.8 V ≤ VDD ≤ 5.5 V	1			μs
		LV (low-voltage main) mode	1.6 V ≤ VDD ≤ 5.5 V	0.25		1	μs	
		Subsystem clock (fSUB) operation	fil	1.8 V ≤ VDD ≤ 5.5 V		66.7		μs
		In the self- programming mode	HS (high-speed main) mode	2.7 V ≤ VDD ≤ 5.5 V	0.04167		1	μs
				2.4 V ≤ VDD < 2.7 V	0.0625		1	μs
			LS (low-speed main) mode	1.8 V ≤ VDD ≤ 5.5 V	0.125		1	μs
LV (low-voltage main) mode	1.8 V ≤ VDD ≤ 5.5 V		0.25		1	μs		
External system clock frequency	fEX	2.7 V ≤ VDD ≤ 5.5 V		1		20	MHz	
		2.4 V ≤ VDD < 2.7 V		1		16	MHz	
		1.8 V ≤ VDD < 2.4 V		1		8	MHz	
		1.6 V ≤ VDD < 1.8 V		1		4	MHz	
External system clock input high-/low- level width	tEXH, tEXL	2.7 V ≤ VDD ≤ 5.5 V		24			ns	
		2.4 V ≤ VDD < 2.7 V		30			ns	
		1.8 V ≤ VDD < 2.4 V		60			ns	
		1.6 V ≤ VDD < 1.8 V		120			ns	
Ti00 to Ti03 input high-/low-level width	tTIH, tTIL <sup>Note</sup>			1/fMCK + 10			ns	

**Note** Following conditions must be satisfied on low level interface of EVDD < VDD.

1.8 V ≤ EVDD ≤ 2.7 V: MIN. 125 ns

1.6 V ≤ EVDD < 1.8 V: MIN. 250 ns

**Remark** fMCK: Timer array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of timer mode register mn (TMRmn). m: Unit number (m = 0), n: Channel number (n = 0 to 3))

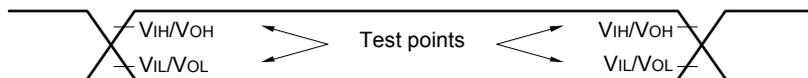
(TA = -40 to +85°C, 1.6 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

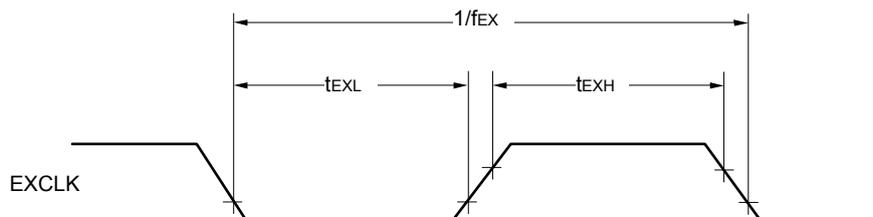
Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
TO00 to TO03, TKBO0, and TKBO1 output frequency <sup>Note</sup>	f <sub>TO</sub>	HS (high-speed main) mode	4.0 V ≤ EVDD ≤ 5.5 V			12	MHz
			2.7 V ≤ EVDD < 4.0 V			8	
			1.8 V ≤ EVDD < 2.7 V			4	
			1.6 V ≤ EVDD ≤ 1.8 V			2	
		LS (low-speed main) mode	1.8 V ≤ EVDD ≤ 5.5 V			4	
			1.6 V ≤ EVDD ≤ 1.8 V			2	
		LP (low-power main) mode	1.8 V ≤ EVDD ≤ 5.5 V			0.5	
		LV (low-voltage main) mode	1.6 V ≤ EVDD ≤ 5.5 V			2	
PCLBUZ0, PCLBUZ1 output frequency	f <sub>PCL</sub>	HS (high-speed main) mode	4.0 V ≤ EVDD ≤ 5.5 V			16	MHz
			2.7 V ≤ EVDD < 4.0 V			8	
			1.8 V ≤ EVDD < 2.7 V			4	
			1.6 V ≤ EVDD ≤ 1.8 V			2	
		LS (low-speed main) mode	1.8 V ≤ EVDD ≤ 5.5 V			4	
			1.6 V ≤ EVDD ≤ 1.8 V			2	
		LP (low-power main) mode	1.6 V ≤ EVDD ≤ 5.5 V			1	
		LV (low-voltage main) mode	1.8 V ≤ EVDD ≤ 5.5 V			4	
		1.6 V ≤ EVDD < 1.8 V			2		
Interrupt input high-/low-level width	t <sub>INTH</sub> , t <sub>INTL</sub>	INTP0 to INTP11	1.6 V ≤ EVDD, VDD ≤ 5.5 V	1		μs	
Key interrupt input low-level width	t <sub>KR</sub>	KR0 to KR7	1.8 V ≤ EVDD ≤ 5.5 V	250		ns	
			1.6 V ≤ EVDD < 1.8 V	1		μs	
RESET low-level width	t <sub>RSL</sub>			10		μs	

**Note** When duty is 50 %.

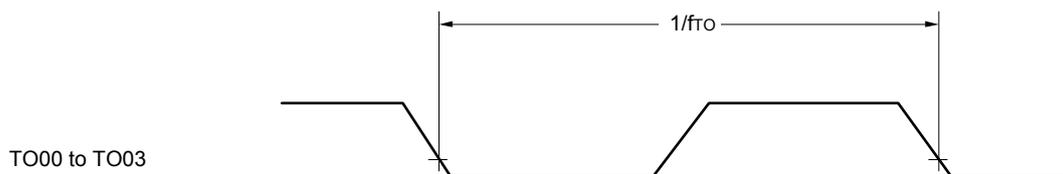
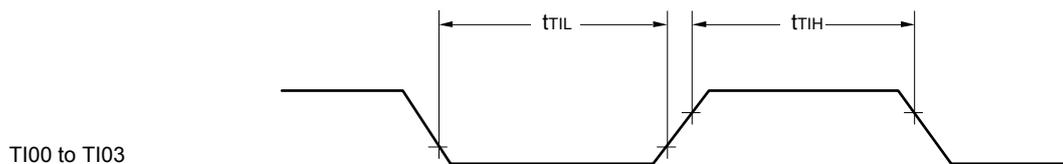
AC Timing Test Points



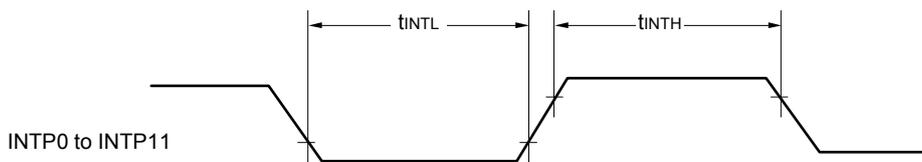
External System Clock Timing



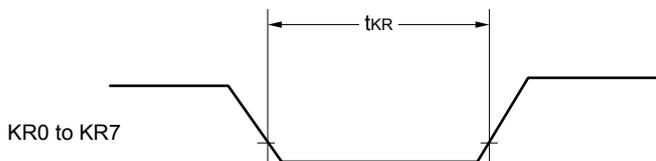
TI/TO Timing



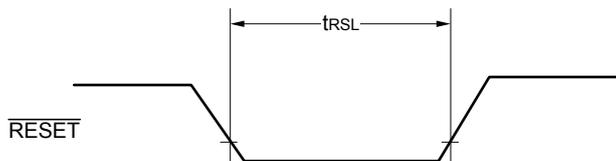
Interrupt Request Input Timing



Key Interrupt Input Timing

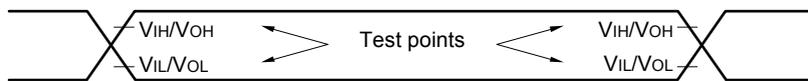


$\overline{\text{RESET}}$  Input Timing



## 2.5 Peripheral Functions Characteristics

AC Timing Test Points



## 2.5.1 Serial array unit

### (1) During communication at same potential (UART mode)

When P01, P30, P31 and P54 are used as Tx/Dq pins

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Transfer rate Note 1, 2		2.7 V ≤ EVDD ≤ 5.5 V		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6	bps
		Theoretical value of the maximum transfer rate f <sub>MCK</sub> = f <sub>CLK</sub> Note 3		4.0		1.3		0.1		0.6	Mbps
		1.8 V ≤ EVDD ≤ 5.5 V		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6	bps
		Theoretical value of the maximum transfer rate f <sub>MCK</sub> = f <sub>CLK</sub> Note 3		4.0		1.3		0.1		0.6	Mbps
		1.7 V ≤ EVDD ≤ 5.5 V		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6	bps
		Theoretical value of the maximum transfer rate f <sub>MCK</sub> = f <sub>CLK</sub> Note 3		4.0		1.3		0.1		0.6	Mbps
		1.6 V ≤ EVDD ≤ 5.5 V		—		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6		f <sub>MCK</sub> /6	bps
		Theoretical value of the maximum transfer rate f <sub>MCK</sub> = f <sub>CLK</sub> Note 3		—		1.3		0.1		0.6	Mbps

**Note 1.** Transfer rate in the SNOOZE mode is 4800 bps only.

**Note 2.** Following conditions must be satisfied on low level interface of EVDD < VDD.

2.4 V ≤ EVDD ≤ 2.7 V: MAX.2.6 Mbps

1.8 V ≤ EVDD ≤ 2.4 V: MAX.1.3 Mbps

1.6 V ≤ EVDD ≤ 1.8 V: MAX.0.6 Mbps

**Note 3.** The maximum operating frequencies of the CPU/peripheral hardware clock (f<sub>CLK</sub>) are:

HS (high-speed main) mode: 24 MHz (2.7 V ≤ EVDD ≤ 5.5 V)

16 MHz (2.4 V ≤ EVDD ≤ 5.5 V)

LS (low-speed main) mode: 8 MHz (1.8 V ≤ EVDD ≤ 5.5 V)

LP (low-power main) mode: 1 MHz (1.8 V ≤ EVDD ≤ 5.5 V)

LV (low-voltage main) mode: 4 MHz (1.6 V ≤ EVDD ≤ 5.5 V)

**Caution** Select the normal input buffer for the Rx/Dq pin and the normal output mode for the Tx/Dq pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**When P20 is used as TxD1 pin****(TA = -40 to +85°C, 1.6 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Transfer rate		4.0 V ≤ VDD ≤ 5.5 V		f <sub>mck</sub> /6 Notes 1, 2, 3		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3		1.5		1.3		0.1		0.6	Mbps
		2.7 V ≤ VDD ≤ 5.5 V		f <sub>mck</sub> /6 Notes 1, 2, 3		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3		1.2		1.2		0.1		0.6	Mbps
		2.4 V ≤ VDD ≤ 5.5 V		f <sub>mck</sub> /6 Notes 1, 2, 3		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3		1.0		1.0		0.1		0.6	Mbps
		1.8 V ≤ VDD ≤ 5.5 V				f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2		f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3				0.6		0.1		0.6	Mbps
		1.7 V ≤ VDD ≤ 5.5 V			Using prohibited		Using prohibited		Using prohibited	f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3						0.5		Mbps	
		1.6 V ≤ VDD ≤ 5.5 V								f <sub>mck</sub> /6 Notes 1, 2	bps
		Theoretical value of the maximum transfer rate f <sub>mck</sub> = f <sub>clk</sub> Notes 1, 3								0.5	Mbps

**Note 1.** f<sub>mck</sub> is a frequency selected by setting the CKS bit in the SPS and SMR registers.

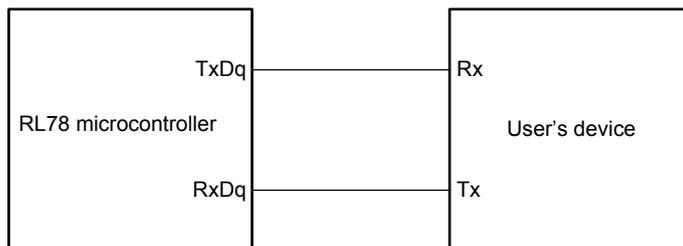
**Note 2.** The transfer rate of 4800 bps is only supported in the SNOOZE mode.  
Note that the SNOOZE mode is not supported when f<sub>HOCO</sub> is 48 MHz.

**Note 3.** f<sub>clk</sub> in each operating mode is as follows.:

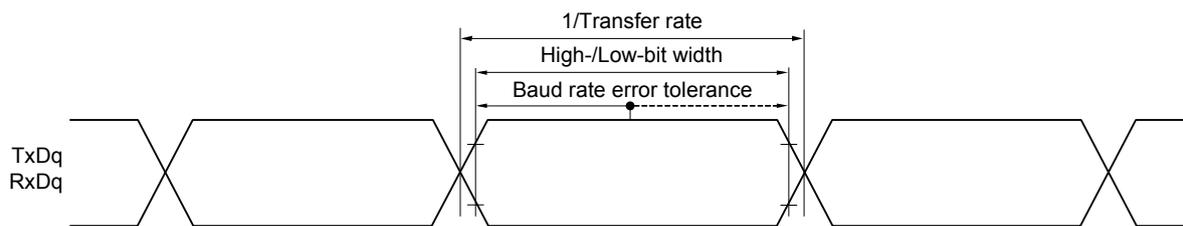
HS (high-speed main) mode:	24 MHz (2.7 V ≤ VDD ≤ 5.5 V)
	16 MHz (2.4 V ≤ VDD ≤ 5.5 V)
LS (low-speed main) mode:	8 MHz (1.8 V ≤ VDD ≤ 5.5 V)
LP (low-power main) mode:	1 MHz (1.8 V ≤ VDD ≤ 5.5 V)
LV (low-voltage main) mode:	4 MHz (1.6 V ≤ VDD ≤ 5.5 V)

**Caution** Select the normal input buffer for the RxDq pin and the normal output mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**UART mode connection diagram (during communication at same potential)**



**UART mode bit width (during communication at same potential) (reference)**



**Remark 1.** q: UART number (q = 0 and 1), g: PIM and POM number (g = 0, 2, 3 and 5)

**Remark 2.** f<sub>MCk</sub>: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

(2) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)

(TA = -40 to +85°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	t <sub>KCY1</sub>	t <sub>KCY1</sub> ≥ 2/f <sub>CLK</sub>	83.3		250		2000		500		ns
SCKp high-/low-level width	t <sub>KL1</sub>	4.0 V ≤ EVDD ≤ 5.5 V	t <sub>KCY1</sub> /2 - 7		t <sub>KCY1</sub> /2 - 50		t <sub>KCY1</sub> /2 - 50		t <sub>KCY1</sub> /2 - 50		ns
		2.7 V ≤ EVDD ≤ 5.5 V	t <sub>KCY1</sub> /2 - 10								ns
Slp setup time (to SCKp↑) Note 1	t <sub>SIK1</sub>	4.0 V ≤ EVDD ≤ 5.5 V	23		110		110		110		ns
		2.7 V ≤ EVDD ≤ 5.5 V	33								ns
Slp hold time (from SCKp↑) Note 2	t <sub>KSI1</sub>		10		10		10		10		ns
Delay time from SCKp↓ to SOp output Note 3	t <sub>KSO1</sub>	C = 20 pF Note 4		10		20		20		20	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SCKp and SOp output lines.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0), g: PIM and POM numbers (g = 5)

**Remark 2.** f<sub>MCK</sub>: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00))

**(3) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output)****When P01, P32, P53, P54 and P56 are used as SOMn pins****(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY1	tkCY1 ≥ 4/fCLK	2.7 V ≤ EVDD ≤ 5.5 V	167		500		4000		1000	ns
			2.4 V ≤ EVDD ≤ 5.5 V	250							
			1.8 V ≤ EVDD ≤ 5.5 V	500							
			1.7 V ≤ EVDD ≤ 5.5 V	1000	1000						
			1.6 V ≤ EVDD ≤ 5.5 V	Using prohibited							
SCKp high-/low-level width	tkH1, tkL1	4.0 V ≤ EVDD ≤ 5.5 V	tkCY1/2- 12		tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50	ns	
		2.7 V ≤ EVDD ≤ 5.5 V	tkCY1/2- 18								
		2.4 V ≤ EVDD ≤ 5.5 V	tkCY1/2- 38								
		1.8 V ≤ EVDD ≤ 5.5 V	tkCY1/2- 50								
		1.7 V ≤ EVDD ≤ 5.5 V	tkCY1/2- 100			tkCY1/2 - 100		tkCY1/2 - 100			tkCY1/2 - 100
		1.6 V ≤ EVDD ≤ 5.5 V	Using prohibited								
Slp setup time (to SCKp↑) Note 1	tsIK1	4.0 V ≤ EVDD ≤ 5.5 V	44		110		110		110	ns	
		2.7 V ≤ EVDD ≤ 5.5 V									
		2.4 V ≤ EVDD ≤ 5.5 V	75								
		1.8 V ≤ EVDD ≤ 5.5 V	110								
		1.7 V ≤ EVDD ≤ 5.5 V	220	220							
		1.6 V ≤ EVDD ≤ 5.5 V	Using prohibited								
Slp hold time (from SCKp↑) Note 2	tkSI1	1.7 V ≤ EVDD ≤ 5.5 V	19		19		19		19	ns	
		1.6 V ≤ EVDD ≤ 5.5 V	Using prohibited								
Delay time from SCKp↓ to SOp output Note 3	tkSO1	C = 30 pF Note 4	1.7 V ≤ EVDD ≤ 5.5 V	33.4		33.4		33.4		33.4	ns
			1.6 V ≤ EVDD ≤ 5.5 V	Using prohibited							

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SCKp and SOp output lines.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**When P20 is used as SO10 pin****(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions		HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY1	tkCY1 ≥ 4/fCLK	4.0 V ≤ VDD ≤ 5.5 V	600		600		4000		1000		ns
			2.7 V ≤ VDD ≤ 5.5 V	850		850						
			2.4 V ≤ VDD ≤ 5.5 V	1000		1000						
			1.8 V ≤ VDD ≤ 5.5 V	—		1500			1500			
			1.7 V ≤ VDD ≤ 5.5 V	—		—		—		2000		
			1.6 V ≤ VDD ≤ 5.5 V	—		—		—		—		
SCKp high-/low-level width	tkH1, tkL1	4.0 V ≤ VDD ≤ 5.5 V		tkCY1/2 - 12		tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50		ns
		2.7 V ≤ VDD ≤ 5.5 V		tkCY1/2 - 18								
		2.4 V ≤ VDD ≤ 5.5 V		tkCY1/2 - 38								
		1.8 V ≤ VDD ≤ 5.5 V		—								
		1.7 V ≤ VDD ≤ 5.5 V		—		—		—		tkCY1/2 - 100		
		1.6 V ≤ VDD ≤ 5.5 V		—		—		—		—		
Slp setup time (to SCKp↑) Note 1	tSIK1	4.0 V ≤ VDD ≤ 5.5 V		44		110		110		110		ns
		2.7 V ≤ VDD ≤ 5.5 V										
		2.4 V ≤ VDD ≤ 5.5 V		75								
		1.8 V ≤ VDD ≤ 5.5 V		—								
		1.7 V ≤ VDD ≤ 5.5 V		—		—		—		220		
		1.6 V ≤ VDD ≤ 5.5 V		—		—		—		—		
Slp hold time (from SCKp↑) Note 2	tkSI1	2.4 V ≤ VDD ≤ 5.5 V		19		19		19		19		ns
		1.8 V ≤ VDD ≤ 5.5 V		—								
		1.6 V ≤ VDD ≤ 5.5 V		—		—		—				
Delay time from SCKp↓ to SOp output Note 3	tkSO1	C = 30 pF Note 4	2.4 V ≤ VDD ≤ 5.5 V		150		250		250		300	ns
			1.8 V ≤ VDD ≤ 5.5 V		—							
			1.6 V ≤ VDD ≤ 5.5 V		—		—		—			

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SCKp and SOp output lines.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 4 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

(4) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input)

When P01, P32, P53, P54 and P56 are used as SOMn pins

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(1/2)

Parameter	Symbol	Conditions		HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit	
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
SCKp cycle time Note 3	tkcy2	4.0 V ≤ EVDD ≤ 5.5 V	fMCK > 20 MHz	8/fMCK		—		—		—		ns	
			fMCK ≤ 20 MHz	6/fMCK		6/fMCK		6/fMCK		6/fMCK			
		2.7 V ≤ EVDD ≤ 5.5 V	fMCK > 16 MHz	8/fMCK		—		—		—	—		
			fMCK ≤ 16 MHz	6/fMCK		6/fMCK		6/fMCK		6/fMCK			
		2.4 V ≤ EVDD ≤ 5.5 V			6/fMCK and 500								
		1.8 V ≤ EVDD ≤ 5.5 V			6/fMCK and 750								
		1.7 V ≤ EVDD ≤ 5.5 V			6/fMCK and 1500		6/fMCK and 1500						
1.6 V ≤ EVDD ≤ 5.5 V			—										
SCKp high-/low-level width	tkH2, tkL2	4.0 V ≤ EVDD ≤ 5.5 V		tkcy2/2 - 7		tkcy2/2 - 7		tkcy2/2 - 7		tkcy2/2 - 7		ns	
		2.7 V ≤ EVDD ≤ 5.5 V		tkcy2/2 - 8		tkcy2/2 - 8		tkcy2/2 - 8		tkcy2/2 - 8			
		1.8 V ≤ EVDD ≤ 5.5 V		tkcy2/2 - 18		tkcy2/2 - 18		tkcy2/2 - 18		tkcy2/2 - 18			
		1.7 V ≤ EVDD ≤ 5.5 V		tkcy2/2 - 66		tkcy2/2 - 66		tkcy2/2 - 66		tkcy2/2 - 66			
		1.6 V ≤ EVDD ≤ 5.5 V		—									
Slp setup time (to SCKp↑) Note 1	tsik2	2.7 V ≤ EVDD ≤ 5.5 V		1/fMCK + 20		1/fMCK + 30		1/fMCK + 30		1/fMCK + 30		ns	
		1.8 V ≤ EVDD ≤ 5.5 V		1/fMCK + 30		1/fMCK + 30		1/fMCK + 30		1/fMCK + 30			
		1.7 V ≤ EVDD ≤ 5.5 V		1/fMCK + 40		1/fMCK + 40		1/fMCK + 40		1/fMCK + 40			
		1.6 V ≤ EVDD ≤ 5.5 V		—									
Slp hold time (from SCKp↑) Note 2	tsis2	1.8 V ≤ EVDD ≤ 5.5 V		1/fMCK + 31		1/fMCK + 31		1/fMCK + 31		1/fMCK + 31		ns	
		1.7 V ≤ EVDD ≤ 5.5 V		1/fMCK + 250		1/fMCK + 250		1/fMCK + 250		1/fMCK + 250			
		1.6 V ≤ EVDD ≤ 5.5 V		—									

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSMn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit		
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.			
Delay time from SCKp <sub>↓</sub> to SOp output Note 1	t <sub>ksO2</sub>	C = 30 pF Note 2	2.7 V ≤ EVDD ≤ 5.5 V		2/f <sub>MCK</sub> + 44		2/f <sub>MCK</sub> + 110		2/f <sub>MCK</sub> + 110		2/f <sub>MCK</sub> + 110	ns	
			2.4 V ≤ EVDD ≤ 5.5 V		2/f <sub>MCK</sub> + 75								
			1.8 V ≤ EVDD ≤ 5.5 V		2/f <sub>MCK</sub> + 110								
			1.7 V ≤ EVDD ≤ 5.5 V		2/f <sub>MCK</sub> + 220								
			1.6 V ≤ EVDD ≤ 5.5 V										
SSI00 setup time	t <sub>ssik</sub>	DAPmn = 0	2.7 V ≤ EVDD ≤ 5.5 V	120		120		120		120		ns	
			1.8 V ≤ EVDD < 2.7 V	200		200		200		200			
			1.7 V ≤ EVDD < 1.8 V	400		400		400		400			
			1.6 V ≤ EVDD < 1.7 V	—									
		DAPmn = 1	2.7 V ≤ EVDD ≤ 5.5 V	1/f <sub>MCK</sub> + 120		1/f <sub>MCK</sub> + 120	ns						
			1.8 V ≤ EVDD < 2.7 V	1/f <sub>MCK</sub> + 200		1/f <sub>MCK</sub> + 200							
			1.7 V ≤ EVDD < 1.8 V	1/f <sub>MCK</sub> + 400		1/f <sub>MCK</sub> + 400							
			1.6 V ≤ EVDD < 1.7 V	—									
SSI00 hold time	t <sub>ssil</sub>	DAPmn = 0	2.7 V ≤ EVDD ≤ 5.5 V	1/f <sub>MCK</sub> + 120		ns							
			1.8 V ≤ EVDD < 2.7 V	1/f <sub>MCK</sub> + 200									
			1.7 V ≤ EVDD < 1.8 V	1/f <sub>MCK</sub> + 400									
			1.6 V ≤ EVDD < 1.7 V	—									
		DAPmn = 1	2.7 V ≤ EVDD ≤ 5.5 V	120		120		120		120		120	ns
			1.8 V ≤ EVDD < 2.7 V	200		200		200		200		200	
			1.7 V ≤ EVDD < 1.8 V	400		400		400		400		400	
			1.6 V ≤ EVDD < 1.7 V	—									

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp<sub>↑</sub>” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** C is the load capacitance of the SOp output lines.

**Caution** Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** f<sub>MCK</sub>: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**When P20 is used as SO10 pin****(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions		HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
				MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time Note 5	tkcy2	4.0 V ≤ VDD ≤ 5.5 V	fMCK > 20 MHz	14/fMCK	—	—	—	—	—	—	ns	
			fMCK ≤ 20 MHz	12/fMCK	12/fMCK	12/fMCK	12/fMCK	12/fMCK				
		2.7 V ≤ VDD ≤ 5.5 V	fMCK > 16 MHz and 850	14/fMCK	—	—	—	—	—			
			fMCK ≤ 16 MHz	12/fMCK and 850	12/fMCK	12/fMCK	12/fMCK	12/fMCK				
		2.4 V ≤ VDD ≤ 5.5 V		12/fMCK and 1000	12/fMCK	12/fMCK	12/fMCK	12/fMCK	12/fMCK			
		1.8 V ≤ VDD ≤ 5.5 V		—	12/fMCK	12/fMCK	12/fMCK	12/fMCK	12/fMCK			
		1.7 V ≤ VDD ≤ 5.5 V		—	—	—	—	12/fMCK	—			
1.6 V ≤ VDD ≤ 5.5 V		—	—	—	—	—	—					
SCKp high-/low-level width	tkH2, tkL2	4.0 V ≤ VDD ≤ 5.5 V		tkcy2/2 - 7	tkcy2/2 - 7	tkcy2/2 - 7	tkcy2/2 - 7	tkcy2/2 - 7	ns			
		2.7 V ≤ VDD ≤ 5.5 V		tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8	tkcy2/2 - 8				
		1.8 V ≤ VDD ≤ 5.5 V		—	tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18	tkcy2/2 - 18				
		1.7 V ≤ VDD ≤ 5.5 V		—	—	—	—	tkcy2/2 - 66				
		1.6 V ≤ VDD ≤ 5.5 V		—	—	—	—	—				
Slp setup time (to SCKp↑) Note 1	tsik2	2.7 V ≤ VDD ≤ 5.5 V		1/fMCK + 20	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	ns			
		1.8 V ≤ VDD ≤ 5.5 V		1/fMCK + 30	—	—	—	—				
		1.7 V ≤ VDD ≤ 5.5 V		—	—	—	—	1/fMCK + 40				
		1.6 V ≤ VDD ≤ 5.5 V		—	—	—	—	—				
Slp hold time (from SCKp↑) Note 2	tksl2	2.5 V ≤ VDD ≤ 5.5 V		1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	ns			
		1.8 V ≤ VDD ≤ 5.5 V		—	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31				
		1.7 V ≤ VDD ≤ 5.5 V		—	—	—	—	1/fMCK + 250				
		1.6 V ≤ VDD ≤ 5.5 V		—	—	—	—	—				
Delay time from SCKp↓ to SOp output Note 3	tkso2	C = 30 pF Note 4	2.7 V ≤ VDD ≤ 5.5 V	2/fMCK + 160	2/fMCK + 260	2/fMCK + 260	2/fMCK + 260	2/fMCK + 260	2/fMCK + 260	ns		
			2.4 V ≤ VDD ≤ 5.5 V	2/fMCK + 190								
			1.8 V ≤ VDD ≤ 5.5 V	—								
			1.7 V ≤ VDD ≤ 5.5 V	—								
			1.6 V ≤ VDD ≤ 5.5 V	—								

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SOp output lines.

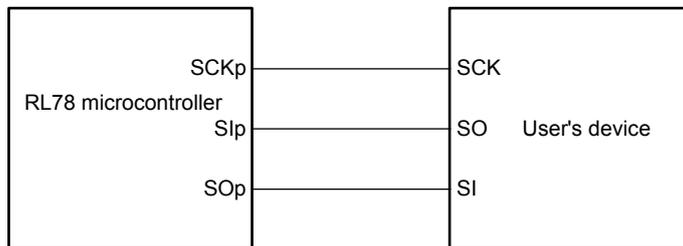
**Note 5.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 4 and 12)

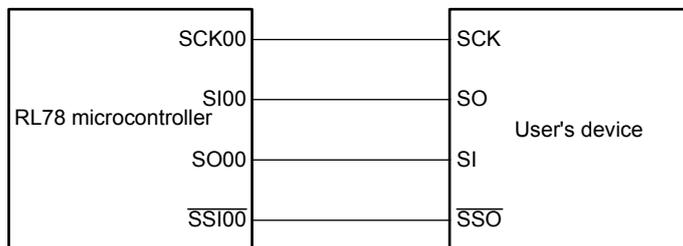
**Remark 2.** f<sub>MCK</sub>: Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,  
 n: Channel number (mn = 00 to 03))

**CSI mode connection diagram (during communication at same potential)**



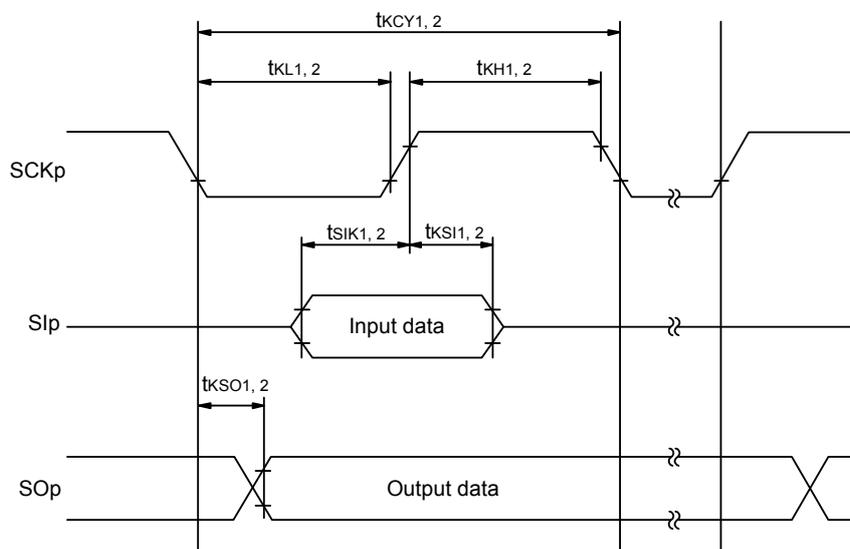
**CSI mode connection diagram (during communication at same potential)**

**(Slave Transmission of slave select input function (CSI00))**

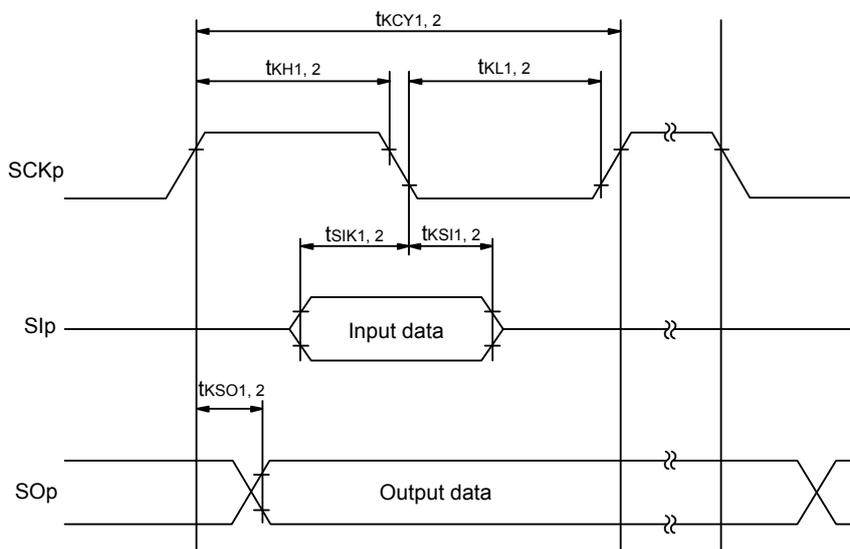


**Remark** p: CSI number (p = 00, 01, 10 and 11)

**CSI mode serial transfer timing (during communication at same potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (during communication at same potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark 1.** p: CSI number (p = 00, 01, 10 and 11)

**Remark 2.** m: Unit number, n: Channel number (mn = 00 to 03)

(5) During communication at same potential (simplified I<sup>2</sup>C mode)

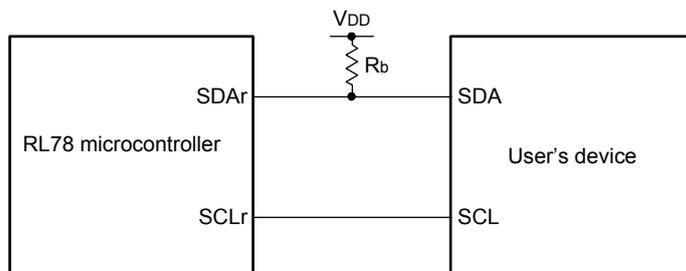
(TA = -40 to +85°C, 1.6 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLr clock frequency	f <sub>SCL</sub>	2.7 V ≤ EVDD ≤ 5.5 V, Cb = 50 pF, Rb = 2.7 kΩ		1000 Note 1		400 Note 1		250 Note 1		400 Note 1	kHz
		1.8 V ≤ EVDD ≤ 5.5 V, Cb = 100 pF, Rb = 3 kΩ		400 Note 1							
		1.8 V ≤ EVDD < 2.7 V, Cb = 100 pF, Rb = 5 kΩ		300 Note 1		300 Note 1		250 Note 1		300 Note 1	
		1.7 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ		250 Note 1		250 Note 1		250 Note 1		250 Note 1	
		1.6 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ		—							
Hold time when SCLr = "L"	t <sub>LOW</sub>	2.7 V ≤ EVDD ≤ 5.5 V, Cb = 50 pF, Rb = 2.7 kΩ	475		1150		1150		1150		ns
		1.8 V ≤ EVDD ≤ 5.5 V, Cb = 100 pF, Rb = 3 kΩ	1150								
		1.8 V ≤ EVDD < 2.7 V, Cb = 100 pF, Rb = 5 kΩ	1550		1550		1550		1550		
		1.7 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	1850		1850		1850		1850		
		1.6 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	—								
Hold time when SCLr = "H"	t <sub>HIGH</sub>	2.7 V ≤ EVDD ≤ 5.5 V, Cb = 50 pF, Rb = 2.7 kΩ	475		1150		1150		1150		ns
		1.8 V ≤ EVDD ≤ 5.5 V, Cb = 100 pF, Rb = 3 kΩ	1150								
		1.8 V ≤ EVDD < 2.7 V, Cb = 100 pF, Rb = 5 kΩ	1550		1550		1550		1550		
		1.7 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	1850		1850		1850		1850		
		1.6 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	—								
Data setup time (reception)	t <sub>SU: DAT</sub>	2.7 V ≤ EVDD ≤ 5.5 V, Cb = 50 pF, Rb = 2.7 kΩ	1/f <sub>MCK</sub> + 85 Note 2		1/f <sub>MCK</sub> + 145 Note 2		1/f <sub>MCK</sub> + 145 Note 2		1/f <sub>MCK</sub> + 145 Note 2		ns
		1.8 V ≤ EVDD ≤ 5.5 V, Cb = 100 pF, Rb = 3 kΩ	1/f <sub>MCK</sub> + 145 Note 2								
		1.8 V ≤ EVDD < 2.7 V, Cb = 100 pF, Rb = 5 kΩ	1/f <sub>MCK</sub> + 230 Note 2		1/f <sub>MCK</sub> + 230 Note 2		1/f <sub>MCK</sub> + 230 Note 2		1/f <sub>MCK</sub> + 230 Note 2		
		1.7 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	1/f <sub>MCK</sub> + 290 Note 2		1/f <sub>MCK</sub> + 290 Note 2		1/f <sub>MCK</sub> + 290 Note 2		1/f <sub>MCK</sub> + 290 Note 2		
		1.6 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	—		—		—		—		
Data hold time (transmission)	t <sub>HD: DAT</sub>	2.7 V ≤ EVDD ≤ 5.5 V, Cb = 50 pF, Rb = 2.7 kΩ	0	305	0	305	0	305	0	305	ns
		1.8 V ≤ EVDD ≤ 5.5 V, Cb = 100 pF, Rb = 3 kΩ		355		355		355		355	
		1.8 V ≤ EVDD < 2.7 V, Cb = 100 pF, Rb = 5 kΩ		405		405		405		405	
		1.7 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ									
		1.6 V ≤ EVDD < 1.8 V, Cb = 100 pF, Rb = 5 kΩ	—	—							

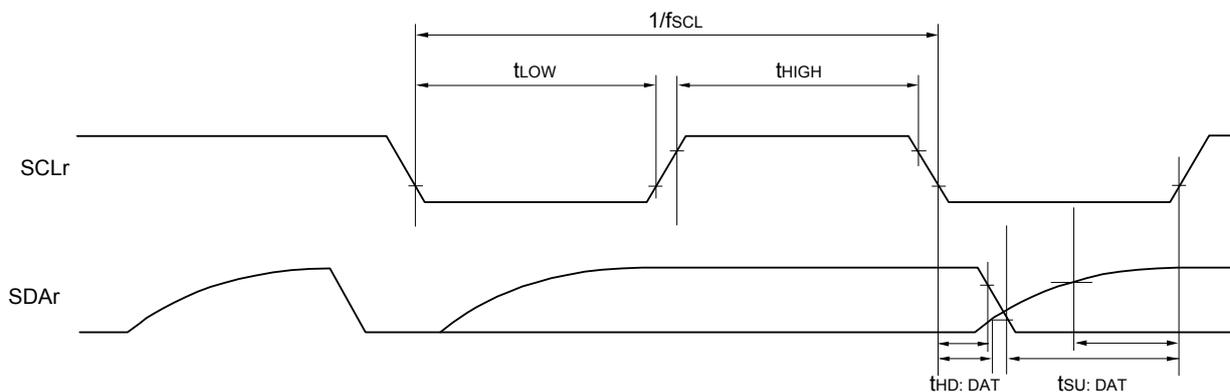
- Note 1.** The value must also be equal to or less than  $f_{MCK}/4$ .
- Note 2.** Set the  $f_{MCK}$  value to keep the hold time of  $SCLr = "L"$  and  $SCLr = "H"$ .

**Caution** Select the normal input buffer and the N-ch open drain output (EVDD tolerance) mode for the  $SDAr$  pin and the normal output mode for the  $SCLr$  pin by using port input mode register g (PIMg) and port output mode register h (POMh).

**Simplified I<sup>2</sup>C mode connection diagram (during communication at same potential)**



**Simplified I<sup>2</sup>C mode serial transfer timing (during communication at same potential)**



**Remark 1.**  $R_b[\Omega]$ : Communication line ( $SDAr$ ) pull-up resistance,  $C_b[F]$ : Communication line ( $SDAr$ ,  $SCLr$ ) load capacitance  
 r: IIC number (r = 00, 01, 10 and 11), g: PIM number (g = 0, 3 and 5), h: POM number (h = 0, 3 and 5)

**Remark 2.**  $f_{MCK}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the  $CKSmn$  bit of serial mode register  $mn$  ( $SMRmn$ ). m: Unit number (m = 0),  
 n: Channel number (n = 0 to 3),  $mn = 00$  to 03)

**(6) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (UART mode) (dedicated baud rate generator output)****(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit	
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Transfer rate		reception	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V		fMCK/6 Note 1		fMCK/6 Note 1		fMCK/6 Note 1		fMCK/6 Note 1	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		4.0		1.3		0.1		0.6	Mbps
			2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V		fMCK/6 Note 1		fMCK/6 Note 1		fMCK/6 Note 1		fMCK/6 Note 1	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		4.0		1.3		0.1		0.6	Mbps
			1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V		fMCK/6 Notes 1, 2, 4		fMCK/6 Notes 1, 2		fMCK/6 Notes 1, 2		fMCK/6 Notes 1, 2	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		4.0		1.3		0.1		0.6	Mbps

**Note 1.** Transfer rate in the SNOOZE mode is 4,800 bps only.**Note 2.** Use it with EVDD ≥ Vb.**Note 3.** The maximum operating frequencies of the CPU/peripheral hardware clock (fCLK) are:

HS (high-speed main) mode: 24 MHz (2.7 V ≤ VDD ≤ 5.5 V)  
16 MHz (2.4 V ≤ VDD ≤ 5.5 V)

LS (low-speed main) mode: 8 MHz (1.8 V ≤ VDD ≤ 5.5 V)

LP (low-power main) mode: 1 MHz (1.8 V ≤ VDD ≤ 5.5 V)

LV (low-voltage main) mode: 4 MHz (1.6 V ≤ VDD ≤ 5.5 V)

**Note 4.** The following conditions are required for low voltage interface when EVDD < VDD

2.4 V ≤ EVDD < 2.7 V: MAX. 2.6 Mbps

1.8 V ≤ EVDD < 2.4 V: MAX. 1.3 Mbps

**Caution** Select the TTL input buffer for the RxDq pin and the N-ch open drain output (EVDD tolerance) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

**Remark 1.** Vb[V]: Communication line voltage**Remark 2.** q: UART number (q = 0 and 1), g: PIM and POM number (g = 0, 2, 3, 5 and 12)**Remark 3.** fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03)

(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit	
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
Transfer rate		Transmission	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V		Note 1		Note 1		Note 1		Note 1	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 1.4 kΩ, Vb = 2.7 V		2.8 Note 2		2.8 Note 2		2.8 Note 2		2.8 Note 2	Mbps
			2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V		Note 3		Note 3		Note 3		Note 3	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 2.7 kΩ, Vb = 2.3 V		1.2 Note 4		1.2 Note 4		1.2 Note 4		1.2 Note 4	Mbps
			1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V		Notes 5, 6		Notes 5, 6		Notes 5, 6		Notes 5, 6	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 5.5 kΩ, Vb = 1.6 V		0.43 Note 7		0.43 Note 7		0.43 Note 7		0.43 Note 7	Mbps

**Note 1.** The smaller maximum transfer rate derived by using fMCK/6 or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when 4.0 V ≤ EVDD ≤ 5.5 V and 2.7 V ≤ Vb ≤ 4.0 V

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{2.2}{V_b})\} \times 3} \text{ [bps]}$$

$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{2.2}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

**Note 2.** This value as an example is calculated when the conditions described in the “Conditions” column are met. Refer to Note 1 above to calculate the maximum transfer rate under conditions of the customer.

**Note 3.** The smaller maximum transfer rate derived by using fMCK/6 or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when 2.7 V ≤ EVDD ≤ 4.0 V and 2.3 V ≤ Vb ≤ 2.7 V

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{2.0}{V_b})\} \times 3} \text{ [bps]}$$

$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{2.0}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

**Note 4.** This value as an example is calculated when the conditions described in the “Conditions” column are met. Refer to Note 3. above to calculate the maximum transfer rate under conditions of the customer.

**Note 5.** Use it with EVDD ≥ Vb.

**Note 6.** The smaller maximum transfer rate derived by using  $f_{MCK}/6$  or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when  $1.8\text{ V} \leq EV_{DD} < 3.3\text{ V}$  and  $1.6\text{ V} \leq V_b \leq 2.0\text{ V}$

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\} \times 3} \text{ [bps]}$$

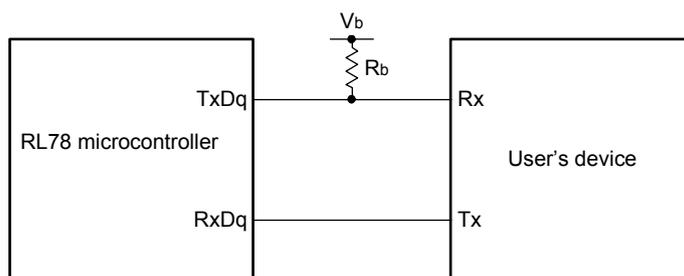
$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

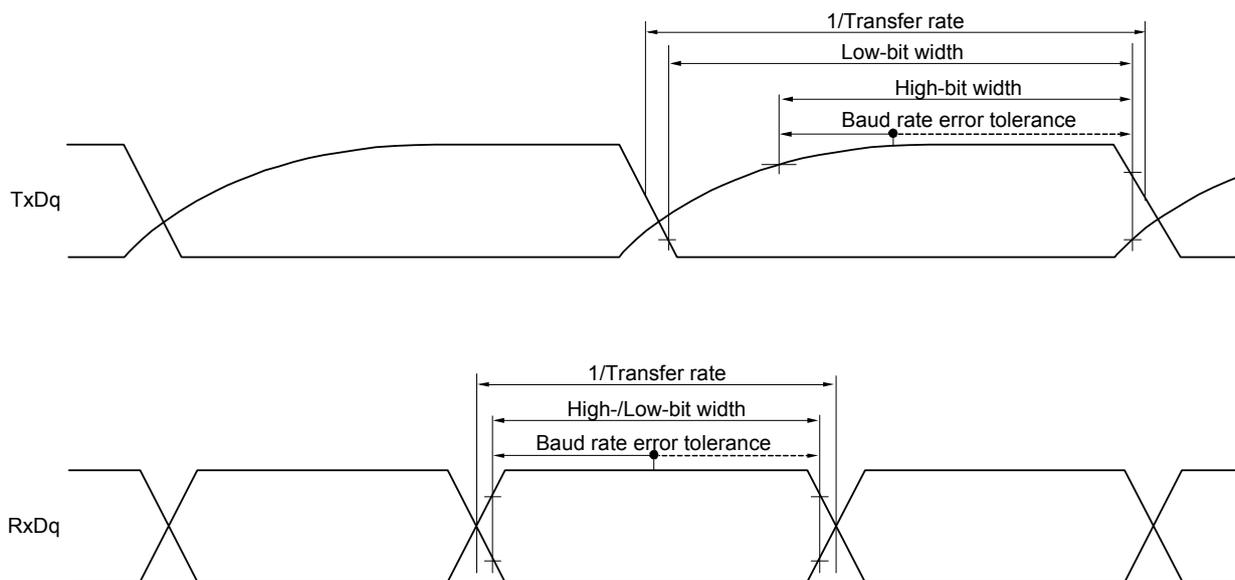
**Note 7.** This value as an example is calculated when the conditions described in the “Conditions” column are met. Refer to Note 6 above to calculate the maximum transfer rate under conditions of the customer.

**Caution** Select the TTL input buffer for the RxDq pin and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

**UART mode connection diagram (during communication at different potential)**



**UART mode bit width (during communication at different potential) (reference)**



**Remark 1.**  $R_b[\Omega]$ : Communication line (TxDq) pull-up resistance,  $C_b[F]$ : Communication line (TxDq) load capacitance,  $V_b[V]$ : Communication line voltage

**Remark 2.** q: UART number (q = 0 and 1), g: PIM and POM number (g = 0, 2, 3, 5 and 12)

**Remark 3.**  $f_{MCK}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**(7) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (master mode, SCKp... internal clock output, corresponding CSI00 only)****(TA = -40 to +85°C, 2.7 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY1	tkCY1 ≥ 2/fCLK 4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	200		1150		1150		1150		ns
		tkCY1 ≥ 2/fCLK 2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ	300								ns
SCKp high-level width	tkH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ	tkCY1/2 - 120		tkCY1/2 - 120		tkCY1/2 - 120		tkCY1/2 - 120		ns
SCKp low-level width	tkL1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	tkCY1/2 - 7		tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ	tkCY1/2 - 10								
Slp setup time (to SCKp↑) Note 1	tSIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	58		479		479		479		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ	121								
Slp hold time (from SCKp↑) Note 1	tKSI1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	10		10		10		10		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ									
Delay time from SCKp↓ to SOP output Note 1	tkSO1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ		60		60		60		60	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ		130		130		130		130	
Slp setup time (to SCKp↓) Note 2	tSIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	23		110		110		110		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ	33								
Slp hold time (from SCKp↓) Note 2	tKSI1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ	10		10		10		10		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ									

(TA = -40 to +85°C, 2.7 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Delay time from SCKp↑ to SOp output <sup>Note 2</sup>	tkSO1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 20 pF, Rb = 1.4 kΩ		10		10		10		10	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 20 pF, Rb = 2.7 kΩ									

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.

**Note 2.** When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Caution** Select the TTL input buffer for the SIp pin and the N-ch open drain output (EVDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

**Remark 1.** Rb[i]: Communication line (SCKp, SOp) pull-up resistance, Cb[F]: Communication line (SCKp, SOp) load capacitance, Vb[V]: Communication line voltage

**Remark 2.** p: CSI number (p = 00), m: Unit number (m = 0), n: Channel number (n = 0), g: PIM and POM number (g = 5)

**Remark 3.** fмск: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00))

**(8) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (master mode, SCKp... internal clock output)****(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time	tkCY1	tkCY1 ≥ 4/fCLK 4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	300		1150		1150		1150		ns
			500								ns
			1150								ns
SCKp high-level width	tkH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	tkCY1/2 - 75		tkCY1/2 - 75		tkCY1/2 - 75		tkCY1/2 - 75		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	tkCY1/2 - 170		tkCY1/2 - 170		tkCY1/2 - 170		tkCY1/2 - 170		ns
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note, Cb = 30 pF, Rb = 5.5 kΩ	tkCY1/2 - 458		tkCY1/2 - 458		tkCY1/2 - 458		tkCY1/2 - 458		ns
SCKp low-level width	tkL1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	tkCY1/2 - 12		tkCY1/2 - 50		tkCY1/2 - 50		tkCY1/2 - 50		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	tkCY1/2 - 18								
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note, Cb = 30 pF, Rb = 5.5 kΩ	tkCY1/2 - 50								ns

**Note** Use it with EVDD ≥ Vb.**Caution** Select the TTL input buffer for the SIp pin and the N-ch open drain output (EVDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the page after the next page.)

**(8) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (master mode, SCKp... internal clock output)****(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, Vss = 0 V)****(2/2)**

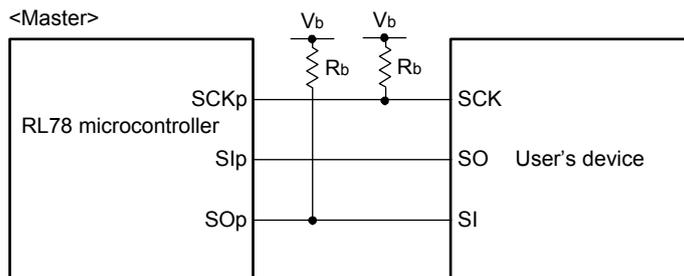
Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
Slp setup time (to SCKp↑) Note 1	tsIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	81		479		479		479		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	177								
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ	479								
Slp hold time (from SCKp↑) Note 1	tkSH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	19		19		19		19		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ									
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ									
Delay time from SCKp↓ to SOp output Note 1	tkSO1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ		100		100		100		100	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ		195		195		195		195	
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ		483		483		483		483	
Slp setup time (to SCKp↓) Note 2	tsIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	44		110		110		110		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ									
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ	110								
Slp hold time (from SCKp↓) Note 2	tkSH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	19		19		19		19		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ									
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ									
Delay time from SCKp↑ to SOp output Note 2	tkSO1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ		25		25		25		25	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ									
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ									

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.**Note 2.** When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.**Note 3.** Use it with EVDD ≥ Vb.

**Caution** Select the TTL input buffer for the Slp pin and the N-ch open drain output (EVDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the next page.)

**CSI mode connection diagram (during communication at different potential)**

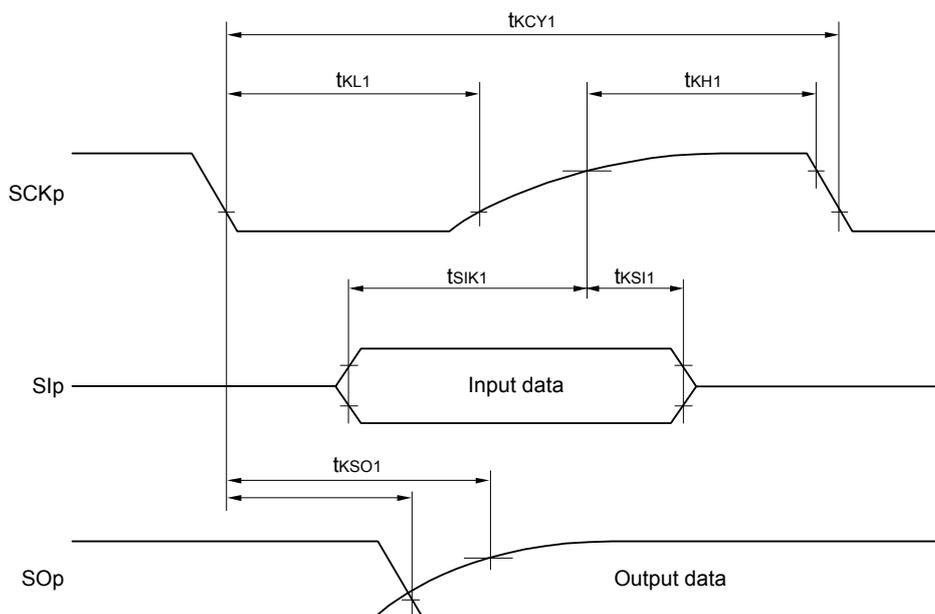


**Remark 1.**  $R_b[\Omega]$ : Communication line (SCKp, SOp) pull-up resistance,  $C_b[F]$ : Communication line (SCKp, SOp) load capacitance,  $V_b[V]$ : Communication line voltage

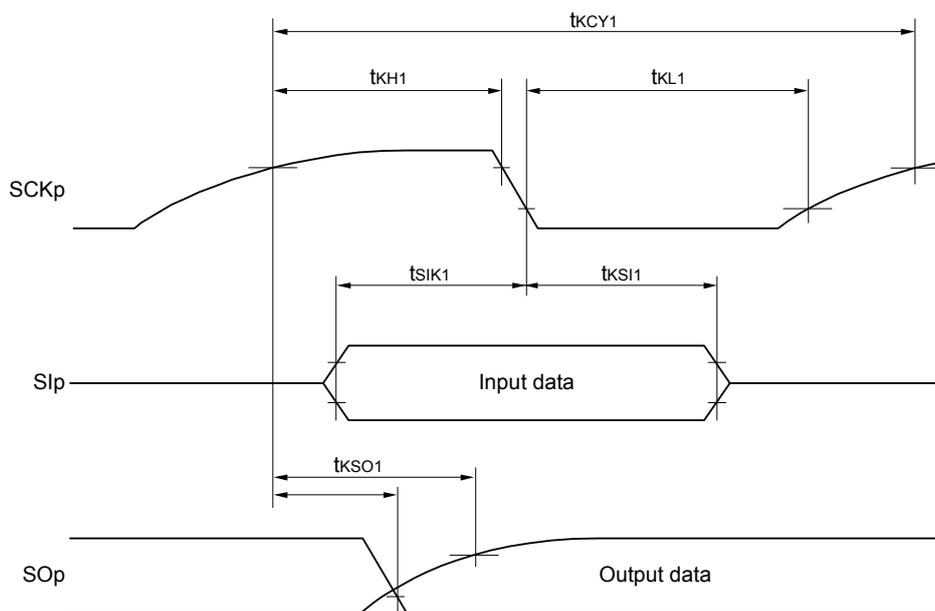
**Remark 2.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 3.**  $f_{mck}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**(9) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (slave mode, SCKp... external clock input)**

**(TA = -40 to 85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

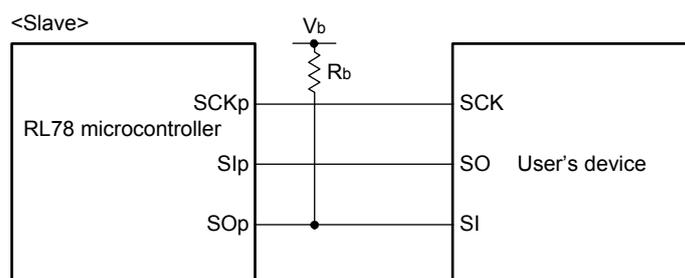
Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCKp cycle time Note 1	tkcy2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V	20 MHz < fMCK ≤ 24 MHz	12/fMCK	—	—	—	—	—	—	ns
			8 MHz < fMCK ≤ 20 MHz	10/fMCK	—	—	—	—	—	—	ns
			4 MHz < fMCK ≤ 8 MHz	8/fMCK	—	16/fMCK	—	—	—	—	ns
			fMCK ≤ 4 MHz	6/fMCK	—	10/fMCK	10/fMCK	10/fMCK	10/fMCK	ns	
	2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V	20 MHz < fMCK ≤ 24 MHz	16/fMCK	—	—	—	—	—	—	ns	
		16 MHz < fMCK ≤ 20 MHz	14/fMCK	—	—	—	—	—	—	ns	
		8 MHz < fMCK ≤ 16 MHz	12/fMCK	—	—	—	—	—	—	ns	
		4 MHz < fMCK ≤ 8 MHz	8/fMCK	—	16/fMCK	—	—	—	—	ns	
	1.8 V ≤ EVDD < 2.7 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2	20 MHz < fMCK ≤ 24 MHz	36/fMCK	—	—	—	—	—	—	ns	
		16 MHz < fMCK ≤ 20 MHz	32/fMCK	—	—	—	—	—	—	ns	
		8 MHz < fMCK ≤ 16 MHz	26/fMCK	—	—	—	—	—	—	ns	
		4 MHz < fMCK ≤ 8 MHz	16/fMCK	—	16/fMCK	—	—	—	—	ns	
	fMCK ≤ 4 MHz	10/fMCK	—	10/fMCK	10/fMCK	10/fMCK	10/fMCK	10/fMCK	10/fMCK	ns	
		SCKp high-/low-level width		tkH2, tkL2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V	tkcy2/2 - 12	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	ns
					2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V	tkcy2/2 - 18	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	ns
					1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	tkcy2/2 - 50	ns
Slp setup time (to SCKp1) Note 3	tsiK2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V	1/fMCK + 20	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	ns		
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V	1/fMCK + 20	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	ns		
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	1/fMCK + 30	ns		
Slp hold time (from SCKp1) Note 3	tsi2		1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	1/fMCK + 31	ns			
Delay time from SCKp↓ to SOP output Note 4	tkso2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	2/fMCK + 120	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	ns		
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	2/fMCK + 214	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	ns		
		1.8 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 30 pF, Rb = 5.5 kΩ	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	2/fMCK + 573	ns		

(Notes, Caution and Remarks are listed on the next page.)

- Note 1.** Transfer rate in the SNOOZE mode: MAX. 1 Mbps
- Note 2.** Use it with  $EV_{DD} \geq V_b$ .
- Note 3.** When  $DAP_{mn} = 0$  and  $CKP_{mn} = 0$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 1$ . The  $S_{lp}$  setup time becomes “to  $SCK_{p\downarrow}$ ” when  $DAP_{mn} = 0$  and  $CKP_{mn} = 1$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 0$ .
- Note 4.** When  $DAP_{mn} = 0$  and  $CKP_{mn} = 0$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 1$ . The delay time to  $SOp$  output becomes “from  $SCK_{p\uparrow}$ ” when  $DAP_{mn} = 0$  and  $CKP_{mn} = 1$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 0$ .

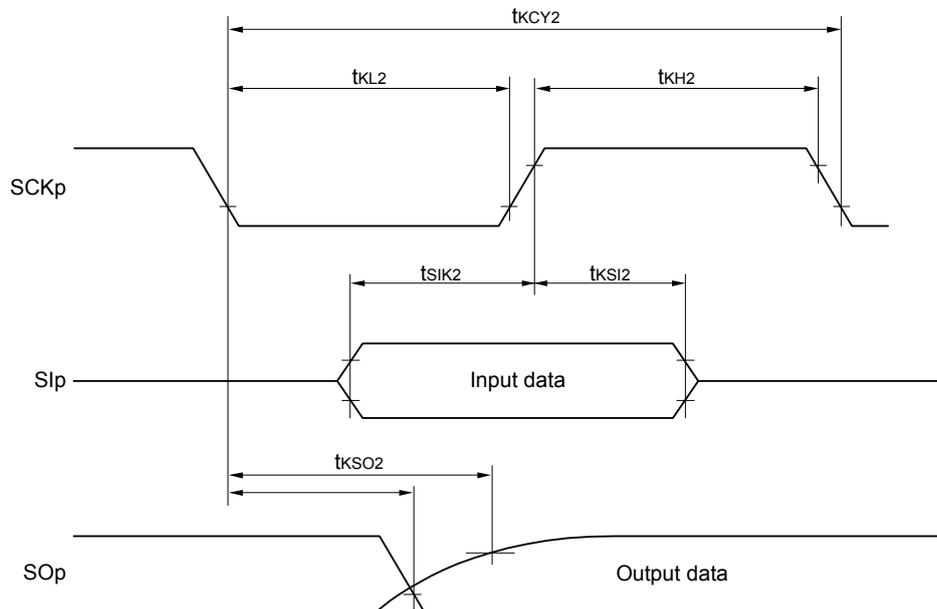
**Caution** Select the TTL input buffer for the  $S_{lp}$  pin and  $SCK_p$  pin and the N-ch open drain output ( $EV_{DD}$  tolerance) mode for the  $SOp$  pin by using port input mode register g (PIMg) and port output mode register g (POMg). For  $V_{IH}$  and  $V_{IL}$ , see the DC characteristics with TTL input buffer selected.

**CSI mode connection diagram (during communication at different potential)**

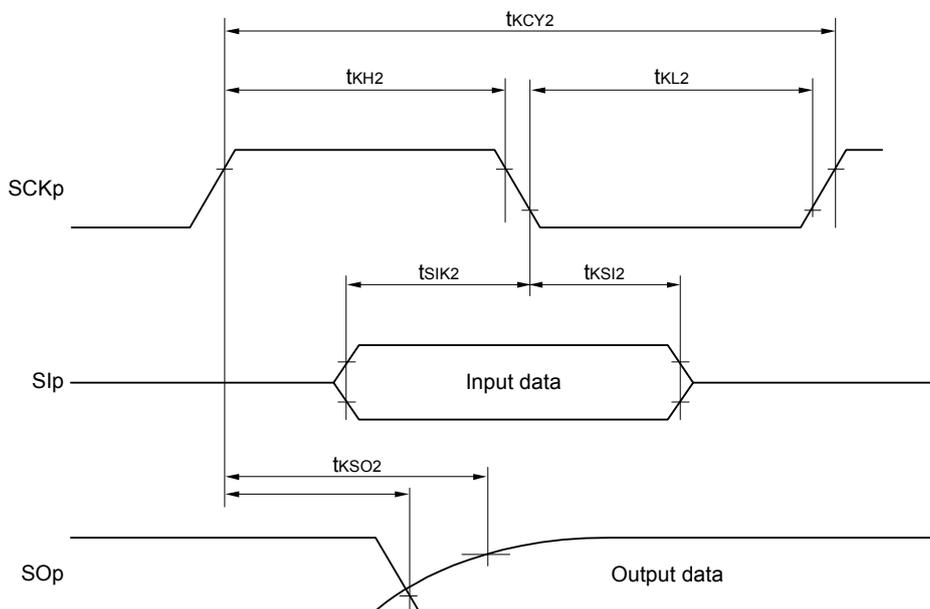


- Remark 1.**  $R_b[\Omega]$ : Communication line (SO<sub>p</sub>) pull-up resistance,  $C_b[F]$ : Communication line (SO<sub>p</sub>) load capacitance,  $V_b[V]$ : Communication line voltage
- Remark 2.** p: CSI number (p = 00 to 03), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)
- Remark 3.**  $f_{MCK}$ : Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**CSI mode serial transfer timing (slave mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (slave mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

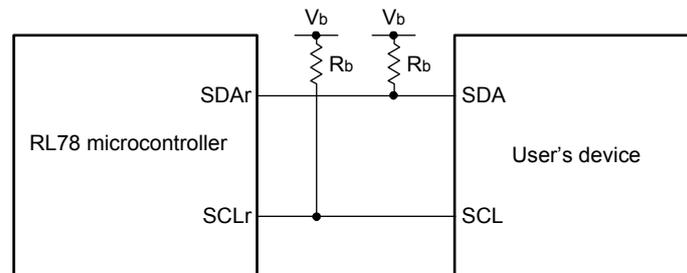
(10) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (simplified I<sup>2</sup>C mode)(TA = -40 to 85°C, 1.8 V ≤ EV<sub>DD</sub> ≤ V<sub>DD</sub> ≤ 5.5 V, V<sub>SS</sub> = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		LS (low-speed main) Mode		LP (Low-power main) mode		LV (low-voltage main) Mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLr clock frequency	f <sub>SCL</sub>	4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ		1000 Note 1		300 Note 1		250 Note 1		300 Note 1	kHz
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ		1000 Note 1		300 Note 1		250 Note 1		300 Note 1	kHz
		4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.8 kΩ		400 Note 1		300 Note 1		250 Note 1		300 Note 1	kHz
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ		400 Note 1		300 Note 1		250 Note 1		300 Note 1	kHz
		1.8 V ≤ EV <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ		300 Note 1		300 Note 1		250 Note 1		300 Note 1	kHz
Hold time when SCLr = "L"	t <sub>LOW</sub>	4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	475		1550		1550		1550		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	475		1550		1550		1550		ns
		4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.8 kΩ	1150		1550		1550		1550		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	1150		1550		1550		1550		ns
		1.8 V ≤ EV <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	1550		1550		1550		1550		ns
Hold time when SCLr = "H"	t <sub>HIGH</sub>	4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	245		610		610		610		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	200		610		610		610		ns
		4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.8 kΩ	675		610		610		610		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	600		610		610		610		ns
		1.8 V ≤ EV <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	610		610		610		610		ns
Data setup time (reception)	t <sub>SU-DAT</sub>	4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 135 Note 3		1/f <sub>MCK</sub> + 190 Note 2		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 135 Note 3		1/f <sub>MCK</sub> + 190 Note 2		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		ns
		4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.8 kΩ	1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		ns
		1.8 V ≤ EV <sub>DD</sub> < 4.0 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		1/f <sub>MCK</sub> + 190 Note 3		ns
Data hold time (transmission)	t <sub>HD-DAT</sub>	4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	0	305	0	305	0	305	0	305	ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	0	305	0	305	0	305	0	305	ns
		4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V, 2.7 V ≤ V <sub>b</sub> ≤ 4.0 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.8 kΩ	0	355	0	355	0	355	0	355	ns
		2.7 V ≤ EV <sub>DD</sub> < 4.0 V, 2.3 V ≤ V <sub>b</sub> ≤ 2.7 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 2.7 kΩ	0	355	0	355	0	355	0	355	ns
		1.8 V ≤ EV <sub>DD</sub> < 3.3 V, 1.6 V ≤ V <sub>b</sub> ≤ 2.0 V Note 2, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 5.5 kΩ	0	405	0	405	0	405	0	405	ns

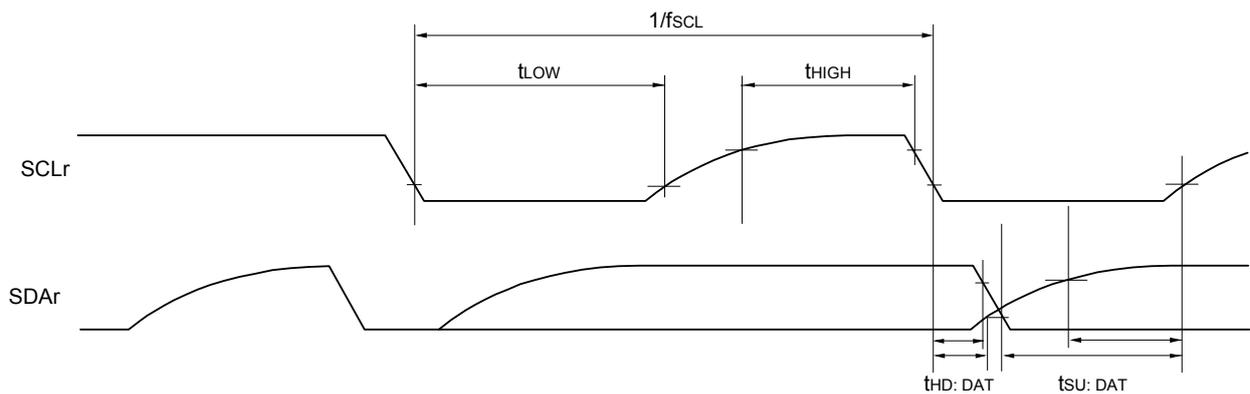
- Note 1.** The value must also be equal to or less than  $f_{MCK}/4$ .
- Note 2.** Use it with  $EV_{DD} \geq V_b$ .
- Note 3.** Set the  $f_{MCK}$  value to keep the hold time of  $SCLr = "L"$  and  $SCLr = "H"$ .

**Caution** Select the TTL input buffer and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the SDA<sub>r</sub> pin and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the SCL<sub>r</sub> pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

#### Simplified I<sup>2</sup>C mode connection diagram (during communication at different potential)



#### Simplified I<sup>2</sup>C mode serial transfer timing (during communication at different potential)



- Remark 1.** R<sub>b</sub>[Ω]: Communication line (SDA<sub>r</sub>, SCL<sub>r</sub>) pull-up resistance, C<sub>b</sub>[F]: Communication line (SDA<sub>r</sub>, SCL<sub>r</sub>) load capacitance, V<sub>b</sub>[V]: Communication line voltage
- Remark 2.** r: IIC number (r = 00, 01, 10 and 11), g: PIM, POM number (g = 0, 3 and 5)
- Remark 3.** f<sub>MCK</sub>: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number (m = 0), n: Channel number (n = 0 to 3), mn = 00 to 03)

## 2.5.2 Serial interface IICA

### (1) I<sup>2</sup>C standard mode

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) mode		LS (low-speed main) mode		LP (Low-power main) mode		LV (low-voltage main) mode		Unit	
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
SCLA0 clock frequency	f <sub>SCL</sub>	Standard mode: f <sub>CLK</sub> ≥ 1 MHz	2.7 V ≤ EVDD ≤ 5.5 V	0	100	0	100	0	100	0	100	kHz
			1.8 V ≤ EVDD ≤ 5.5 V	0	100	0	100	0	100	0	100	kHz
			1.7 V ≤ EVDD ≤ 5.5 V	0	100	0	100	0	100	0	100	kHz
			1.6 V ≤ EVDD ≤ 5.5 V	—		0	100	0	100	0	100	kHz
Setup time of restart condition	t <sub>SU: STA</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.7		4.7		4.7		μs	
Hold time Note 1	t <sub>HD: STA</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.0		4.0		4.0		μs	
Hold time when SCLA0 = "L"	t <sub>LOW</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.7		4.7		4.7		μs	
Hold time when SCLA0 = "H"	t <sub>HIGH</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.0		4.0		4.0		μs	
Data setup time (reception)	t <sub>SU: DAT</sub>	2.7 V ≤ EVDD ≤ 5.5 V	250		250		250		250		ns	
		1.8 V ≤ EVDD ≤ 5.5 V	250		250		250		250		ns	
		1.7 V ≤ EVDD ≤ 5.5 V	250		250		250		250		ns	
		1.6 V ≤ EVDD ≤ 5.5 V	—		250		250		250		ns	
Data hold time (transmission) Note 2	t <sub>HD: DAT</sub>	2.7 V ≤ EVDD ≤ 5.5 V	0	3.45	0	3.45	0	3.45	0	3.45	μs	
		1.8 V ≤ EVDD ≤ 5.5 V	0	3.45	0	3.45	0	3.45	0	3.45	μs	
		1.7 V ≤ EVDD ≤ 5.5 V	0	3.45	0	3.45	0	3.45	0	3.45	μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		0	3.45	0	3.45	0	3.45	μs	
Setup time of stop condition	t <sub>SU: STO</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.0		4.0		4.0		4.0		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.0		4.0		4.0		μs	
Bus-free time	t <sub>BUF</sub>	2.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.8 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.7 V ≤ EVDD ≤ 5.5 V	4.7		4.7		4.7		4.7		μs	
		1.6 V ≤ EVDD ≤ 5.5 V	—		4.7		4.7		4.7		μs	

**Note 1.** The first clock pulse is generated after this period when the start/restart condition is detected.

**Note 2.** The maximum value (MAX.) of t<sub>HD: DAT</sub> is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

**Caution** The values in the above table are applied even when bit 2 (PIOR02) in the peripheral I/O redirection register 0 (PIOR0) is 1. At this time, the pin characteristics (I<sub>OH1</sub>, I<sub>OL1</sub>, V<sub>OH1</sub>, V<sub>OL1</sub>) must satisfy the values in the redirect destination.

**Remark** The maximum value of C<sub>b</sub> (communication line capacitance) and the value of R<sub>b</sub> (communication line pull-up resistor) at that time in each mode are as follows.

Standard mode: C<sub>b</sub> = 400 pF, R<sub>b</sub> = 2.7 kΩ

(2) I<sup>2</sup>C fast mode

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) mode		LS (low-speed main) mode		LP (Low-power main) mode		LV (low-voltage main) mode		Unit	
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.		
SCLA0 clock frequency	fsCL	Fast mode: fCLK ≥ 3.5 MHz	2.7 V ≤ EVDD ≤ 5.5 V	0	400	0	400	0	400	0	400	kHz
			1.8 V ≤ EVDD ≤ 5.5 V	0	400	0	400	0	400	0	400	kHz
Setup time of restart condition	tsu: STA	2.7 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
		1.8 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
Hold time <sup>Note 1</sup>	tHD: STA	2.7 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
		1.8 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
Hold time when SCLA0 = "L"	tLOW	2.7 V ≤ EVDD ≤ 5.5 V	1.3		1.3		1.3		1.3			μs
		1.8 V ≤ EVDD ≤ 5.5 V	1.3		1.3		1.3		1.3			μs
Hold time when SCLA0 = "H"	tHIGH	2.7 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
		1.8 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
Data setup time (reception)	tsu: DAT	2.7 V ≤ EVDD ≤ 5.5 V	100		100		100		100			ns
		1.8 V ≤ EVDD ≤ 5.5 V	100		100		100		100			ns
Data hold time (transmission) <sup>Note 2</sup>	tHD: DAT	2.7 V ≤ EVDD ≤ 5.5 V	0	0.9	0	0.9	0	0.9	0	0.9		μs
		1.8 V ≤ EVDD ≤ 5.5 V	0	0.9	0	0.9	0	0.9	0	0.9		μs
Setup time of stop condition	tsu: STO	2.7 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
		1.8 V ≤ EVDD ≤ 5.5 V	0.6		0.6		0.6		0.6			μs
Bus-free time	tBUF	2.7 V ≤ EVDD ≤ 5.5 V	1.3		1.3		1.3		1.3			μs
		1.8 V ≤ EVDD ≤ 5.5 V	1.3		1.3		1.3		1.3			μs

**Note 1.** The first clock pulse is generated after this period when the start/restart condition is detected.

**Note 2.** The maximum value (MAX.) of tHD: DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

**Caution** The values in the above table are applied even when bit 2 (PIOR02) in the peripheral I/O redirection register 0 (PIOR0) is 1. At this time, the pin characteristics (IOH1, IO L1, VO H1, VO L1) must satisfy the values in the redirect destination.

**Remark** The maximum value of C<sub>b</sub> (communication line capacitance) and the value of R<sub>b</sub> (communication line pull-up resistor) at that time in each mode are as follows.

Fast mode: C<sub>b</sub> = 320 pF, R<sub>b</sub> = 1.1 kΩ

**(3) I<sup>2</sup>C fast mode plus**

(TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) mode		LS (low-speed main) mode		LP (Low-power main) mode		LV (low-voltage main) mode		Unit
			MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fsCL	Fast mode plus: fCLK ≥ 10 MHz	2.7 V ≤ EVDD ≤ 5.5 V	0	1000	—	—	—	—	—	kHz
Setup time of restart condition	tsU: STA	2.7 V ≤ EVDD ≤ 5.5 V		0.26		—	—	—	—		μs
Hold time Note 1	tHD: STA	2.7 V ≤ EVDD ≤ 5.5 V		0.26		—	—	—	—		μs
Hold time when SCLA0 = "L"	tLOW	2.7 V ≤ EVDD ≤ 5.5 V		0.5		—	—	—	—		μs
Hold time when SCLA0 = "H"	tHIGH	2.7 V ≤ EVDD ≤ 5.5 V		0.26		—	—	—	—		μs
Data setup time (reception)	tsU: DAT	2.7 V ≤ EVDD ≤ 5.5 V		50		—	—	—	—		ns
Data hold time (transmission) Note 2	tHD: DAT	2.7 V ≤ EVDD ≤ 5.5 V		0	0.45		—	—	—		μs
Setup time of stop condition	tsU: STO	2.7 V ≤ EVDD ≤ 5.5 V		0.26		—	—	—	—		μs
Bus-free time	tBUF	2.7 V ≤ EVDD ≤ 5.5 V		0.5		—	—	—	—		μs

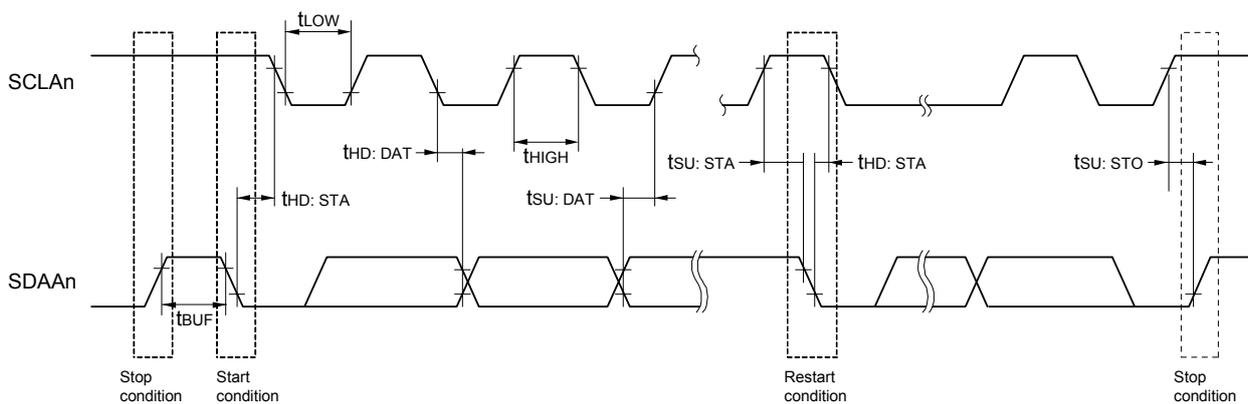
**Note 1.** The first clock pulse is generated after this period when the start/restart condition is detected.

**Note 2.** The maximum value (MAX.) of tHD: DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

**Caution** The values in the above table are applied even when bit 2 (PIOR02) in the peripheral I/O redirection register 0 (PIOR0) is 1. At this time, the pin characteristics (IOH1, IOL1, VOH1, VOL1) must satisfy the values in the redirect destination.

**Remark** The maximum value of Cb (communication line capacitance) and the value of Rb (communication line pull-up resistor) at that time in each mode are as follows.  
Fast mode plus: Cb = 120 pF, Rb = 1.1 kΩ

**I<sup>2</sup>C serial transfer timing**



**Remark** n = 0, 1

## 2.6 Analog Characteristics

### 2.6.1 A/D converter characteristics

#### Classification of A/D converter characteristics

Input channel	Reference Voltage	Reference voltage (+) = AVREFP Reference voltage (-) = AVREFM	Reference voltage (+) = VDD Reference voltage (-) = VSS	Reference voltage (+) = VBGR Reference voltage (-) = AVREFM
ANI0 to ANI3		Refer to 2.6.1 (1).	Refer to 2.6.1 (3).	Refer to 2.6.1 (4).
ANI16 to ANI22		Refer to 2.6.1 (2).		
Internal reference voltage Temperature sensor output voltage		Refer to 2.6.1 (1).		

(1) When reference voltage (+) = AVREFP/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target pin: ANI2 and ANI3, internal reference voltage, and temperature sensor output voltage

(TA = -40 to +85°C, 1.6 V ≤ AVREFP ≤ VDD ≤ 5.5 V, VSS = 0 V, Reference voltage (+) = AVREFP, Reference voltage (-) = AVREFM = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	RES		8		10	bit
Overall error Note 1	AINL	10-bit resolution AVREFP = VDD Note 3	1.8 V ≤ AVREFP ≤ 5.5 V	1.2	±3.5	LSB
			1.6 V ≤ AVREFP ≤ 5.5 V Note 4	1.2	±7.0	LSB
Conversion time	tCONV	10-bit resolution Target pin: ANI2 and ANI3	3.6 V ≤ VDD ≤ 5.5 V	2.125	39	μs
			2.7 V ≤ VDD ≤ 5.5 V	3.1875	39	μs
			1.8 V ≤ VDD ≤ 5.5 V	17	39	μs
			1.6 V ≤ VDD ≤ 5.5 V	57	95	μs
		10-bit resolution Target pin: Internal reference voltage, and temperature sensor output voltage	3.6 V ≤ VDD ≤ 5.5 V	2.375	39	μs
			2.7 V ≤ VDD ≤ 5.5 V	3.5625	39	μs
Zero-scale error Notes 1, 2	EZS	10-bit resolution AVREFP = VDD Note 3	1.8 V ≤ AVREFP ≤ 5.5 V		±0.25	%FSR
			1.6 V ≤ AVREFP ≤ 5.5 V Note 4		±0.50	%FSR
Full-scale error Notes 1, 2	EFS	10-bit resolution AVREFP = VDD Note 3	1.8 V ≤ AVREFP ≤ 5.5 V		±0.25	%FSR
			1.6 V ≤ AVREFP ≤ 5.5 V Note 4		±0.50	%FSR
Integral linearity error Note 1	ILE	10-bit resolution AVREFP = VDD Note 3	1.8 V ≤ AVREFP ≤ 5.5 V		±2.5	LSB
			1.6 V ≤ AVREFP ≤ 5.5 V Note 4		±5.0	LSB
Differential linearity error Note 1	DLE	10-bit resolution AVREFP = VDD Note 3	1.8 V ≤ AVREFP ≤ 5.5 V		±1.5	LSB
			1.6 V ≤ AVREFP ≤ 5.5 V Note 4		±2.0	LSB
Analog input voltage	VAIN	ANI2 and ANI3	0		AVREFP	V
		Internal reference voltage (1.8 V ≤ VDD ≤ 5.5 V)			VBGR Note 5	V
		Temperature sensor output voltage (1.8 V ≤ VDD ≤ 5.5 V)			VTMPS25 Note 5	V

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (%FSR) to the full-scale value.

**Note 3.** When AVREFP < VDD, the MAX. values are as follows.

Overall error: Add ±1.0 LSB to the MAX. value when AVREFP = VDD.

Zero-scale error/Full-scale error: Add ±0.05%FSR to the MAX. value when AVREFP = VDD.

Integral linearity error/ Differential linearity error: Add ±0.5 LSB to the MAX. value when AVREFP = VDD.

**Note 4.** Values when the conversion time is set to 57 μs (min.) and 95 μs (max.).

**Note 5.** Refer to 2.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

(2) When reference voltage (+) =  $AV_{REFP}/ANI0$  ( $ADREFP1 = 0$ ,  $ADREFP0 = 1$ ), reference voltage (-) =  $AV_{REFM}/ANI1$  ( $ADREFM = 1$ ), target pin: ANI16 to ANI22

(TA = -40 to +85°C,  $1.6\text{ V} \leq EV_{DD} \leq V_{DD} \leq 5.5\text{ V}$ ,  $1.6\text{ V} \leq AV_{REFP} \leq V_{DD} \leq 5.5\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,

Reference voltage (+) =  $AV_{REFP}$ , Reference voltage (-) =  $AV_{REFM} = 0\text{ V}$ )

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Resolution	RES		8		10	bit	
Overall error Note 1	AINL	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$1.8\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$		1.2	±5.0	LSB
			$1.6\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$ Note 5		1.2	±8.5	LSB
Conversion time	t <sub>CONV</sub>	10-bit resolution Target ANI pin: ANI16 to ANI22	$3.6\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	2.125		39	μs
			$2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	3.1875		39	μs
			$1.8\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	17		39	μs
			$1.6\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	57		95	μs
Zero-scale error Notes 1, 2	E <sub>ZS</sub>	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$1.8\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			±0.35	%FSR
			$1.6\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$ Note 5			±0.60	%FSR
Full-scale error Notes 1, 2	E <sub>FS</sub>	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$1.8\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			±0.35	%FSR
			$1.6\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$ Note 5			±0.60	%FSR
Integral linearity error Note 1	ILE	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$1.8\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			±3.5	LSB
			$1.6\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$ Note 5			±6.0	LSB
Differential linearity error Note 1	DLE	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$1.8\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			±2.0	LSB
			$1.6\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$ Note 5			±2.5	LSB
Analog input voltage	V <sub>AIN</sub>	ANI16 to ANI22	0		$AV_{REFP}$ and $EV_{DD}$	V	

**Note 1.** Excludes quantization error ( $\pm 1/2$  LSB).

**Note 2.** This value is indicated as a ratio (%FSR) to the full-scale value.

**Note 3.** When  $EV_{DD} \leq AV_{REFP} \leq V_{DD}$ , the MAX. values are as follows.

Overall error: Add  $\pm 1.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

Zero-scale error/Full-scale error: Add  $\pm 0.05\%$ FSR to the MAX. value when  $AV_{REFP} = V_{DD}$ .

Integral linearity error/ Differential linearity error: Add  $\pm 0.5$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

**Note 4.** When  $AV_{REFP} < EV_{DD} \leq V_{DD}$ , the MAX. values are as follows.

Overall error: Add  $\pm 4.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

Zero-scale error/Full-scale error: Add  $\pm 0.20\%$ FSR to the MAX. value when  $AV_{REFP} = V_{DD}$ .

Integral linearity error/ Differential linearity error: Add  $\pm 2.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

**Note 5.** When the conversion time is set to 57 μs (min.) and 95 μs (max.).

- (3) When reference voltage (+) = V<sub>DD</sub> (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = V<sub>SS</sub> (ADREFM = 0), target pin: ANI0 to ANI3, ANI16 to ANI22, internal reference voltage, and temperature sensor output voltage

(TA = -40 to +85°C, 1.6 V ≤ EV<sub>DD</sub> ≤ V<sub>DD</sub> ≤ 5.5 V, V<sub>SS</sub> = 0 V, Reference voltage (+) = V<sub>DD</sub>, Reference voltage (-) = V<sub>SS</sub>)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Resolution	RES		8		10	bit	
Overall error Note 1	AINL	10-bit resolution	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V		1.2	±7.0	LSB
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V Note 3		1.2	±10.5	LSB
Conversion time	t <sub>CONV</sub>	10-bit resolution Target pin: ANI0 to ANI3, ANI16 to ANI22	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.125		39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.1875		39	μs
			1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V	17		39	μs
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	57		95	μs
		10-bit resolution Target pin: internal reference voltage, and temperature sensor output voltage	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.375		39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.5625		39	μs
2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V	17			39	μs		
Zero-scale error Notes 1, 2	E <sub>ZS</sub>	10-bit resolution	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V Note 3			±0.85	%FSR
Full-scale error Notes 1, 2	E <sub>FS</sub>	10-bit resolution	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V Note 3			±0.85	%FSR
Integral linearity error Note 1	ILE	10-bit resolution	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V			±4.0	LSB
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V Note 3			±6.5	LSB
Differential linearity error Note 1	DLE	10-bit resolution	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V			±2.0	LSB
			1.6 V ≤ V <sub>DD</sub> ≤ 5.5 V Note 3			±2.5	LSB
Analog input voltage	V <sub>AIN</sub>	ANI0 to ANI3	0		V <sub>DD</sub>	V	
		ANI16 to ANI22	0		EV <sub>DD</sub>	V	
		Internal reference voltage (1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V)	V <sub>BGR</sub> Note 4			V	
		Temperature sensor output voltage (1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V)	V <sub>TMPS25</sub> Note 4			V	

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (% FSR) to the full-scale value.

**Note 3.** When the conversion time is set to 57 μs (min.) and 95 μs (max.).

**Note 4.** Refer to 2.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

(4) When reference voltage (+) = Internal reference voltage (ADREFP1 = 1, ADREFP0 = 0), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target pin: ANI0, ANI2 and ANI3, ANI16 to ANI22

(TA = -40 to +85°C, 1.8 V ≤ VDD ≤ 5.5 V, 1.6 V ≤ EVDD ≤ VDD, VSS = 0 V, Reference voltage (+) = VBGR Note 3, Reference voltage (-) = AVREFM = 0 V Note 4, HS (high-speed main) mode)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	RES		8			bit
Conversion time	tCONV		17		39	μs
Zero-scale error Notes 1, 2	Ezs				±0.60	% FSR
Integral linearity error Note 1	ILE				±2.0	LSB
Differential linearity error Note 1	DLE				±1.0	LSB
Analog input voltage	VAIN		0		VBGR Note 3	V

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (% FSR) to the full-scale value.

**Note 3.** Refer to **2.6.2 Temperature sensor characteristics/internal reference voltage characteristic**.

**Note 4.** When reference voltage (-) = VSS, the MAX. values are as follows.

Zero-scale error: Add ±0.35%FSR to the MAX. value when reference voltage (-) = AVREFM.

Integral linearity error: Add ±0.5 LSB to the MAX. value when reference voltage (-) = AVREFM.

Differential linearity error: Add ±0.2 LSB to the MAX. value when reference voltage (-) = AVREFM.

## 2.6.2 Temperature sensor characteristics/internal reference voltage characteristic

(TA = -40 to +85°C, 1.8 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Temperature sensor output voltage	VTMPS25	Setting ADS register = 80H, TA = +25°C		1.05		V
Internal reference voltage	VBGR	Setting ADS register = 81H	1.38	1.45	1.5	V
Temperature coefficient	FVTMPS	Temperature sensor that depends on the temperature		-3.6		mV/°C
Operation stabilization wait time	tAMP	2.4 V ≤ VDD ≤ 5.5 V	5			μs
		1.8 V ≤ VDD < 2.4 V	10			μs

## 2.6.3 D/A converter characteristics

(TA = -40 to +85°C, 1.6 V ≤ EVSS ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES					8	bit
Overall error	AINL	Rload = 4 MΩ	1.8 V ≤ VDD ≤ 5.5 V			±2.5	LSB
		Rload = 8 MΩ	1.8 V ≤ VDD ≤ 5.5 V			±2.5	LSB
Settling time	tSET	Cload = 20 pF	2.7 V ≤ VDD ≤ 5.5 V			3	μs
			1.6 V ≤ VDD < 2.7 V			6	μs

## 2.6.4 Comparator

**Comparator0: (TA = -40 to +85°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

**Comparator1: (TA = -40 to +85°C, 1.6 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Input voltage range	VIREF0	IVREF0 pin		0		V <sub>DD</sub> - 1.4 Note 1	V
	VIREF1	IVREF1 pin		1.4 Note 1		V <sub>DD</sub>	V
	VICMP	IVCMP0 pin		-0.3		V <sub>DD</sub> + 0.3	V
		IVCMP1 pin		-0.3		EV <sub>DD</sub> + 0.3	V
Output delay	td	V <sub>DD</sub> = 3.0 V Input slew rate > 50 mV/μs	Comparator high-speed mode, standard mode			1.2	μs
			Comparator high-speed mode, window mode			1.5	μs
			Comparator low-speed mode, standard mode		3		μs
			Comparator low-speed mode, window mode		4		μs
Operation stabilization wait time	tcMP			100			μs
Reference voltage declination in channel 0 of internal DAC Note 2	ΔVIDAC					± 2.5	LSB

**Note 1.** In window mode, make sure that VREF1 - VREF0 ≥ 0.2 V.

**Note 2.** Only in CMP0

## 2.6.5 PGA

(TA = -40 to +85°C, 2.7 V ≤ EVDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input offset voltage	V <sub>IOPGA</sub>				±10	mV	
Input voltage range	V <sub>IPGA</sub>		0		0.9 × V <sub>DD</sub> /Gain	V	
Output voltage range	V <sub>IOHPGA</sub>		0.93 × V <sub>DD</sub>			V	
	V <sub>IOHPGA</sub>				0.07 × V <sub>DD</sub>	V	
Gain error		x4, x8			±1	%	
		x16			±1.5	%	
		x32			±2	%	
Slew rate	SR <sub>RPGA</sub>	Rising When V <sub>IN</sub> = 0.1V <sub>DD</sub> /gain to 0.9V <sub>DD</sub> /gain. 10 to 90% of output voltage amplitude	4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (Other than x32)		3.5		V/μs
			4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (x32)		3.0		
			2.7 V ≤ V <sub>DD</sub> ≤ 4.0V		0.5		
	SR <sub>FPGA</sub>	Falling When V <sub>IN</sub> = 0.1V <sub>DD</sub> /gain to 0.9V <sub>DD</sub> /gain. 90 to 10% of output voltage amplitude	4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (Other than x32)		3.5		
			4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (x32)		3.0		
			2.7 V ≤ V <sub>DD</sub> ≤ 4.0V		0.5		
Reference voltage stabilization wait time <sup>Note</sup>	t <sub>PGA</sub>	x4, x8			5	μs	
		x16, x32			10	μs	

**Note** Time required until a state is entered where the DC and AC specifications of the PGA are satisfied after the PGA operation has been enabled (PGAEN = 1).

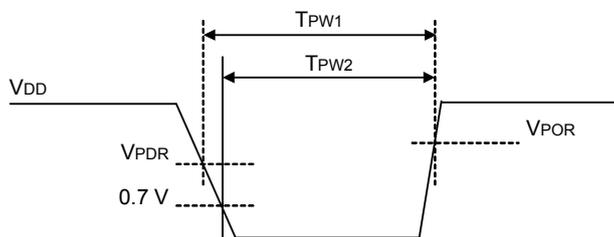
### 2.6.6 POR circuit characteristics

(TA = -40 to +85°C, Vss = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	V <sub>POR</sub>	Power supply rise time	1.47	1.51	1.55	V
	V <sub>PDR</sub>	Power supply fall time <i>Note 1</i>	1.46	1.50	1.54	V
Minimum pulse width <i>Note 2</i>	T <sub>PW1</sub>	Other than STOP/SUB HALT/SUB RUN	300			μs
	T <sub>PW2</sub>	STOP/SUB HALT/SUB RUN	300			μs

**Note 1.** However, when the operating voltage falls while the LVD is off, enter STOP mode, or enable the reset status using the external reset pin before the voltage falls below the operating voltage range shown in 2.4 AC Characteristics.

**Note 2.** Minimum time required for a POR reset when V<sub>DD</sub> exceeds below V<sub>PDR</sub>. This is also the minimum time required for a POR reset from when V<sub>DD</sub> exceeds below 0.7 V to when V<sub>DD</sub> exceeds V<sub>POR</sub> while STOP mode is entered or the main system clock is stopped through setting bit 0 (HIOSTOP) and bit 7 (MSTOP) in the clock operation status control register (CSC).



## 2.6.7 LVD circuit characteristics

### (1) LVD Detection Voltage of Reset Mode and Interrupt Mode

(TA = -40 to +85°C, VPDR ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	Supply voltage level	VLVD0	Power supply rise time	3.98	4.06	4.14	V
			Power supply fall time	3.90	3.98	4.06	V
		VLVD1	Power supply rise time	3.68	3.75	3.82	V
			Power supply fall time	3.60	3.67	3.74	V
		VLVD2	Power supply rise time	3.07	3.13	3.19	V
			Power supply fall time	3.00	3.06	3.12	V
		VLVD3	Power supply rise time	2.96	3.02	3.08	V
			Power supply fall time	2.90	2.96	3.02	V
		VLVD4	Power supply rise time	2.86	2.92	2.97	V
			Power supply fall time	2.80	2.86	2.91	V
		VLVD5	Power supply rise time	2.76	2.81	2.87	V
			Power supply fall time	2.70	2.75	2.81	V
		VLVD6	Power supply rise time	2.66	2.71	2.76	V
			Power supply fall time	2.60	2.65	2.70	V
		VLVD7	Power supply rise time	2.56	2.61	2.66	V
			Power supply fall time	2.50	2.55	2.60	V
		VLVD8	Power supply rise time	2.45	2.50	2.55	V
			Power supply fall time	2.40	2.45	2.50	V
		VLVD9	Power supply rise time	2.05	2.09	2.13	V
			Power supply fall time	2.00	2.04	2.08	V
		VLVD10	Power supply rise time	1.94	1.98	2.02	V
			Power supply fall time	1.90	1.94	1.98	V
		VLVD11	Power supply rise time	1.84	1.88	1.91	V
			Power supply fall time	1.80	1.84	1.87	V
VLVD12	Power supply rise time	1.74	1.77	1.81	V		
	Power supply fall time	1.70	1.73	1.77	V		
VLVD13	Power supply rise time	1.64	1.67	1.70	V		
	Power supply fall time	1.60	1.63	1.66	V		
Minimum pulse width		tLW		300			μs
Detection delay time						300	μs

## (2) LVD Detection Voltage of Interrupt &amp; Reset Mode

(TA = -40 to +85°C, VPDR ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Interrupt and reset mode	VLVDA0	VPOC0, VPOC1, VPOC2 = 0, 0, 0, falling reset voltage	1.60	1.63	1.66	V	
	VLVDA1	LVIS0, LVIS1 = 1, 0	Rising release reset voltage	1.74	1.77	1.81	V
			Falling interrupt voltage	1.70	1.73	1.77	V
	VLVDA2	LVIS0, LVIS1 = 0, 1	Rising release reset voltage	1.84	1.88	1.91	V
			Falling interrupt voltage	1.80	1.84	1.87	V
	VLVDA3	LVIS0, LVIS1 = 0, 0	Rising release reset voltage	2.86	2.92	2.97	V
			Falling interrupt voltage	2.80	2.86	2.91	V
	VLVDB0	VPOC0, VPOC1, VPOC2 = 0, 0, 1, falling reset voltage	1.80	1.84	1.87	V	
	VLVDB1	LVIS0, LVIS1 = 1, 0	Rising release reset voltage	1.94	1.98	2.02	V
			Falling interrupt voltage	1.90	1.94	1.98	V
	VLVDB2	LVIS0, LVIS1 = 0, 1	Rising release reset voltage	2.05	2.09	2.13	V
			Falling interrupt voltage	2.00	2.04	2.08	V
	VLVDB3	LVIS0, LVIS1 = 0, 0	Rising release reset voltage	3.07	3.13	3.19	V
			Falling interrupt voltage	3.00	3.06	3.12	V
	VLVDC0	VPOC0, VPOC1, VPOC2 = 0, 1, 0, falling reset voltage	2.40	2.45	2.50	V	
	VLVDC1	LVIS0, LVIS1 = 1, 0	Rising release reset voltage	2.56	2.61	2.66	V
			Falling interrupt voltage	2.50	2.55	2.60	V
	VLVDC2	LVIS0, LVIS1 = 0, 1	Rising release reset voltage	2.66	2.71	2.76	V
Falling interrupt voltage			2.60	2.65	2.70	V	
VLVDC3	LVIS0, LVIS1 = 0, 0	Rising release reset voltage	3.68	3.75	3.82	V	
		Falling interrupt voltage	3.60	3.67	3.74	V	
VLVDD0	VPOC0, VPOC1, VPOC2 = 0, 1, 1, falling reset voltage	2.70	2.75	2.81	V		
VLVDD1	LVIS0, LVIS1 = 1, 0	Rising release reset voltage	2.86	2.92	2.97	V	
		Falling interrupt voltage	2.80	2.86	2.91	V	
VLVDD2	LVIS0, LVIS1 = 0, 1	Rising release reset voltage	2.96	3.02	3.08	V	
		Falling interrupt voltage	2.90	2.96	3.02	V	
VLVDD3	LVIS0, LVIS1 = 0, 0	Rising release reset voltage	3.98	4.06	4.14	V	
		Falling interrupt voltage	3.90	3.98	4.06	V	

## 2.6.8 Power supply voltage rising slope characteristics

(TA = -40 to +85°C, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Power supply voltage rising slope	SVDD				54	V/ms

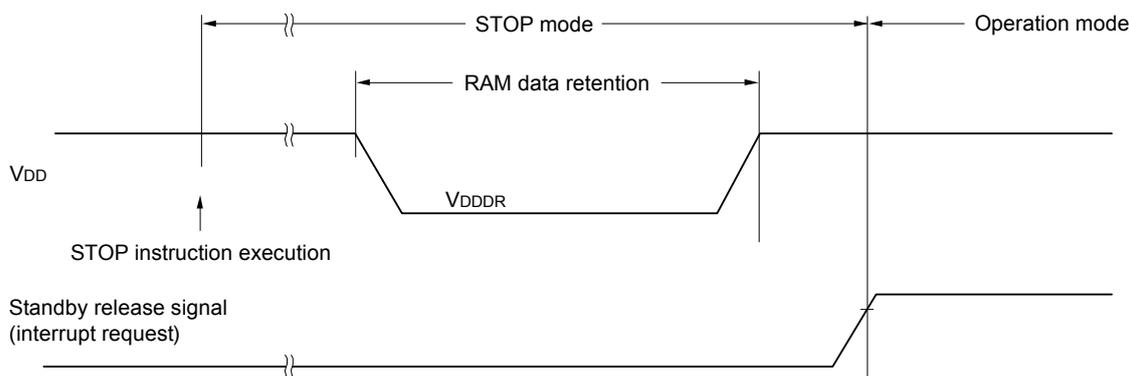
**Caution** Make sure to keep the internal reset state by the LVD circuit or an external reset until VDD reaches the operating voltage range shown in 2.4 AC Characteristics.

## 2.7 RAM Data Retention Characteristics

(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	VDDDR		1.46 Note		5.5	V

**Note** The value depends on the POR detection voltage. When the voltage drops, the RAM data is retained before a POR reset is effected, but RAM data is not retained when a POR reset is effected.



## 2.8 Flash Memory Programming Characteristics

(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
System clock frequency	fCLK			1		24	MHz
Number of code flash rewrites Notes 1, 2, 3	Cerwr	Retained for 20 years	TA = 85°C	1,000			Times
		Retained for 1 year	TA = 25°C		1,000,000		
		Retained for 5 years	TA = 85°C	100,000			
		Retained for 20 years	TA = 85°C	10,000			
Number of data flash rewrites Notes 1, 2, 3							

**Note 1.** 1 erase + 1 write after the erase is regarded as 1 rewrite. The retaining years are until next rewrite after the rewrite.

**Note 2.** When using flash memory programmer and Renesas Electronics self-programming library

**Note 3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

## 2.9 Dedicated Flash Memory Programmer Communication (UART)

(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		During serial programming	115,200		1,000,000	bps

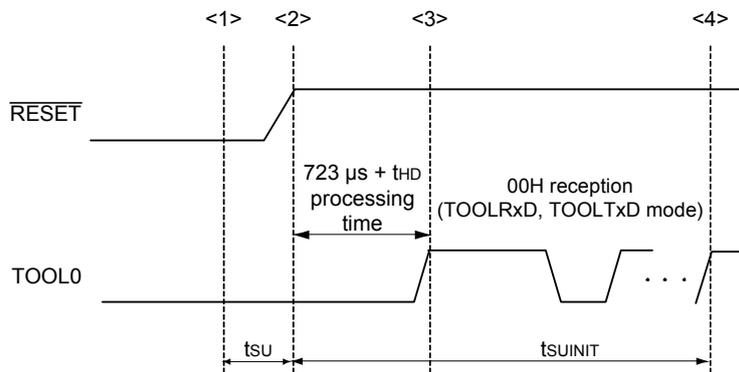
## 2.10 Timing of Entry to Flash Memory Programming Modes

(TA = -40 to +85°C, 1.8 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
How long from when an external reset ends until the initial communication settings are specified <sup>Note 1</sup>	tsUNIT	POR and LVD reset must end before the external reset ends.			100	ms
How long from when the TOOL0 pin is placed at the low level until an external reset ends <sup>Note 1</sup>	tsu	POR and LVD reset must end before the external reset ends.	10			μs
How long the TOOL0 pin must be kept at the low level after an external reset ends (excluding the processing time of the firmware to control the flash memory) <sup>Notes 1, 2</sup>	tHD	POR and LVD reset must end before the external reset ends.	1			ms

**Note 1.** Deassertion of the POR and LVD reset signals must precede deassertion of the pin reset signal.

**Note 2.** This excludes the flash firmware processing time (723 μs).



<1> The low level is input to the TOOL0 pin.

<2> The external reset ends (POR and LVD reset must end before the external reset ends).

<3> The TOOL0 pin is set to the high level.

<4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.

**Remark** tsUNIT: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the external resets end.

tsu: How long from when the TOOL0 pin is placed at the low level until a pin reset ends

tHD: How long to keep the TOOL0 pin at the low level from when the external resets end (excluding the processing time of the firmware to control the flash memory)

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### 3. ELECTRICAL SPECIFICATIONS (TA = -40 to +105°C)

This chapter describes the following electrical specifications.

Target products G: Industrial applications (TA = -40 to +105 °C)

R5F105xxGxx

**Caution 1.** The RL78 microcontrollers have an on-chip debug function, which is provided for development and evaluation. Do not use the on-chip debug function in products designated for mass production, because the guaranteed number of rewritable times of the flash memory may be exceeded when this function is used, and product reliability therefore cannot be guaranteed. Renesas Electronics is not liable for problems occurring when the on-chip debug function is used.

**Caution 2.** The pins mounted depend on the product. Refer to 2.1 Port Functions to 2.2.1 Functions for each product in the RL78/G11 User's Manual.

**Caution 3.** Please contact Renesas Electronics sales office for derating of operation under TA = +85 to +105°C. Derating is the systematic reduction of load for the sake of improved reliability.

**Caution 4.** When operating temperature exceeds 85°C, only HS (high-speed main) mode can be used as the flash operation mode. Regulator mode should be used with the normal setting (MCSEL = 0).

**Caution 5.** The EVDD pin is not present on products with 24 or less pins. Accordingly, replace EVDD with VDD and the voltage condition  $1.6 \leq EVDD \leq VDD \leq 5.5 \text{ V}$  with  $1.6 \leq VDD \leq 5.5 \text{ V}$ .

**Remark** When the products "G: Industrial applications" is used in the range of TA = -40 to +85°C, see 2. ELECTRICAL SPECIFICATIONS (TA = -40 to +85°C).

Fields of application	A: Consumer applications	G: Industrial applications
Operating ambient temperature	TA = -40 to +85 °	TA = -40 to +105 °
Operating mode Operating Voltage Range	HS (High-speed main) mode: 2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 24 MHz 2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 16 MHz LS (Low-speed main) mode: 1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 8 MHz LV (Low-voltage main) mode: 1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 4 MHz	Only in HS (High-speed main) mode: 2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 24 MHz 2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V @ 1 MHz to 16 MHz
High-speed on-chip oscillator clock to an accuracy	1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V: ±1.0% @ TA = -20 to +85 °C ±1.5% @ TA = -40 to -20 °C 1.6 V ≤ V <sub>DD</sub> < 1.8 V: ±5.0% @ TA = -20 to +85 °C ±5.5% @ TA = -40 to -20 °C	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V: ±2.0% @ TA = +85 to +105 °C ±1.0% @ TA = -20 to +85 °C ±1.5% @ TA = -40 to -20 °C
Serial array unit	UART CSI: f <sub>CLK</sub> /2 (12Mbps are supported ), f <sub>CLK</sub> /4 Simplified I <sup>2</sup> C	UART CSI: f <sub>CLK</sub> /4 Simplified I <sup>2</sup> C
IICA	Standard mode Fast mode Fast mode plus	Standard mode Fast mode
Voltage Detector	• Rising: 1.67 V to 4.06 V (14 levels) • Falling: 1.63 V to 3.98 V (14 levels)	• Rising: 2.61 V to 4.06 V (8 levels) • Falling: 2.55 V to 3.98 V (8 levels)

**Remark** The electrical characteristics for "G: Industrial applications" differ from those for "A: Consumer applications" when the product is in use in an ambient temperature over 85°C. For details, see 3.1 to 3.10 in the following pages.

### 3.1 Absolute Maximum Ratings

(1/2)

Parameter	Symbols	Conditions	Ratings	Unit
Supply voltage	V <sub>DD</sub> , EV <sub>DD</sub>	V <sub>DD</sub> ≤ EV <sub>DD</sub>	-0.5 to + 6.5	V
	AV <sub>REFP</sub>		0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	AV <sub>REFM</sub>		-0.3 to V <sub>DD</sub> + 0.3 Note 2 and AV <sub>REFM</sub> ≤ AV <sub>REFP</sub>	V
REGC pin input voltage	V <sub>I</sub> REGC	REGC	-0.3 to + 2.8 and -0.3 to V <sub>DD</sub> + 0.3 Note 1	V
Input voltage	V <sub>I1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	V <sub>I2</sub>	P20 to P23, P121, P122, P125, P137, EXCLK, $\overline{\text{RESET}}$	-0.3 to V <sub>DD</sub> + 0.3 Note 2	V
Output voltage	V <sub>O1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to V <sub>DD</sub> + 0.3 Note 2	V
	V <sub>O2</sub>	P20 to P23	-0.3 to V <sub>DD</sub> + 0.3 Note 2	V
Analog input voltage	V <sub>AI1</sub>	ANI16 to ANI22	-0.3 to EV <sub>DD</sub> + 0.3 and -0.3 to AV <sub>REF</sub> (+) + 0.3 Notes 2, 3	V
	V <sub>AI2</sub>	ANI0 to ANI3	-0.3 to V <sub>DD</sub> + 0.3 and -0.3 to AV <sub>REF</sub> (+) + 0.3 Notes 2, 3	V

**Note 1.** Connect the REGC pin to V<sub>SS</sub> via a capacitor (0.47 to 1 μF). This value regulates the absolute maximum rating of the REGC pin. Do not use this pin with voltage applied to it.

**Note 2.** Must be 6.5 V or lower.

**Note 3.** Do not exceed AV<sub>REF</sub> (+) + 0.3 V in case of A/D conversion target pin.

**Caution** Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

**Remark 1.** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

**Remark 2.** AV<sub>REF</sub> (+): + side reference voltage of the A/D converter.

**Remark 3.** V<sub>SS</sub>: Reference voltage

(2/2)

Parameter	Symbols	Conditions		Ratings	Unit
Output current, high	IOH1	Per pin	P00, P01, P30 to P33, P40, P51 to P56	-40	mA
		Total of all pins -170 mA	P00, P01, P40	-70	mA
			P30 to P33, P51 to P56	-100	mA
	IOH2	Per pin	P20 to P23	-0.5	mA
		Total of all pins		-2	mA
Output current, low	IOL1	Per pin	P00, P01, P30 to P33, P40, P51 to P56	40	mA
		Total of all pins 170 mA	P00, P01, P40	70	mA
			P30 to P33, P51 to P56	100	mA
	IOL2	Per pin	P20 to P23	1	mA
		Total of all pins		4	mA
Operating ambient temperature	TA	In normal operation mode		-40 to +105	°C
		In flash memory programming mode			
Storage temperature	Tstg			-65 to +150	°C

**Caution** Product quality may suffer if the absolute maximum rating is exceeded even momentarily for any parameter. That is, the absolute maximum ratings are rated values at which the product is on the verge of suffering physical damage, and therefore the product must be used under conditions that ensure that the absolute maximum ratings are not exceeded.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

## 3.2 Oscillator Characteristics

### 3.2.1 X1 characteristics

(TA = -40 to +105°C, 1.6 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Resonator	Resonator	Conditions	MIN.	TYP.	MAX.	Unit
X1 clock oscillation frequency (fx) <sup>Note</sup>	Ceramic resonator/ crystal resonator	2.7 V ≤ VDD ≤ 5.5 V	1.0		20.0	MHz
		2.4 V ≤ VDD < 2.7 V	1.0		16.0	
		1.8 V ≤ VDD < 2.4 V	1.0		8.0	
		1.6 V ≤ VDD < 1.8 V	1.0		4.0	

**Note** Indicates only permissible oscillator frequency ranges. Refer to **3.4 AC Characteristics** for instruction execution time. Request evaluation by the manufacturer of the oscillator circuit mounted on a board to check the oscillator characteristics.

**Caution** Since the CPU is started by the high-speed on-chip oscillator clock after a reset release, check the X1 clock oscillation stabilization time using the oscillation stabilization time counter status register (OSTC) by the user. Determine the oscillation stabilization time of the OSTC register and the oscillation stabilization time select register (OSTS) after sufficiently evaluating the oscillation stabilization time with the resonator to be used.

**Remark** When using the X1 oscillator, refer to **6.4 System Clock Oscillator** in the RL78/G11 User's Manual.

### 3.2.2 On-chip oscillator characteristics

(TA = -40 to +105°C, 1.6 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Oscillators	Parameters	Conditions	MIN.	TYP.	MAX.	Unit
High-speed on-chip oscillator clock frequency <sup>Notes 1, 2</sup>	f <sub>ih</sub>	2.7 V ≤ VDD ≤ 5.5 V	1		24	MHz
		2.4 V ≤ VDD ≤ 5.5 V	1		16	
High-speed on-chip oscillator clock frequency accuracy		TA = +85°C to +105°C	-2		2	%
		TA = -20°C to +85°C	-1		1	%
		TA = -40°C to -20°C	-1.5		1.5	%
Middle-speed on-chip oscillator oscillation frequency <sup>Note 2</sup>	f <sub>im</sub>		1		4	MHz
Middle-speed on-chip oscillator oscillation frequency accuracy			-12		+12	%
Temperature drift of Middle-speed on-chip oscillator oscillation frequency accuracy	DIMT			± 0.05		%/°C
Voltage drift of Middle-speed on-chip oscillator oscillation frequency accurac	DIMV	TA = 25°C		0.1		%/V
Low-speed on-chip oscillator clock frequency <sup>Note 2</sup>	f <sub>il</sub>			15		kHz
Low-speed on-chip oscillator clock frequency accuracy			-15		+15	%

**Note 1.** High-speed on-chip oscillator frequency is selected with bits 0 to 3 of the option byte (000C2H) and bits 0 to 2 of the HOCODIV register.

**Note 2.** This only indicates the oscillator characteristics. Refer to **3.4 AC Characteristics** for instruction execution time.

### 3.3 DC Characteristics

#### 3.3.1 Pin characteristics

(TA = -40 to +105°C, 2.4 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(1/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output current, high Note 1	IOH1	Per pin for P00, P01, P30 to P33, P40, and P51 to P56			-3.0 Note 2	mA
		Total of P00, P01, and P40 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		-30.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		-10.0	mA
			2.4 V ≤ EVDD < 2.7 V		-5.0	mA
		Total of P30 to P33, and P51 to P56 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		-30.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		-19.0	mA
			2.4 V ≤ EVDD < 2.7 V		-10.0	mA
	Total of all pins (When duty ≤ 70% Note 3)			-60.0	mA	
	IOH2	Per pin for P20 to P23			-0.1 Note 2	mA
		Total of all pins (When duty ≤ 70% Note 3)	2.4 V ≤ VDD ≤ 5.5 V		-0.4	mA

**Note 1.** Value of current at which the device operation is guaranteed even if the current flows from the VDD pin to an output pin.

**Note 2.** Do not exceed the total current value.

**Note 3.** Specification under conditions where the duty factor ≤ 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins =  $(I_{OH} \times 0.7)/(n \times 0.01)$

<Example> Where n = 80% and IOH = -10.0 mA

$$\text{Total output current of pins} = (-10.0 \times 0.7)/(80 \times 0.01) \approx -8.7 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

**Caution** P00, P01, P20, P30 to P33, P40 and P51 to P56 do not output high level in N-ch open-drain mode.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Output current, low Note 1	IOL1	Per pin for P00, P01, P30 to P33, P40, and P51 to P56			8.5 Note 2	mA
		Total of P00, P01, and P40 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		40.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		15.0	mA
			2.4 V ≤ EVDD < 2.7 V		9.0	mA
		Total of P30 to P33, and P51 to P56 (When duty ≤ 70% Note 3)	4.0 V ≤ EVDD ≤ 5.5 V		40.0	mA
			2.7 V ≤ EVDD ≤ 4.0 V		35.0	mA
			2.4 V ≤ EVDD < 2.7 V		20.0	mA
	Total of all pins (When duty ≤ 70% Note 3)			80.0	mA	
	IOL2	Per pin for P20 to P23			0.4 Note 2	mA
		Total of all pins (When duty ≤ 70% Note 3)	2.4 V ≤ VDD ≤ 5.5 V		1.6	mA

**Note 1.** Value of current at which the device operation is guaranteed even if the current flows from an output pin to the VSS pin.

**Note 2.** Do not exceed the total current value.

**Note 3.** Specification under conditions where the duty factor ≤ 70%.

The output current value that has changed to the duty factor > 70% the duty ratio can be calculated with the following expression (when changing the duty factor from 70% to n%).

- Total output current of pins =  $(IOL \times 0.7)/(n \times 0.01)$

- 

<Example> Where n = 80% and IOL = 10.0 mA

$$\text{Total output current of pins} = (10.0 \times 0.7)/(80 \times 0.01) \approx 8.7 \text{ mA}$$

However, the current that is allowed to flow into one pin does not vary depending on the duty factor.

A current higher than the absolute maximum rating must not flow into one pin.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(3/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Input voltage, high	V <sub>IH1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	Normal mode	0.8 EV <sub>DD</sub>		EV <sub>DD</sub>	V
	V <sub>IH2</sub>	P00, P30 to P32, P40, P51 to P56	TTL mode 4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V	2.2		EV <sub>DD</sub>	V
			TTL mode 3.3 V ≤ EV <sub>DD</sub> < 4.0 V	2.0		EV <sub>DD</sub>	V
			TTL mode 1.6 V ≤ EV <sub>DD</sub> < 3.3 V	1.5		EV <sub>DD</sub>	V
	V <sub>IH3</sub>	P20 to P23 (digital input)		0.7 V <sub>DD</sub>		V <sub>DD</sub>	V
	V <sub>IH4</sub>	P20 (SDAA0 input), P121, P122, P125, P137, EXCLK, RESET		0.8 V <sub>DD</sub>		V <sub>DD</sub>	V
Input voltage, low	V <sub>IL1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	Normal mode	0		0.2 EV <sub>DD</sub>	V
	V <sub>IL2</sub>	P00, P30 to P32, P40, P51 to P56	TTL mode 4.0 V ≤ EV <sub>DD</sub> ≤ 5.5 V	0		0.8	V
			TTL mode 3.3 V ≤ EV <sub>DD</sub> < 4.0 V	0		0.5	V
			TTL mode 1.6 V ≤ EV <sub>DD</sub> < 3.3 V	0		0.32	V
	V <sub>IL3</sub>	P20 to P23 (digital input)		0		0.3 V <sub>DD</sub>	V
	V <sub>IL4</sub>	P20 (SDAA0 input), P121, P122, P125, P137, EXCLK, RESET		0		0.2 V <sub>DD</sub>	V

**Caution** The maximum value of V<sub>IH</sub> of pins P00, P01, P20, P30 to P33, P40 and P51 to P56 is V<sub>DD</sub> or EV<sub>DD</sub>, even in the N-ch open-drain mode.

(P20: V<sub>DD</sub>)

(P00, P01, P30-P33, P40, P51-P56: EV<sub>DD</sub>)

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +105°C, 2.4 V ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

(4/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Output voltage, high	VOH1	P00, P01, P30 to P33, P40, and P51 to P56	4.0 V ≤ EVDD ≤ 5.5 V, IOH = -3.0 mA		EVDD - 0.7		V
			2.7 V ≤ EVDD ≤ 5.5 V, IOH = -2.0 mA		EVDD - 0.6		V
			2.4 V ≤ EVDD ≤ 5.5 V IOH = -1.5 mA		EVDD - 0.5		V
	VOH2	P20 to P23	2.4 V ≤ VDD ≤ 5.5 V, IOH = -100 μA		VDD - 0.5		V
Output voltage, low	VOL1	P00, P01, P30 to P33, P40, and P51 to P56	4.0 V ≤ EVDD ≤ 5.5 V, IOL = 8.5 mA			0.7	V
			2.7 V ≤ EVDD ≤ 5.5 V, IOL = 3.0 mA			0.6	V
			2.7 V ≤ EVDD ≤ 5.5 V, IOL = 1.5 mA			0.4	V
			2.4 V ≤ EVDD ≤ 5.5 V, IOL = 0.6 mA			0.4	V
	VOL2	P20 to P23	2.4 V ≤ VDD ≤ 5.5 V, IOL = 400 μA			0.4	V

**Caution** P00, P01, P20, P30 to P33, P40 and P51 to P56 do not output high level in N-ch open-drain mode.

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(5/5)

Items	Symbol	Conditions	MIN.	TYP.	MAX.	Unit		
Input leakage current, high	ILI <sub>H1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	V <sub>I</sub> = EVDD		1	μA		
	ILI <sub>H2</sub>	P20 to P23, P125, P137, $\overline{\text{RESET}}$	V <sub>I</sub> = VDD		1	μA		
	ILI <sub>H3</sub>	P121, P122, X1, X2, EXCLK	V <sub>I</sub> = VDD	In input port or external clock input		1	μA	
				In resonator connection		10	μA	
Input leakage current, low	ILI <sub>L1</sub>	P00, P01, P30 to P33, P40, and P51 to P56	V <sub>I</sub> = VSS		-1	μA		
	ILI <sub>L2</sub>	P20 to P23, P125, P137, $\overline{\text{RESET}}$	V <sub>I</sub> = VSS		-1	μA		
	ILI <sub>L3</sub>	P121, P122, X1, X2, EXCLK	V <sub>I</sub> = VSS	In input port or external clock input		-1	μA	
				In resonator connection		-10	μA	
On-chip pull-up resistance	R <sub>u</sub>	P00, P01, P30 to P33, P40, P51 to P56, P125	V <sub>I</sub> = VSS, In input port		10	20	100	kΩ

**Remark** Unless specified otherwise, the characteristics of alternate-function pins are the same as those of the port pins.

### 3.3.2 Supply current characteristics

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(1/3)

Parameter	Symbol	Conditions				MIN.	TYP.	MAX.	Unit		
Supply current Note 1	IDD1	Operating mode	Basic operation	HS (high-speed main) mode	fHOCO = 48 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		1.7		mA	
						VDD = 3.0 V		1.7			
					fHOCO = 24 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		1.4			
						VDD = 3.0 V		1.4			
			Normal operation	HS (high-speed main) mode	fHOCO = 48 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		3.5	7.3		mA
						VDD = 3.0 V		3.5	7.3		
					fHOCO = 24 MHz <sup>Note 3</sup> fIH = 24 MHz <sup>Note 3</sup>	VDD = 5.0 V		3.2	6.7		
						VDD = 3.0 V		3.2	6.7		
		Normal operation	HS (high-speed main) mode	fMX = 20 MHz <sup>Note 2</sup>	VDD = 5.0 V	Square wave input		2.7	5.7	mA	
						Resonator connection		2.8	5.8		
					VDD = 3.0 V	Square wave input		2.7	5.7		
						Resonator connection		2.8	5.8		
				fMX = 10 MHz <sup>Note 2</sup>	VDD = 5.0 V	Square wave input		1.8	3.4		
						Resonator connection		1.9	3.5		
					VDD = 3.0 V	Square wave input		1.8	3.4		
						Resonator connection		1.9	3.5		
Normal operation	Subsystem clock operation	fIL = 15 kHz, TA = -40°C <sup>Note 4</sup>			1.8	5.9	μA				
			fIL = 15 kHz, TA = +25°C <sup>Note 4</sup>		1.9	5.9					
			fIL = 15 kHz, TA = +85°C <sup>Note 4</sup>		2.3	8.7					
			fIL = 15 kHz, TA = +105°C <sup>Note 4</sup>		3.0	20.9					

**Note 1.** Total current flowing into VDD and EVDD, including the input leakage current flowing when the level of the input pin is fixed to VDD or VSS. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.

**Note 2.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Note 3.** When the high-speed system clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Note 4.** When the high-speed system clock, high-speed on-chip oscillator clock and middle-speed on-chip oscillator clock are stopped.

**Remark 1.** fMX: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)

**Remark 2.** fIH: High-speed on-chip oscillator clock frequency (24 MHz max.)

**Remark 3.** fIM: Middle-speed on-chip oscillator clock frequency (4 MHz max.)

**Remark 4.** fIL: Low-speed on-chip oscillator clock frequency

**Remark 5.** fSUB: Subsystem clock frequency (Low-speed on-chip oscillator clock frequency)

**Remark 6.** Except subsystem clock operation, temperature condition of the TYP. value is TA = 25°C

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/3)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit			
Supply current Note 1	I <sub>DD2</sub> Note 2	HALT mode	HS (high-speed main) mode	f <sub>IH</sub> = 24 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.59	3.45	mA	
					V <sub>DD</sub> = 3.0 V		0.59	3.45		
				f <sub>IH</sub> = 16 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.41	2.85		
					V <sub>DD</sub> = 3.0 V		0.41	2.85		
				f <sub>IH</sub> = 16 MHz Note 4	V <sub>DD</sub> = 5.0 V		0.39	2.08		
					V <sub>DD</sub> = 3.0 V		0.39	2.08		
			HS (high-speed main) mode	f <sub>MX</sub> = 20 MHz Note 3	V <sub>DD</sub> = 5.0 V	Square wave input		0.20	2.45	mA
						Resonator connection		0.40	2.57	
					V <sub>DD</sub> = 3.0 V	Square wave input		0.20	2.45	
				Resonator connection			0.40	2.57		
				f <sub>MX</sub> = 10 MHz Note 3	V <sub>DD</sub> = 5.0 V	Square wave input		0.15	1.28	
						Resonator connection		0.30	1.36	
			V <sub>DD</sub> = 3.0 V		Square wave input		0.15	1.28		
				Resonator connection		0.30	1.36			
Subsystem clock operation				f <sub>IL</sub> = 15 kHz, T <sub>A</sub> = -40°C Note 5		0.48	1.22	μA		
				f <sub>IL</sub> = 15 kHz, T <sub>A</sub> = +25°C Note 5		0.55	1.22			
				f <sub>IL</sub> = 15 kHz, T <sub>A</sub> = +85°C Note 5		0.80	3.30			
				f <sub>IL</sub> = 15 kHz, T <sub>A</sub> = +105°C Note 5		2.00	17.3			

**Note 1.** Total current flowing into V<sub>DD</sub> and EV<sub>DD</sub>, including the input leakage current flowing when the level of the input pin is fixed to V<sub>DD</sub> or V<sub>SS</sub>. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.

**Note 2.** When the HALT instruction is executed in the flash memory.

**Note 3.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, and low-speed on-chip oscillator clock are stopped.

**Note 4.** When the high-speed system clock, middle-speed on-chip oscillator clock and low-speed on-chip oscillator clock are stopped.

**Note 5.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock and high-speed system clock are stopped.

**Remark 1.** f<sub>MX</sub>: High-speed system clock frequency (X1 clock oscillation frequency or external main system clock frequency)

**Remark 2.** f<sub>IH</sub>: High-speed on-chip oscillator clock frequency (24 MHz max.)

**Remark 3.** f<sub>IM</sub>: Middle-speed on-chip oscillator clock frequency (4 MHz max.)

**Remark 4.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency

**Remark 5.** f<sub>SUB</sub>: Subsystem clock frequency (Low-speed on-chip oscillator clock frequency)

**Remark 6.** Except subsystem clock operation, temperature condition of the TYP. value is T<sub>A</sub> = 25°C

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(3/3)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Supply current Note 1	IDD3 Note 2	STOP mode Note 3	TA = -40°C		0.19	0.51	μA
			TA = +25°C		0.25	0.51	
			TA = +50°C		0.28	1.10	
			TA = +70°C		0.38	1.90	
			TA = +85°C		0.60	3.30	
			TA = +105°C		1.5	17.0	

**Note 1.** Total current flowing into VDD and EVDD, including the input leakage current flowing when the level of the input pin is fixed to VDD or VSS. The MAX values include the peripheral operating current. However, these values do not include the current flowing into the A/D converter, comparator, Programmable gain amplifier, LVD circuit, I/O ports, and on-chip pull-up/pull-down resistors, and the current flowing during data flash rewrite.

**Note 2.** The values do not include the current flowing into the 12-bit interval timer and watchdog timer.

**Note 3.** For the setting of the current values when operating the subsystem clock in STOP mode, see the current values when operating the subsystem clock in HALT mode.

## Peripheral Functions (Common to all products)

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Low-speed on-chip oscillator operating current	IFIL Note 1				0.20		μA
12-bit interval timer operating current	ITMKA Notes 1, 3, 4	fIL = 15 kHz fMAIN stopped (per unit)			0.02		μA
8-bit interval timer operating current Notes 1, 9	ITMT	fIL = 15 kHz fMAIN stopped (per unit)	8-bit counter mode × 2-channel operation		0.04		μA
			16-bit counter mode operation		0.03		μA
Watchdog timer operating current	IWD <sub>T</sub> Notes 1, 3, 5	fIL = 15 kHz fMAIN stopped (per unit)			0.22		μA
A/D converter operating current	IADC Notes 1, 6	During maximum-speed conversion	Normal mode, AVREFP = VDD = 5.0 V		1.3	1.7	mA
			Low voltage mode, AVREFP = VDD = 3.0 V		0.5	0.7	mA
Internal reference voltage (1.45 V) current Notes 1, 10	IADREF				85.0		μA
Temperature sensor operating current	ITMPS Note 1				85.0		μA
D/A converter operating current	IDAC Note 1	Per channel				1.5	mA
PGA operating current	IPGA Notes 1, 2				480	700	μA
Comparator operating current	ICMP Note 8	VDD = 5.0 V, Regulator output voltage = 2.1 V	Comparator high-speed mode Window mode		12.5		μA
			Comparator low-speed mode Window mode		3.0		
			Comparator high-speed mode Standard mode		6.5		
			Comparator low-speed mode Standard mode		1.9		
		VDD = 5.0 V, Regulator output voltage = 1.8 V	Comparator high-speed mode Window mode		8.0		
			Comparator low-speed mode Window mode		2.2		
			Comparator high-speed mode Standard mode		4.0		
			Comparator low-speed mode Standard mode		1.3		
LVD operating current	ILVD Notes 1, 7				0.10		μA
Self-programming operating current	IFSP Notes 1, 12				2.0	12.20	mA
BGO current	IBGO Notes 1, 11				2.0	12.20	mA
SNOOZE operating current	ISNOZ Note 1	ADC operation fIH = 24 MHz, AVREFP = VDD = 3.0 V	Mode transition Note 13		0.50	1.10	mA
			The A/D conversion operations are performed		1.20	1.54	mA
		CSI/UART operation fIH = 24 MHz		0.70	1.54	mA	
	ISNOZM Note 1	ADC operation fIM = 4 MHz, AVREFP = VDD = 3.0 V	Mode transition Note 13		0.05	0.13	mA
			The A/D conversion operations are performed		0.67	0.84	mA
		CSI operation, fIM = 4 MHz		0.06	0.15	mA	

(Notes and Remarks are listed on the next page.)

- Note 1.** Current flowing to VDD.
- Note 2.** Operable range is 2.7 to 5.5 V.
- Note 3.** When the high-speed on-chip oscillator clock, middle-speed on-chip oscillator clock, and high-speed system clock are stopped.
- Note 4.** Current flowing only to the 12-bit interval timer (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IIT, when the 12-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added.
- Note 5.** Current flowing only to the watchdog timer (including the operating current of the low-speed on-chip oscillator). The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and IWDT when the watchdog timer is in operation.
- Note 6.** Current flowing only to the A/D converter. The supply current of the RL78 microcontrollers is the sum of IDD1 or IDD2 and IADC when the A/D converter operates in an operation mode or the HALT mode.
- Note 7.** Current flowing only to the LVD circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2 or IDD3 and ILVD when the LVD circuit is in operation.
- Note 8.** Current flowing only to the comparator circuit. The supply current of the RL78 microcontrollers is the sum of IDD1, IDD2, or IDD3 and ICMP when the comparator circuit is in operation.
- Note 9.** Current flowing only to the 8-bit interval timer (excluding the operating current of the low-speed on-chip oscillator and the XT1 oscillator). The supply current of the RL78 microcontrollers is the sum of the values of either IDD1 or IDD2, and IIT, when the 8-bit interval timer operates in operation mode or HALT mode. When the low-speed on-chip oscillator is selected, IFIL should be added.
- Note 10.** Current consumed by generating the internal reference voltage (1.45 V).
- Note 11.** Current flowing during programming of the data flash.
- Note 12.** Current flowing during self-programming.
- Note 13.** For transition time to the SNOOZE mode, see **24.3.3 SNOOZE mode** in the RL78/G11 User's Manual.

**Remark 1.** f<sub>IL</sub>: Low-speed on-chip oscillator clock frequency

**Remark 2.** f<sub>CLK</sub>: CPU/peripheral hardware clock frequency

**Remark 3.** Temperature condition of the TYP. value is TA = 25°C

### 3.4 AC Characteristics

(TA = -40 to +105°C, 2.4V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

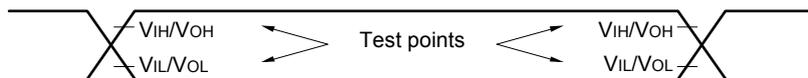
Items	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Instruction cycle (minimum instruction execution time)	TCY	Main system clock (fMAIN) operation	HS (high-speed main) mode	2.7 V ≤ VDD ≤ 5.5 V	0.04167	1	μs
				2.4 V ≤ VDD < 2.7 V	0.0625	1	μs
		Subsystem clock (fSUB) operation	fiL	2.4 V ≤ VDD ≤ 5.5 V		66.7	μs
		In the self- programming mode	HS (high-speed main) mode	2.7 V ≤ VDD ≤ 5.5 V	0.04167	1	μs
2.4 V ≤ VDD < 2.7 V	0.0625			1	μs		
External system clock frequency	fEX	2.7 V ≤ VDD ≤ 5.5 V		1		20	MHz
		2.4 V ≤ VDD < 2.7 V		1		16	MHz
External system clock input high-/low- level width	tEXH,	2.7 V ≤ VDD ≤ 5.5 V		24			ns
	tEXL	2.4 V ≤ VDD < 2.7 V		30			ns
Ti00 to Ti03 input high-/low-level width	tTIH, tTIL <sup>Note 1</sup>			1/fMCK + 10			ns
TO00 to TO03, TKBO0, and TKBO1 output frequency <sup>Note 2</sup>	fTO	HS (high-speed main) mode		4.0 V ≤ EVDD ≤ 5.5 V		12	MHz
				2.7 V ≤ EVDD < 4.0 V		8	
				2.4 V ≤ EVDD < 2.7 V		4	
PCLBUZ0, PCLBUZ1 output frequency	fPCL	HS (high-speed main) mode		4.0 V ≤ EVDD ≤ 5.5 V		16	MHz
				2.7 V ≤ EVDD < 4.0 V		8	
				2.4 V ≤ EVDD < 2.7 V		4	
Interrupt input high- /low-level width	tINTH, tINTL	INTP0 to INTP11		2.4 V ≤ EVDD, VDD ≤ 5.5 V	1		μs
Key interrupt input low-level width	tKR	KR0 to KR7		2.4 V ≤ EVDD ≤ 5.5 V	250		ns
RESET low-level width	tRSL				10		μs

**Note 1.** Following conditions must be satisfied on low level interface of EVDD < VDD.  
2.4 V ≤ EVDD ≤ 2.7 V: MIN.125 ns

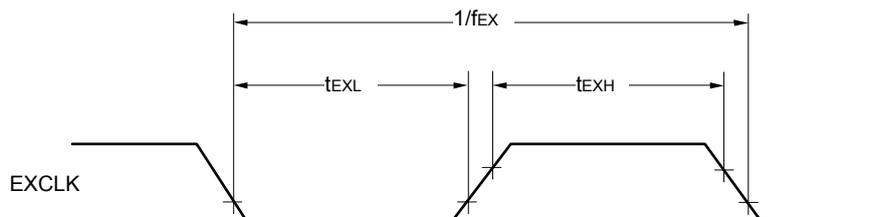
**Note 2.** When duty is 50 %.

**Remark** fMCK: Timer array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of timer mode register mn (TMRmn). m: Unit number (m = 0), n: Channel number (n = 0 to 3))

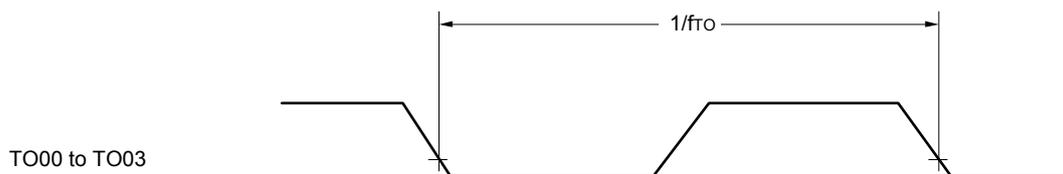
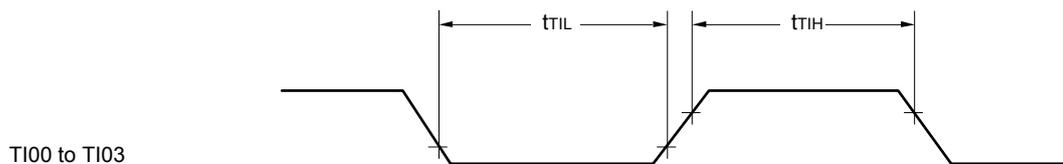
AC Timing Test Points



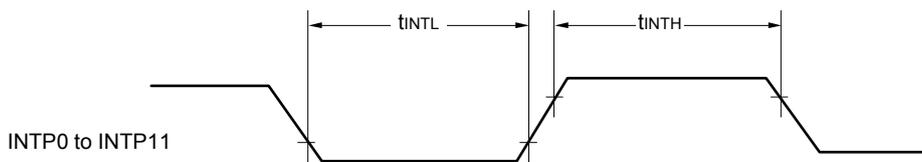
External System Clock Timing



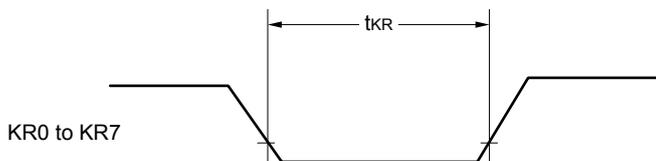
TI/TO Timing



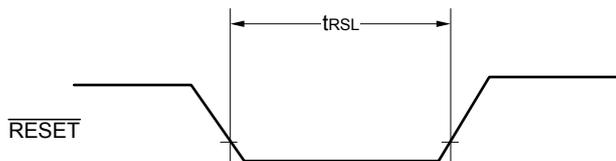
Interrupt Request Input Timing



Key Interrupt Input Timing

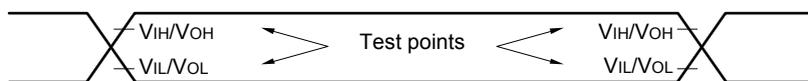


$\overline{\text{RESET}}$  Input Timing



### 3.5 Peripheral Functions Characteristics

AC Timing Test Points



### 3.5.1 Serial array unit

(1) during communication at same potential (UART mode)

When P01, P30, P31 and P54 are used as TxDq pins

((TA = -40 to +105°C, 2.4V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
Transfer rate		Theoretical value of the maximum transfer rate fMCK = fCLK = 24MHz		fMCK/12 <sup>Notes 1, 2</sup>	bps
				2.0	Mbps

**Note 1.** Transfer rate in the SNOOZE mode is 4800 bps only.

**Note 2.** The maximum operating frequencies of the CPU/peripheral hardware clock (fCLK) are:

HS (high-speed main) mode:

2.4 V ≤ EVDD ≤ 2.7 V: MAX. 1.3 Mbps

**Caution** Select the normal input buffer for the RxDq pin and the normal output mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg).

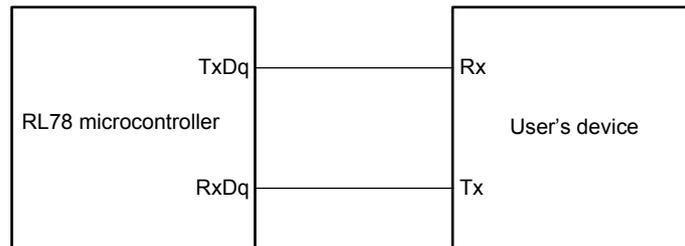
When P20 is used as TxD1 pin

((TA = -40 to +105°C, 2.4V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

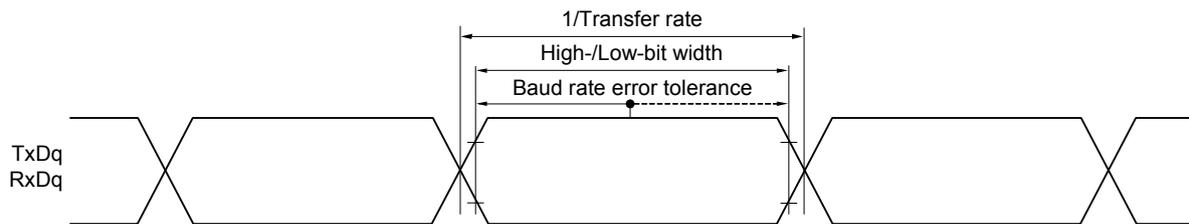
Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
Transfer rate		4.0 V ≤ VDD ≤ 5.5 V		fMCK/16 <sup>Note</sup>	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK = 24MHz		1.5
		2.7 V ≤ VDD ≤ 5.5 V		fMCK/20 <sup>Note</sup>	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK = 24MHz		1.2
		2.4 V ≤ VDD ≤ 5.5 V		fMCK/16 <sup>Note</sup>	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK = 16MHz		1.0

**Note** Transfer rate in the SNOOZE mode is 4800 bps only.

**UART mode connection diagram (during communication at same potential)**



**UART mode bit width (during communication at same potential) (reference)**



**Remark 1.** q: UART number (q = 0 and 1), g: PIM and POM number (g = 0, 2, 3 and 5)

**Remark 2.** f<sub>MCK</sub>: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

## (2) During communication at same potential (CSI mode) (master mode, SCKp... internal clock output)

When P01, P32, P53, P54 and P56 are used as SOMn pins

(TA = -40 to +105°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCKp cycle time	t <sub>KCY1</sub>	t <sub>KCY1</sub> ≥ 4/f <sub>CLK</sub>	2.7 V ≤ EVDD ≤ 5.5 V	250	ns
			2.4 V ≤ EVDD ≤ 5.5 V	500	ns
SCKp high-/low-level width	t <sub>KH1</sub> , t <sub>KL1</sub>	4.0 V ≤ EVDD ≤ 5.5 V	t <sub>KCY1</sub> /2 - 24	ns	
		2.7 V ≤ EVDD ≤ 5.5 V	t <sub>KCY1</sub> /2 - 36	ns	
		2.4 V ≤ EVDD ≤ 5.5 V	t <sub>KCY1</sub> /2 - 76	ns	
Slp setup time (to SCKp↑) Note 1	t <sub>SIK1</sub>	4.0 V ≤ EVDD ≤ 5.5 V	66	ns	
		2.7 V ≤ EVDD ≤ 5.5 V		ns	
		2.4 V ≤ EVDD ≤ 5.5 V	133	ns	
Slp hold time (from SCKp↑) Note 2	t <sub>KSI1</sub>		38	ns	
Delay time from SCKp↓ to SOp output Note 3	t <sub>KSO1</sub>	C = 30 pF Note 4		50	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SCKp and SOp output lines.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** f<sub>MCK</sub>: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**When P20 is used as SO10 pin****TA = -40 to +105°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit	
			MIN.	MAX.		
SCKp cycle time	tkCY1	tkCY1 ≥ 4/fCLK	2.7 V ≤ VDD ≤ 5.5 V	1000		ns
			2.4 V ≤ VDD ≤ 5.5 V	1200		ns
SCKp high-/low-level width	tkH1, tkL1	4.0 V ≤ VDD ≤ 5.5 V	tkCY1/2 - 24		ns	
		2.4 V ≤ VDD ≤ 5.5 V	tkCY1/2 - 76		ns	
Slp setup time (to SCKp↑) Note 1	tsIK1	2.7 V ≤ VDD ≤ 5.5 V	66		ns	
		2.4 V ≤ VDD ≤ 5.5 V	133		ns	
Slp hold time (from SCKp↑) Note 2	tkSI1		38		ns	
Delay time from SCKp↓ to SOp output Note 3	tkSO1	C = 30 pF Note 4		180	ns	

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp setup time becomes “to SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 4.** C is the load capacitance of the SCKp and SOp output lines.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**(3) During communication at same potential (CSI mode) (slave mode, SCKp... external clock input)****When P01, P32, P53, P54 and P56 are used as SOMn pins****TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCKp cycle time Note 4	tkCY2	4.0 V ≤ EVDD < 5.5 V	fMCK > 20 MHz	16/fMCK	ns
			fMCK ≤ 20 MHz	12/fMCK	ns
		2.7 V ≤ EVDD < 4.0 V	fMCK > 16 MHz	16/fMCK	ns
			fMCK ≤ 16 MHz	12/fMCK	ns
		2.4 V ≤ EVDD < 2.7 V	12/fMCK and 1000	ns	
SCKp high-/low-level width	tkH2, tkL2	4.0 V ≤ EVDD ≤ 5.5 V	tkCY2/2 - 14	ns	
		2.7 V ≤ EVDD < 4.0 V	tkCY2/2 - 16	ns	
		2.4 V ≤ EVDD < 2.7 V	tkCY2/2 - 36	ns	
Slp setup time (to SCKp↑) Note 1	tsIK2	2.7 V ≤ EVDD ≤ 5.5 V	1/fMCK + 40	ns	
		2.4 V ≤ EVDD < 2.7 V	1/fMCK + 60	ns	
Slp hold time (from SCKp↑) Note 1	tkSI2		1/fMCK + 62	ns	
Delay time from SCKp↓ to SOp output Note 2	tkSO2	C = 30 pF Note 3	2.7 V ≤ EVDD ≤ 5.5 V	2/fMCK + 66	ns
			2.4 V ≤ EVDD < 2.7 V	2/fMCK + 113	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** C is the load capacitance of the SOp output lines.

**Note 4.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit	
			MIN.	MAX.		
SSI00 setup time	tssik	DAPmn = 0	2.7 V ≤ VDD ≤ 3.6 V	240		ns
			2.4 V ≤ VDD < 2.7 V	400		ns
		DAPmn = 1	2.7 V ≤ VDD ≤ 3.6 V	1/fMCK + 240		ns
			2.4 V ≤ VDD < 2.7 V	1/fMCK + 400		ns
SSI00 hold time	tkssi	DAPmn = 0	2.7 V ≤ VDD ≤ 3.6 V	1/fMCK + 240		ns
			2.4 V ≤ VDD < 2.7 V	1/fMCK + 400		ns
		DAPmn = 1	2.7 V ≤ VDD ≤ 3.6 V	240		ns
			2.4 V ≤ VDD < 2.7 V	400		ns

**Caution** Select the normal input buffer for the SIp pin and SCKp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

**Remark** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5, 12)

**When P20 is used as SO10 pin****TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCKp cycle time <sup>Note 4</sup>	tkCY2	4.0 V ≤ VDD < 5.5 V	fMCK > 20 MHz	20/fMCK	ns
			fMCK ≤ 20 MHz	18/fMCK	ns
		2.7 V ≤ VDD < 4.0 V	fMCK > 16 MHz	20/fMCK and 1000	ns
			fMCK ≤ 16 MHz	18/fMCK	ns
		2.4 V ≤ VDD < 2.7 V	18/fMCK and 1200	ns	
SCKp high-/low-level width	tkH2, tkL2	4.0 V ≤ VDD ≤ 5.5 V	tkCY2/2 - 14	ns	
		2.7 V ≤ VDD ≤ 4.0 V	tkCY2/2 - 16	ns	
		2.4 V ≤ VDD < 2.7 V	tkCY2/2 - 36	ns	
Slp setup time (to SCKp↑) <sup>Note 1</sup>	tsIK2	2.7 V ≤ VDD ≤ 5.5 V	1/fMCK + 40	ns	
		2.4 V ≤ VDD < 2.7 V	1/fMCK + 60	ns	
Slp hold time (from SCKp↓) <sup>Note 1</sup>	tkSI2		1/fMCK + 62	ns	
Delay time from SCKp↓ to SOp output <sup>Note 2</sup>	tkSO2	C = 30 pF <sup>Note 3</sup>	2.7 V ≤ VDD ≤ 5.5 V	2/fMCK + 190	ns
			2.4 V ≤ VDD < 2.7 V	2/fMCK + 250	ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The Slp hold time becomes “from SCKp↓” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 2.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1. The delay time to SOp output becomes “from SCKp↑” when DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** C is the load capacitance of the SOp output lines.

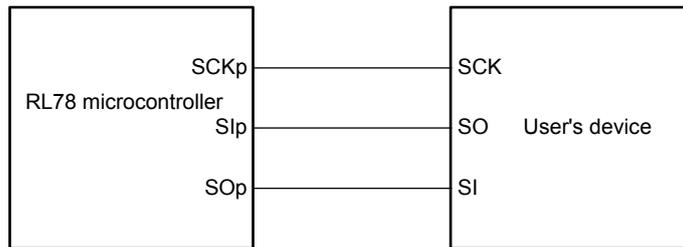
**Note 4.** The maximum transfer rate when using the SNOOZE mode is 1 Mbps.

**Caution** Select the normal input buffer for the Slp pin and the normal output mode for the SOp pin by using port input mode register g (PIMg) and port output mode register g (POMg).

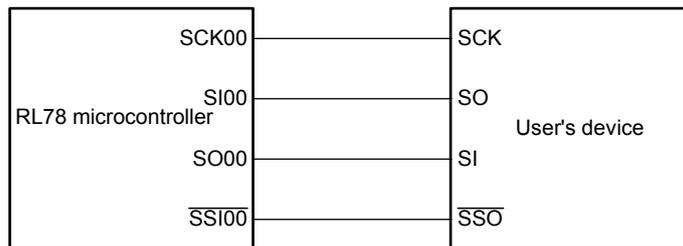
**Remark 1.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

**Remark 2.** fMCK: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**CSI mode connection diagram (during communication at same potential)**

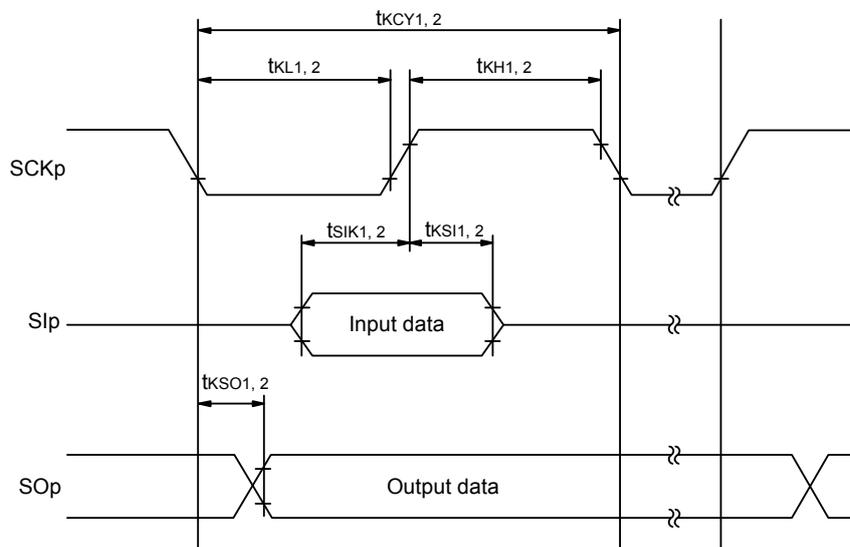


**CSI mode connection diagram (during communication at same potential)  
(Slave Transmission of slave select input function (CSI00))**

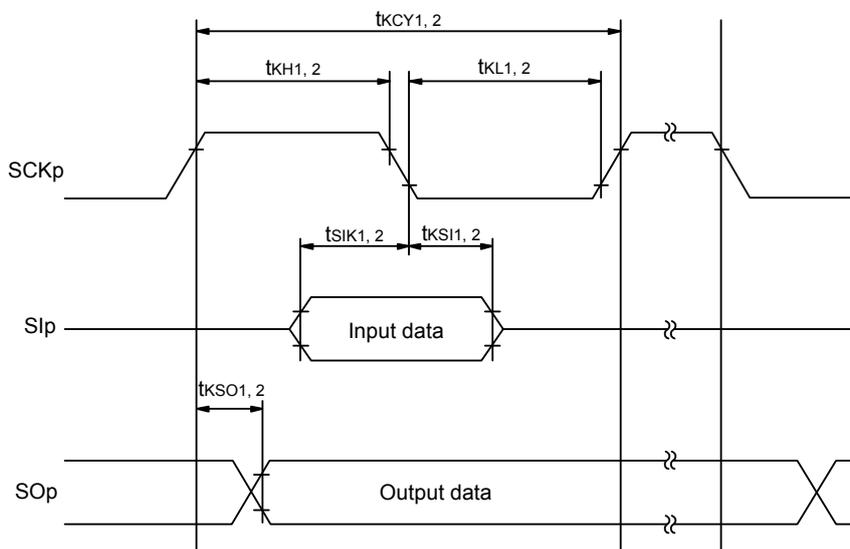


**Remark** p: CSI number (p = 00, 01, 10 and 11)

**CSI mode serial transfer timing (during communication at same potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (during communication at same potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark 1.** p: CSI number (p = 00, 01, 10 and 11)

**Remark 2.** m: Unit number, n: Channel number (mn = 00 to 03)

(4) During communication at same potential (simplified I<sup>2</sup>C mode)TA = -40 to +105°C, 2.4 V ≤ EV<sub>DD</sub> ≤ V<sub>DD</sub> ≤ 5.5 V, V<sub>SS</sub> = 0 V)

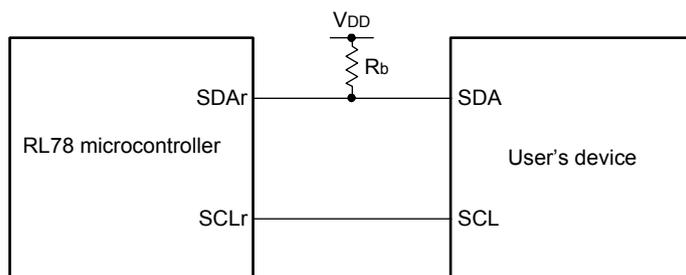
Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCLr clock frequency	f <sub>SCL</sub>	2.7 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ		400 Note 1	kHz
		2.4 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 3 kΩ		100 Note 1	
Hold time when SCLr = "L"	t <sub>LOW</sub>	2.7 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1200		ns
		2.4 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 3 kΩ	4600		
Hold time when SCLr = "H"	t <sub>HIGH</sub>	2.7 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1200		ns
		2.4 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 3 kΩ	4600		
Data setup time (reception)	t <sub>SU: DAT</sub>	2.7 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	1/f <sub>MCK</sub> + 220 Note 2		ns
		2.4 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 3 kΩ	1/f <sub>MCK</sub> + 580 Note 2		
Data hold time (transmission)	t <sub>HD: DAT</sub>	2.7 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 50 pF, R <sub>b</sub> = 2.7 kΩ	0	770	ns
		2.4 V ≤ EV <sub>DD</sub> ≤ 5.5 V, C <sub>b</sub> = 100 pF, R <sub>b</sub> = 3 kΩ	0	1420	

**Note 1.** The value must also be equal to or less than f<sub>MCK</sub>/4.

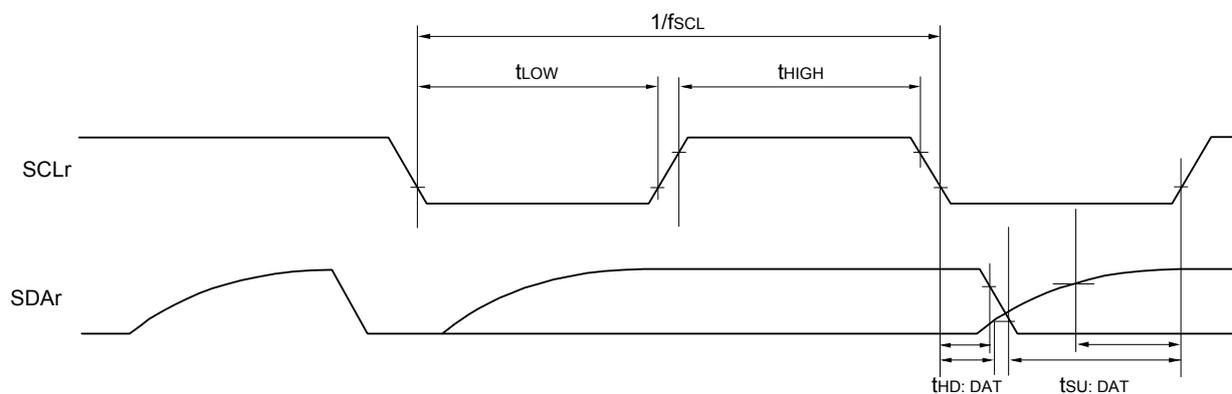
**Note 2.** Set the f<sub>MCK</sub> value to keep the hold time of SCLr = "L" and SCLr = "H".

**Caution** Select the normal input buffer and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the SDAr pin and the normal output mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register h (POMh).

**Simplified I<sup>2</sup>C mode connection diagram (during communication at same potential)**



**Simplified I<sup>2</sup>C mode serial transfer timing (during communication at same potential)**



- Remark 1.**  $R_b[\Omega]$ : Communication line (SDAr) pull-up resistance,  $C_b[F]$ : Communication line (SDAr, SCLr) load capacitance
- Remark 2.** r: IIC number (r = 00, 01, 10 and 11), g: PIM number (g = 0, 3 and 5), h: POM number (h = 0, 3 and 5)
- Remark 3.**  $f_{mck}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number (m = 0), n: Channel number (n = 0 to 3), mn = 00 to 03)

**(5) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (UART mode) (dedicated baud rate generator output)****TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
Transfer rate		Reception 4.0 V ≤ EVDD ≤ 5.5 V, 2.3 V ≤ Vb ≤ 4.0 V		fMCK/12 Note 1	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		2.0
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V		fMCK/12 Note 1	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		2.0
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V		fMCK/12 Notes 1, 2	bps
			Theoretical value of the maximum transfer rate fMCK = fCLK Note 3		1.3

**Note 1.** Transfer rate in the SNOOZE mode is 4,800 bps only.**Note 2.** Use it with EVDD ≥ Vb.**Note 3.** The maximum operating frequencies of the CPU/peripheral hardware clock (fCLK) are:

HS (high-speed main) mode: 24 MHz (2.7 V ≤ VDD ≤ 5.5 V)

16 MHz (2.4 V ≤ VDD ≤ 5.5 V)

**Caution** Select the TTL input buffer for the RxDq pin and the N-ch open drain output (EVDD tolerance) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

**Remark 1.** Vb[V]: Communication line voltage**Remark 2.** q: UART number (q = 0 and 1), g: PIM and POM numbers (g = 0, 2, 3, 5, 12)**Remark 3.** fMCK: Serial array unit operation clock frequency

(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number,

n: Channel number (mn = 00 to 03))

TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit	
			MIN.	MAX.		
Transfer rate		Transmission	4.0 V ≤ EVDD ≤ 5.5 V, 2.3 V ≤ Vb ≤ 4.0 V		Note 1	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 1.4 kΩ, Vb = 2.7 V		2.6 Note 2	Mbps
			2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V		Note 3	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 2.7 kΩ, Vb = 2.3 V		1.2 Note 4	Mbps
			2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V		Notes 5, 6	bps
			Theoretical value of the maximum transfer rate Cb = 50 pF, Rb = 5.5 kΩ, Vb = 1.6 V		0.43 Note 7	Mbps

**Note 1.** The smaller maximum transfer rate derived by using  $f_{MCK}/6$  or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when 4.0 V ≤ EVDD ≤ 5.5 V and 2.7 V ≤ Vb ≤ 4.0 V

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{2.2}{V_b})\} \times 3} \text{ [bps]}$$

$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{2.2}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

**Note 2.** This value as an example is calculated when the conditions described in the "Conditions" column are met. Refer to Note 1 above to calculate the maximum transfer rate under conditions of the customer.

**Note 3.** The smaller maximum transfer rate derived by using  $f_{MCK}/6$  or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when 2.7 V ≤ EVDD ≤ 4.0 V and 2.3 V ≤ Vb ≤ 2.7 V

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{2.0}{V_b})\} \times 3} \text{ [bps]}$$

$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{2.0}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

**Note 4.** This value as an example is calculated when the conditions described in the "Conditions" column are met. Refer to Note 3 above to calculate the maximum transfer rate under conditions of the customer.

**Note 5.** Use it with EVDD ≥ Vb.

**Note 6.** The smaller maximum transfer rate derived by using  $f_{MCK}/6$  or the following expression is the valid maximum transfer rate. Expression for calculating the transfer rate when  $2.4\text{ V} \leq EV_{DD} < 3.3\text{ V}$  and  $1.6\text{ V} \leq V_b \leq 2.0\text{ V}$

$$\text{Maximum transfer rate} = \frac{1}{\{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\} \times 3} \text{ [bps]}$$

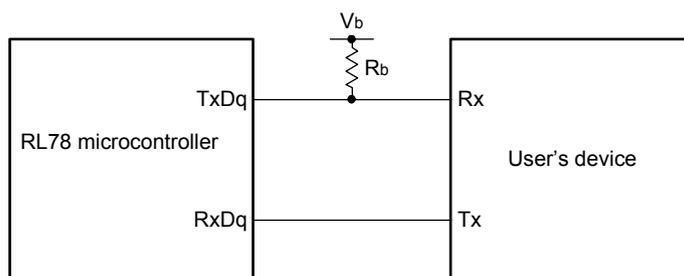
$$\text{Baud rate error (theoretical value)} = \frac{\frac{1}{\text{Transfer rate} \times 2} - \{-C_b \times R_b \times \ln(1 - \frac{1.5}{V_b})\}}{(\frac{1}{\text{Transfer rate}}) \times \text{Number of transferred bits}} \times 100 \text{ [%]}$$

\* This value is the theoretical value of the relative difference between the transmission and reception sides

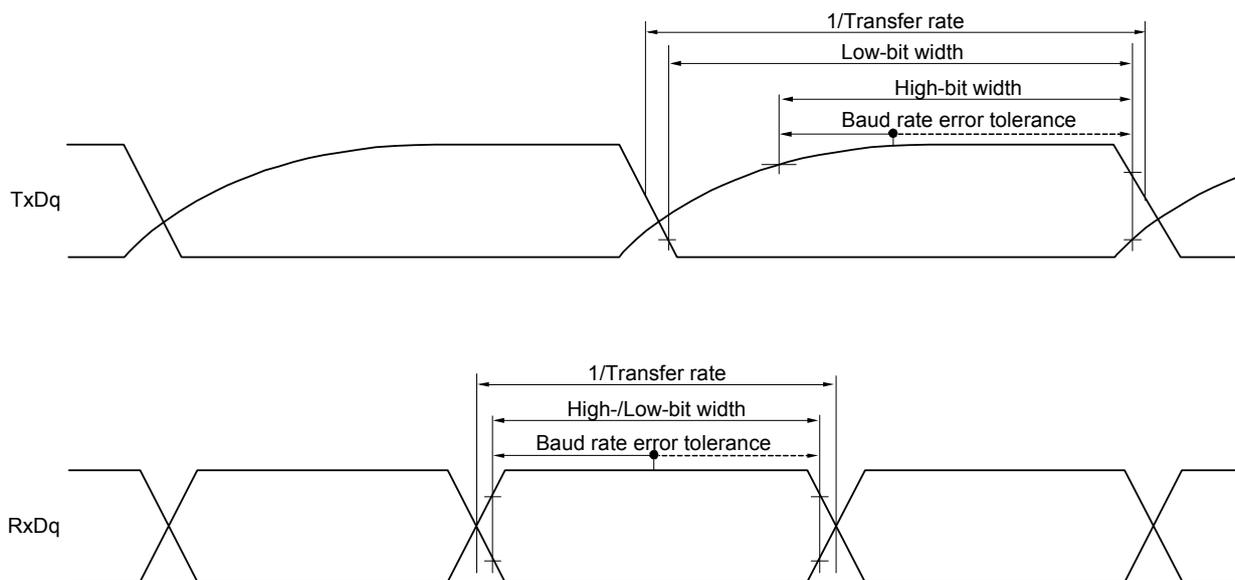
**Note 7.** This value as an example is calculated when the conditions described in the "Conditions" column are met. Refer to Note 6 above to calculate the maximum transfer rate under conditions of the customer.

**Caution** Select the TTL input buffer for the RxDq pin and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the TxDq pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

**UART mode connection diagram (during communication at different potential)**



**UART mode bit width (during communication at different potential) (reference)**



**Remark 1.**  $R_b[\Omega]$ : Communication line (TxDq) pull-up resistance,  $C_b[F]$ : Communication line (TxDq) load capacitance,  $V_b[V]$ : Communication line voltage

**Remark 2.** q: UART number (q = 0 and 1), g: PIM and POM number (g = 0, 2, 3, 5 and 12)

**Remark 3.**  $f_{MCK}$ : Serial array unit operation clock frequency  
 (Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**(6) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (master mode, SCKp... internal clock output)****(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)****(1/2)**

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCKp cycle time	tkCY1	tkCY1 ≥ 4/fCLK 4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	600		ns
			1000		ns
			2300		ns
SCKp high-level width	tkH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	tkCY1/2 - 150		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	tkCY1/2 - 340		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V, Cb = 30 pF, Rb = 5.5 kΩ	tkCY1/2 - 916		ns
SCKp low-level width	tkL1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	tkCY1/2 - 24		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	tkCY1/2 - 36		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V, Cb = 30 pF, Rb = 5.5 kΩ	tkCY1/2 - 100		ns

**Caution** Select the TTL input buffer for the SIp pin and the N-ch open drain output (EVDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

(Remarks are listed on the page after the next page.)

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

(2/2)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
Slp setup time (to SCKp↑) Note 1	tSIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	162		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ	354		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ	958		ns
Slp hold time (from SCKp↑) Note 1	tSIH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	38		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ			ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ			ns
Delay time from SCKp↓ to SOp output Note 1	tKS01	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ		200	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ		390	ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ		966	ns
Slp setup time (to SCKp↓) Note 2	tSIK1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	88		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ			ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ	220		ns
Slp hold time (from SCKp↓) Note 2	tSIH1	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ	38		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ			
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ			ns
Delay time from SCKp↑ to SOp output Note 2	tKS01	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 30 pF, Rb = 1.4 kΩ		50	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 30 pF, Rb = 2.7 kΩ			
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 3, Cb = 30 pF, Rb = 5.5 kΩ			ns

**Note 1.** When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.

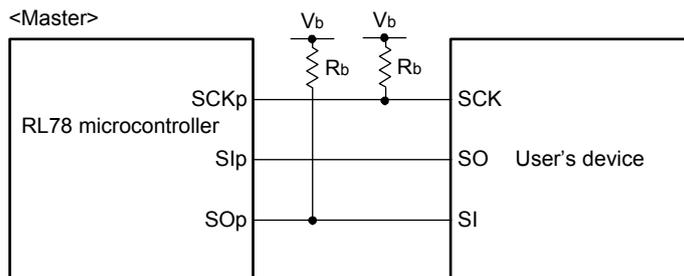
**Note 2.** When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.

**Note 3.** Use it with EVDD ≥ Vb.

**Caution** Select the TTL input buffer for the Slp pin and the N-ch open drain output (EVDD tolerance) mode for the SOp pin and SCKp pin by using port input mode register g (PIMg) and port output mode register g (POMg). For VIH and VIL, see the DC characteristics with TTL input buffer selected.

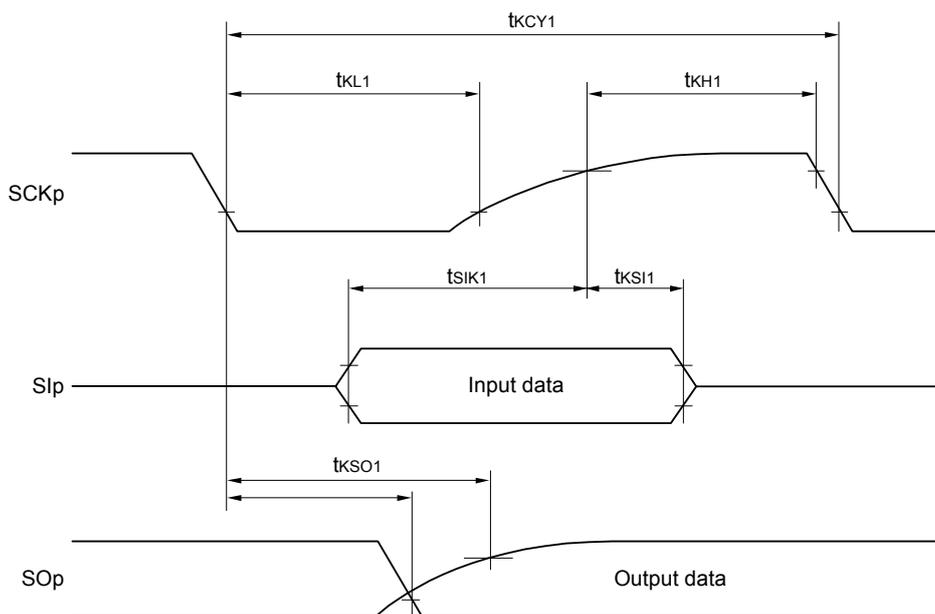
(Remarks are listed on the next page.)

**CSI mode connection diagram (during communication at different potential)**

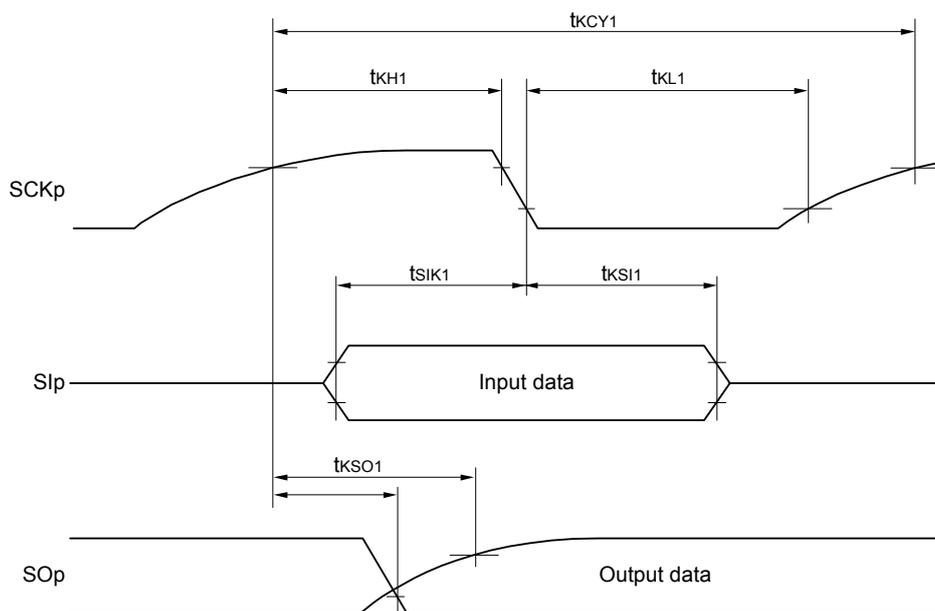


- Remark 1.**  $R_b[\Omega]$ : Communication line (SCKp, SOp) pull-up resistance,  $C_b[F]$ : Communication line (SCKp, SOp) load capacitance,  $V_b[V]$ : Communication line voltage
- Remark 2.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)
- Remark 3.**  $f_{mck}$ : Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (master mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

## (7) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (CSI mode) (slave mode, SCKp... external clock input)

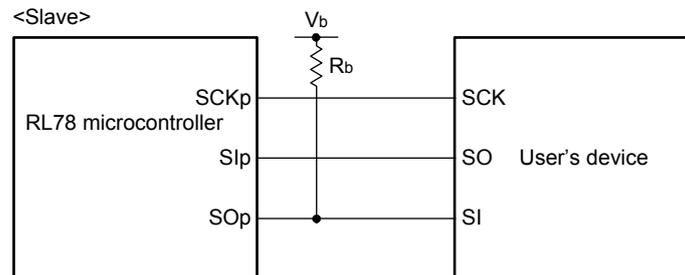
TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit	
			MIN.	MAX.		
SCKp cycle time <sup>Note 1</sup>	tkCY2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V	20 MHz < fMCK ≤ 24 MHz	24/fMCK		ns
			8 MHz < fMCK ≤ 20 MHz	20/fMCK		ns
			4 MHz < fMCK ≤ 8 MHz	16/fMCK		ns
			fMCK ≤ 4 MHz	12/fMCK		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V	20 MHz < fMCK ≤ 24 MHz	32/fMCK		ns
			16 MHz < fMCK ≤ 20 MHz	28/fMCK		ns
			8 MHz < fMCK ≤ 16 MHz	24/fMCK		ns
			4 MHz < fMCK ≤ 8 MHz	16/fMCK		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 2</sup>	20 MHz < fMCK ≤ 24 MHz	72/fMCK		ns
			16 MHz < fMCK ≤ 20 MHz	64/fMCK		ns
			8 MHz < fMCK ≤ 16 MHz	52/fMCK		ns
			4 MHz < fMCK ≤ 8 MHz	32/fMCK		ns
		fMCK ≤ 4 MHz	20/fMCK		ns	
SCKp high-/low-level width	tkH2, tkL2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V	tkCY2/2 - 24		ns	
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V	tkCY2/2 - 36		ns	
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 2</sup>	tkCY2/2 - 100		ns	
Slp setup time (to SCKp↑) <sup>Note 3</sup>	tsIK2	2.7 V ≤ EVDD ≤ 5.5 V, 2.3 V ≤ Vb ≤ 4.0 V	1/fMCK + 40		ns	
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 2</sup>	1/fMCK + 60		ns	
Slp hold time (from SCKp↑) <sup>Note 4</sup>	tkSI2		1/fMCK + 62		ns	
Delay time from SCKp↓ to SOP output <sup>Note 5</sup>	tkSO2	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V Cb = 30 pF, Rb = 1.4 kΩ		2/fMCK + 240	ns	
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V Cb = 30 pF, Rb = 2.7 kΩ		2/fMCK + 428	ns	
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V <sup>Note 2</sup> Cb = 30 pF, Rb = 5.5 kΩ		2/fMCK + 1146	ns	

(Notes, Caution and Remarks are listed on the next page.)

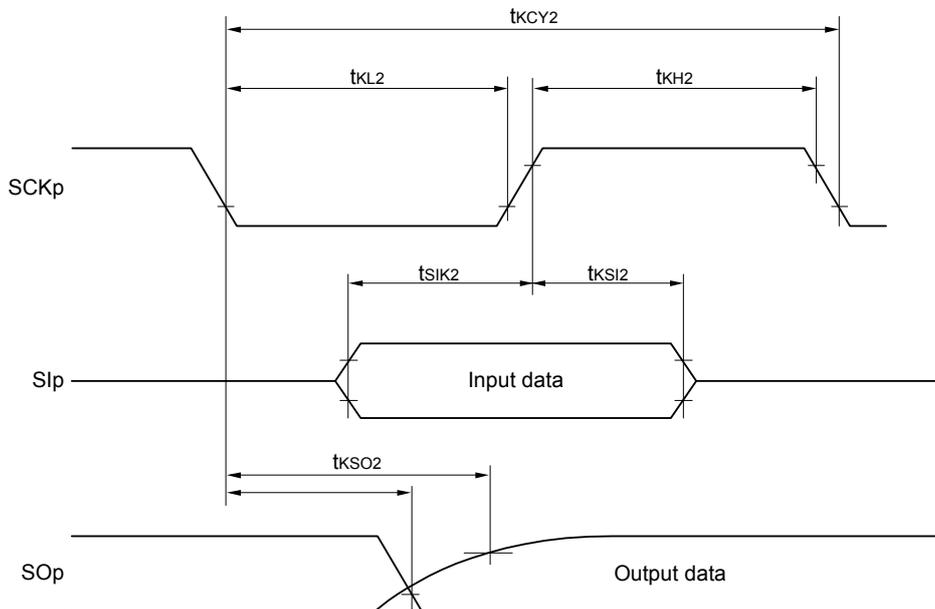
- Note 1.** Transfer rate in the SNOOZE mode: MAX. 1 Mbps
- Note 2.** Use it with  $EV_{DD} \geq V_b$ .
- Note 3.** When  $DAP_{mn} = 0$  and  $CKP_{mn} = 0$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 1$ . The  $Slp$  setup time becomes “to  $SCKp_{\downarrow}$ ” when  $DAP_{mn} = 0$  and  $CKP_{mn} = 1$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 0$ .
- Note 4.** When  $DAP_{mn} = 0$  and  $CKP_{mn} = 0$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 1$ . The  $Slp$  hold time becomes “from  $SCKp_{\downarrow}$ ” when  $DAP_{mn} = 0$  and  $CKP_{mn} = 1$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 0$ .
- Note 5.** When  $DAP_{mn} = 0$  and  $CKP_{mn} = 0$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 1$ . The delay time to  $SOp$  output becomes “from  $SCKp_{\uparrow}$ ” when  $DAP_{mn} = 0$  and  $CKP_{mn} = 1$ , or  $DAP_{mn} = 1$  and  $CKP_{mn} = 0$ .
- Caution** Select the TTL input buffer for the  $Slp$  pin and  $SCKp$  pin and the N-ch open drain output ( $EV_{DD}$  tolerance) mode for the  $SOp$  pin by using port input mode register g (PIMg) and port output mode register g (POMg). For  $V_{IH}$  and  $V_{IL}$ , see the DC characteristics with TTL input buffer selected.

**CSI mode connection diagram (during communication at different potential)**

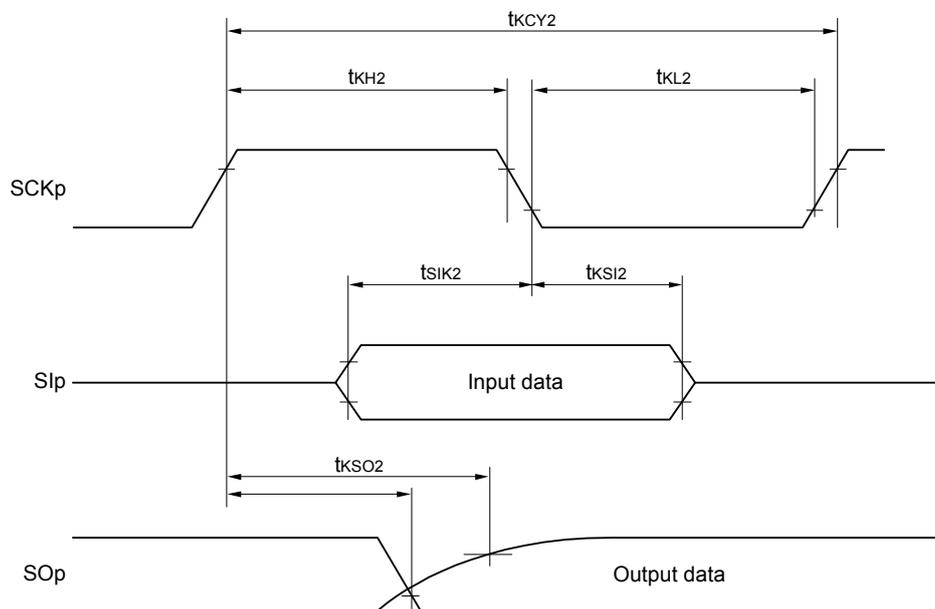


- Remark 1.**  $R_b[\Omega]$ : Communication line (SOp) pull-up resistance,  $C_b[F]$ : Communication line (SOp) load capacitance,  $V_b[V]$ : Communication line voltage
- Remark 2.** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)
- Remark 3.**  $f_{MCK}$ : Serial array unit operation clock frequency  
(Operation clock to be set by the  $CKSmn$  bit of serial mode register mn (SMRmn). m: Unit number, n: Channel number (mn = 00 to 03))

**CSI mode serial transfer timing (slave mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 0, or DAPmn = 1 and CKPmn = 1.)**



**CSI mode serial transfer timing (slave mode) (during communication at different potential)  
(When DAPmn = 0 and CKPmn = 1, or DAPmn = 1 and CKPmn = 0.)**



**Remark** p: CSI number (p = 00, 01, 10 and 11), m: Unit number (m = 0), n: Channel number (n = 0 to 3), g: PIM and POM numbers (g = 0, 2, 3 to 5 and 12)

(8) Communication at different potential (1.8 V, 2.5 V, 3.0 V) (simplified I<sup>2</sup>C mode)

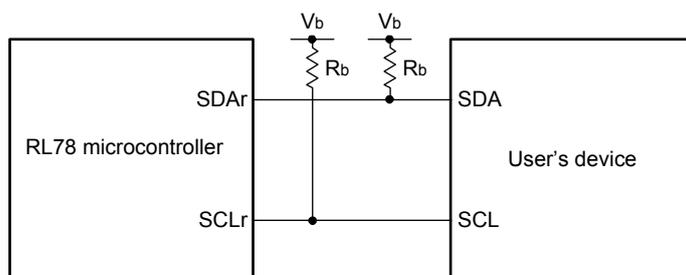
(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) Mode		Unit
			MIN.	MAX.	
SCLr clock frequency	f <sub>SCL</sub>	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 50 pF, Rb = 2.7 kΩ		400 Note 1	kHz
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 50 pF, Rb = 2.7 kΩ		400 Note 1	kHz
		4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 100 pF, Rb = 2.8 kΩ		100 Note 1	kHz
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 100 pF, Rb = 2.7 kΩ		100 Note 1	kHz
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 100 pF, Rb = 5.5 kΩ		100 Note 1	kHz
Hold time when SCLr = "L"	t <sub>LOW</sub>	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 50 pF, Rb = 2.7 kΩ	1200		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 50 pF, Rb = 2.7 kΩ	1200		ns
		4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 100 pF, Rb = 2.8 kΩ	4600		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 100 pF, Rb = 2.7 kΩ	4600		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 100 pF, Rb = 5.5 kΩ	4650		ns
Hold time when SCLr = "H"	t <sub>HIGH</sub>	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 50 pF, Rb = 2.7 kΩ	620		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 50 pF, Rb = 2.7 kΩ	500		ns
		4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 100 pF, Rb = 2.8 kΩ	2700		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 100 pF, Rb = 2.7 kΩ	2400		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 100 pF, Rb = 5.5 kΩ	1830		ns
Data setup time (reception)	t <sub>SU-DAT</sub>	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 50 pF, Rb = 2.7 kΩ	1/f <sub>MCK</sub> + 340 Note 3		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 50 pF, Rb = 2.7 kΩ	1/f <sub>MCK</sub> + 340 Note 3		ns
		4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 100 pF, Rb = 2.8 kΩ	1/f <sub>MCK</sub> + 760 Note 3		ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 100 pF, Rb = 2.7 kΩ	1/f <sub>MCK</sub> + 760 Note 3		ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 100 pF, Rb = 5.5 kΩ	1/f <sub>MCK</sub> + 570 Note 3		ns
Data hold time (transmission)	t <sub>HD-DAT</sub>	4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 50 pF, Rb = 2.7 kΩ	0	770	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 50 pF, Rb = 2.7 kΩ	0	770	ns
		4.0 V ≤ EVDD ≤ 5.5 V, 2.7 V ≤ Vb ≤ 4.0 V, Cb = 100 pF, Rb = 2.8 kΩ	0	1420	ns
		2.7 V ≤ EVDD < 4.0 V, 2.3 V ≤ Vb ≤ 2.7 V, Cb = 100 pF, Rb = 2.7 kΩ	0	1420	ns
		2.4 V ≤ EVDD < 3.3 V, 1.6 V ≤ Vb ≤ 2.0 V Note 2, Cb = 100 pF, Rb = 5.5 kΩ	0	1215	ns

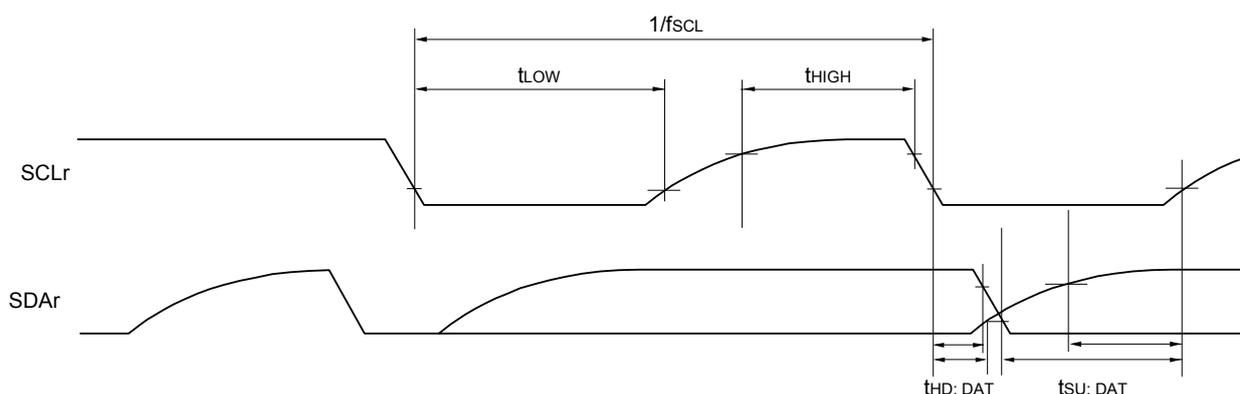
- Note 1.** The value must also be equal to or less than  $f_{mck}/4$ .
- Note 2.** Use it with  $EV_{DD} \geq V_b$ .
- Note 3.** Set the  $f_{mck}$  value to keep the hold time of  $SCLr = "L"$  and  $SCLr = "H"$ .

**Caution** Select the TTL input buffer and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the SDAr pin and the N-ch open drain output (EV<sub>DD</sub> tolerance) mode for the SCLr pin by using port input mode register g (PIMg) and port output mode register g (POMg). For V<sub>IH</sub> and V<sub>IL</sub>, see the DC characteristics with TTL input buffer selected.

**Simplified I<sup>2</sup>C mode connection diagram (during communication at different potential)**



**Simplified I<sup>2</sup>C mode serial transfer timing (during communication at different potential)**



- Remark 1.** R<sub>b</sub>[Ω]: Communication line (SDAr, SCLr) pull-up resistance, C<sub>b</sub>[F]: Communication line (SDAr, SCLr) load capacitance, V<sub>b</sub>[V]: Communication line voltage
- Remark 2.** r: IIC number (r = 00, 01, 10 and 11), g: PIM, POM number (g = 0, 3 and 5)
- Remark 3.** f<sub>mck</sub>: Serial array unit operation clock frequency  
(Operation clock to be set by the CKSmn bit of serial mode register mn (SMRmn). m: Unit number (m = 0), n: Channel number (n = 0 to 3), mn = 00 to 03)

### 3.5.2 Serial interface IICA

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	HS (high-speed main) mode				Unit
			Standard mode		Fast mode		
			MIN.	MAX.	MIN.	MAX.	
SCLA0 clock frequency	fSCL	Fast mode: fCLK ≥ 3.5 MHz	—	—	0	400	kHz
		Standard mode: fCLK ≥ 1 MHz	0	100	—	—	
Setup time of restart condition	tSU: STA		4.7		0.6		μs
Hold time Note 1	tHD: STA		4.0		0.6		μs
Hold time when SCLA0 = "L"	tLOW		4.7		1.3		μs
Hold time when SCLA0 = "H"	tHIGH		4.0		0.6		μs
Data setup time (reception)	tSU: DAT		250		100		ns
Data hold time (transmission) Note 2	tHD: DAT		0	3.45	0	0.9	μs
Setup time of stop condition	tSU: STO		4.0		0.6		μs
Bus-free time	tBUF		4.7		1.3		μs

**Note 1.** The first clock pulse is generated after this period when the start/restart condition is detected.

**Note 2.** The maximum value (MAX.) of tHD: DAT is during normal transfer and a wait state is inserted in the ACK (acknowledge) timing.

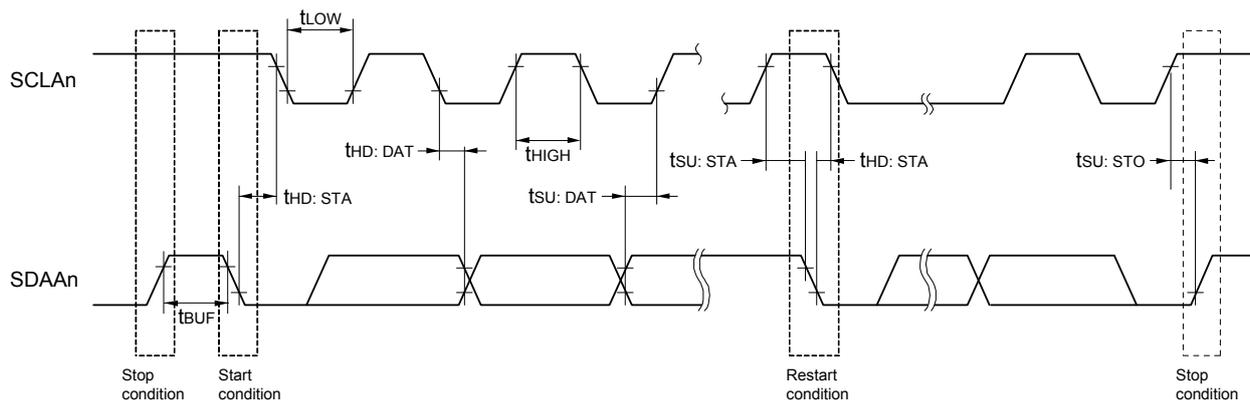
**Caution** The values in the above table are applied even when bit 2 (PIOR02) in the peripheral I/O redirection register 0 (PIOR0) is 1. At this time, the pin characteristics (IOH1, IOL1, VOH1, VOL1) must satisfy the values in the redirect destination.

**Remark** The maximum value of Cb (communication line capacitance) and the value of Rb (communication line pull-up resistor) at that time in each mode are as follows.

Standard mode: Cb = 400 pF, Rb = 2.7 kΩ

Fast mode: Cb = 320 pF, Rb = 1.1 kΩ

IICA serial transfer timing



**Remark** n = 0, 1

## 3.6 Analog Characteristics

### 3.6.1 A/D converter characteristics

#### Classification of A/D converter characteristics

Input channel	Reference Voltage	Reference voltage (+) = AV <sub>REFP</sub> Reference voltage (-) = AV <sub>REFM</sub>	Reference voltage (+) = V <sub>DD</sub> Reference voltage (-) = V <sub>SS</sub>	Reference voltage (+) = V <sub>BGR</sub> Reference voltage (-) = AV <sub>REFM</sub>
ANI0 to ANI3		Refer to 3.6.1 (1).	Refer to 3.6.1 (3).	Refer to 3.6.1 (4).
ANI16 to ANI22		Refer to 3.6.1 (2).		
Internal reference voltage Temperature sensor output voltage		Refer to 3.6.1 (1).		

(1) When reference voltage (+) = AV<sub>REFP</sub>/ANI0 (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) = AV<sub>REFM</sub>/ANI1 (ADREFM = 1), target pin: ANI2 and ANI3, internal reference voltage, and temperature sensor output voltage

(TA = -40 to +105°C, 2.4 V ≤ AV<sub>REFP</sub> ≤ V<sub>DD</sub> ≤ 5.5 V, V<sub>SS</sub> = 0 V, Reference voltage (+) = AV<sub>REFP</sub>, Reference voltage (-) = AV<sub>REFM</sub> = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	RES		8		10	bit
Overall error Note 1	AINL	10-bit resolution AV <sub>REFP</sub> = V <sub>DD</sub> Note 3	2.4 V ≤ AV <sub>REFP</sub> ≤ 5.5 V	1.2	±3.5	LSB
Conversion time	t <sub>CONV</sub>	10-bit resolution Target pin: ANI2 and ANI3	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.125	39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.1875	39	μs
			2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V	17	39	μs
		10-bit resolution Target pin: Internal reference voltage, and temperature sensor output voltage	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.375	39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.5625	39	μs
			1.8 V ≤ V <sub>DD</sub> ≤ 5.5 V	17	39	μs
Zero-scale error Notes 1, 2	EzS	10-bit resolution AV <sub>REFP</sub> = V <sub>DD</sub> Note 3	2.4 V ≤ AV <sub>REFP</sub> ≤ 5.5 V		±0.25	%FSR
Full-scale error Notes 1, 2	EFS	10-bit resolution AV <sub>REFP</sub> = V <sub>DD</sub> Note 3	2.4 V ≤ AV <sub>REFP</sub> ≤ 5.5 V		±0.25	%FSR
Integral linearity error Note 1	ILE	10-bit resolution AV <sub>REFP</sub> = V <sub>DD</sub> Note 3	2.4 V ≤ AV <sub>REFP</sub> ≤ 5.5 V		±2.5	LSB
Differential linearity error Note 1	DLE	10-bit resolution AV <sub>REFP</sub> = V <sub>DD</sub> Note 3	2.4 V ≤ AV <sub>REFP</sub> ≤ 5.5 V		±1.5	LSB
Analog input voltage	V <sub>AIN</sub>	ANI2 and ANI3		0	AV <sub>REFP</sub>	V
		Internal reference voltage (2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V)		V <sub>BGR</sub> Note 4		V
		Temperature sensor output voltage (2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V)		V <sub>TMPS25</sub> Note 4		V

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (%FSR) to the full-scale value.

**Note 3.** When AV<sub>REFP</sub> < V<sub>DD</sub>, the MAX. values are as follows.

Overall error: Add ±1.0 LSB to the MAX. value when AV<sub>REFP</sub> = V<sub>DD</sub>.  
 Zero-scale error/Full-scale error: Add ±0.05%FSR to the MAX. value when AV<sub>REFP</sub> = V<sub>DD</sub>.  
 Integral linearity error/ Differential linearity error: Add ±0.5 LSB to the MAX. value when AV<sub>REFP</sub> = V<sub>DD</sub>.

**Note 4.** Refer to 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

(2) When reference voltage (+) =  $AV_{REFP}/ANI0$  (ADREFP1 = 0, ADREFP0 = 1), reference voltage (-) =  $AV_{REFM}/ANI1$  (ADREFM = 1), target pin: ANI16 to ANI22

(TA = -40 to +105°C,  $2.4\text{ V} \leq EV_{DD} \leq V_{DD} \leq 5.5\text{ V}$ ,  $2.4\text{ V} \leq AV_{REFP} \leq V_{DD} \leq 5.5\text{ V}$ ,  $V_{SS} = 0\text{ V}$ ,

Reference voltage (+) =  $AV_{REFP}$ , Reference voltage (-) =  $AV_{REFM} = 0\text{ V}$ )

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES			8		10	bit
Overall error Note 1	AINL	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$2.4\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$		1.2	$\pm 5.0$	LSB
Conversion time	tCONV	10-bit resolution Target ANI pin: ANI16 to ANI22	$3.6\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	2.125		39	$\mu\text{s}$
			$2.7\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	3.1875		39	$\mu\text{s}$
			$2.4\text{ V} \leq V_{DD} \leq 5.5\text{ V}$	17		39	$\mu\text{s}$
Zero-scale error Notes 1, 2	E <sub>ZS</sub>	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$2.4\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			$\pm 0.35$	%FSR
Full-scale error Notes 1, 2	E <sub>FS</sub>	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$2.4\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			$\pm 0.35$	%FSR
Integral linearity error Note 1	ILE	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$2.4\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			$\pm 3.5$	LSB
Differential linearity error Note 1	DLE	10-bit resolution $EV_{DD} \leq AV_{REFP} = V_{DD}$ Notes 3, 4	$2.4\text{ V} \leq AV_{REFP} \leq 5.5\text{ V}$			$\pm 2.0$	LSB
Analog input voltage	V <sub>AIN</sub>	ANI16 to ANI22		0		$AV_{REFP}$ and $EV_{DD}$	V

**Note 1.** Excludes quantization error ( $\pm 1/2$  LSB).

**Note 2.** This value is indicated as a ratio (%FSR) to the full-scale value.

**Note 3.** When  $EV_{DD} \leq AV_{REFP} \leq V_{DD}$ , the MAX. values are as follows.

Overall error: Add  $\pm 1.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .  
 Zero-scale error/Full-scale error: Add  $\pm 0.05\%$ FSR to the MAX. value when  $AV_{REFP} = V_{DD}$ .  
 Integral linearity error/ Differential linearity error: Add  $\pm 0.5$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

**Note 4.** When  $AV_{REFP} < EV_{DD} \leq V_{DD}$ , the MAX. values are as follows.

Overall error: Add  $\pm 4.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .  
 Zero-scale error/Full-scale error: Add  $\pm 0.20\%$ FSR to the MAX. value when  $AV_{REFP} = V_{DD}$ .  
 Integral linearity error/ Differential linearity error: Add  $\pm 2.0$  LSB to the MAX. value when  $AV_{REFP} = V_{DD}$ .

- (3) When reference voltage (+) = V<sub>DD</sub> (ADREFP1 = 0, ADREFP0 = 0), reference voltage (-) = V<sub>SS</sub> (ADREFM = 0), target pin: ANI0 to ANI3, ANI16 to ANI22, internal reference voltage, and temperature sensor output voltage

(TA = -40 to +105°C, 2.4 V ≤ EV<sub>DD</sub> ≤ V<sub>DD</sub> ≤ 5.5 V, V<sub>SS</sub> = 0 V,

Reference voltage (+) = V<sub>DD</sub>, Reference voltage (-) = V<sub>SS</sub>)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES			8		10	bit
Overall error Note 1	AINL	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V		1.2	±7.0	LSB
Conversion time	t <sub>CONV</sub>	10-bit resolution Target pin: ANI0 to ANI3, ANI16 to ANI22	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.125		39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.1875		39	μs
			2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V	17		39	μs
		10-bit resolution Target pin: internal reference voltage, and temperature sensor output voltage	3.6 V ≤ V <sub>DD</sub> ≤ 5.5 V	2.375		39	μs
			2.7 V ≤ V <sub>DD</sub> ≤ 5.5 V	3.5625		39	μs
			2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V	17		39	μs
Zero-scale error Notes 1, 2	E <sub>ZS</sub>	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
Full-scale error Notes 1, 2	E <sub>FS</sub>	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±0.60	%FSR
Integral linearity error Note 1	ILE	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±4.0	LSB
Differential linearity error Note 1	DLE	10-bit resolution	2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V			±2.0	LSB
Analog input voltage	V <sub>AIN</sub>	ANI0 to ANI3		0		V <sub>DD</sub>	V
		ANI16 to ANI22		0		EV <sub>DD</sub>	V
		Internal reference voltage (2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V)		V <sub>BGR</sub> Note 3			V
		Temperature sensor output voltage (2.4 V ≤ V <sub>DD</sub> ≤ 5.5 V)		V <sub>TMPS25</sub> Note 3			V

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (% FSR) to the full-scale value.

**Note 3.** Refer to 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

- (4) When reference voltage (+) = Internal reference voltage (ADREFP1 = 1, ADREFP0 = 0), reference voltage (-) = AVREFM/ANI1 (ADREFM = 1), target pin: ANI0 to ANI3, ANI16 to ANI22

(TA = -40 to +105°C, 2.4 V ≤ VDD ≤ 5.5 V, 1.6 V ≤ EVDD ≤ VDD = 0 V,

Reference voltage (+) = VBGR Note 3, Reference voltage (-) = AVREFM = 0 V Note 4)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Resolution	RES		8			bit
Conversion time	tCONV		17		39	μs
Zero-scale error Notes 1, 2	Ezs				±0.60	% FSR
Integral linearity error Note 1	ILE				±2.0	LSB
Differential linearity error Note 1	DLE	8-bit resolution			±1.0	LSB
Analog input voltage	VAIN		0		VBGR Note 3	V

**Note 1.** Excludes quantization error (±1/2 LSB).

**Note 2.** This value is indicated as a ratio (% FSR) to the full-scale value.

**Note 3.** Refer to 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic.

**Note 4.** When reference voltage (-) = Vss, the MAX. values are as follows.

Zero-scale error: Add ±0.35%FSR to the MAX. value when reference voltage (-) = AVREFM.

Integral linearity error: Add ±0.5 LSB to the MAX. value when reference voltage (-) = AVREFM.

Differential linearity error: Add ±0.2 LSB to the MAX. value when reference voltage (-) = AVREFM.

### 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic

(TA = -40 to +105°C, 2.4 V ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Temperature sensor output voltage	VTMPS25	Setting ADS register = 80H, TA = +25°C		1.05		V
Internal reference voltage	VBGR	Setting ADS register = 81H	1.38	1.45	1.5	V
Temperature coefficient	FVTMPS	Temperature sensor that depends on the temperature		-3.6		mV/°C
Operation stabilization wait time	tAMP	2.4 V ≤ VDD ≤ 3.6 V	5			μs

### 3.6.3 D/A converter characteristics

(TA = -40 to +105°C, 2.4 V ≤ EVSS ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Resolution	RES					8	bit
Overall error	AINL	Rload = 4 MΩ	2.4 V ≤ VDD ≤ 5.5 V			±2.5	LSB
		Rload = 8 MΩ	2.4 V ≤ VDD ≤ 5.5 V			±2.5	LSB
Settling time	tSET	Cload = 20 pF	2.7 V ≤ VDD ≤ 5.5 V			3	μs
			2.4 V ≤ VDD < 2.7 V			6	μs

### 3.6.4 Comparator

**Comparator0: (TA = -40 to +105°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, Vss = 0 V)**

**Comparator1: (TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, Vss = 0 V)**

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Input voltage range	VIREF0	IVREF0 pin	0		V <sub>DD</sub> - 1.4 Note 1	V
	VIREF1	IVREF1 pin	1.4 Note 1		V <sub>DD</sub>	V
	VICMP	IVCMP0 pin	-0.3		V <sub>DD</sub> +0.3	V
		IVCMP1 pin	-0.3		EV <sub>DD</sub> +0.3	V
Output delay	td	V <sub>DD</sub> = 3.0 V Input slew rate > 50 mV/μs	Comparator high-speed mode, standard mode		1.2	μs
			Comparator high-speed mode, window mode		1.5	μs
			Comparator low-speed mode, standard mode		3	μs
			Comparator low-speed mode, window mode		4	μs
Operation stabilization wait time	tcMP		100			μs
Reference voltage declination in channel 0 of internal DAC Note 2	ΔVIDAC				±2.5	LSB

**Note 1.** In window mode, make sure that VREF1 - VREF0 ≥ 0.2 V.

**Note 2.** Only in CMP0

### 3.6.5 PGA

(TA = -40 to +105°C, 2.7 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
Input offset voltage	V <sub>IOPGA</sub>					±10	mV
Input voltage range	V <sub>IPGA</sub>			0		0.9 × V <sub>DD</sub> /Gain	V
Output voltage range	V <sub>IOHPGA</sub>			0.93 × V <sub>DD</sub>			V
	V <sub>IOHPGA</sub>					0.07 × V <sub>DD</sub>	V
Gain error		x4, x8				±1	%
		x16				±1.5	%
		x32				±2	%
Slew rate	SR <sub>RPGA</sub>	Rising When V <sub>IN</sub> = 0.1V <sub>DD</sub> /gain to 0.9V <sub>DD</sub> /gain. 10 to 90% of output voltage amplitude	4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (Other than x32)	3.5			V/μs
			4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (x32)	3.0			
			2.7 V ≤ V <sub>DD</sub> ≤ 4.0V	0.5			
	SR <sub>FPGA</sub>	Falling When V <sub>IN</sub> = 0.1V <sub>DD</sub> /gain to 0.9V <sub>DD</sub> /gain. 90 to 10% of output voltage amplitude	4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (Other than x32)	3.5			
			4.0 V ≤ V <sub>DD</sub> ≤ 5.5 V (x32)	3.0			
			2.7 V ≤ V <sub>DD</sub> ≤ 4.0V	0.5			
Reference voltage stabilization wait time <sup>Note</sup>	t <sub>PGA</sub>	x4, x8				5	μs
		x16, x32				10	μs

**Note** Time required until a state is entered where the DC and AC specifications of the PGA are satisfied after the PGA operation has been enabled (PGAEN = 1).

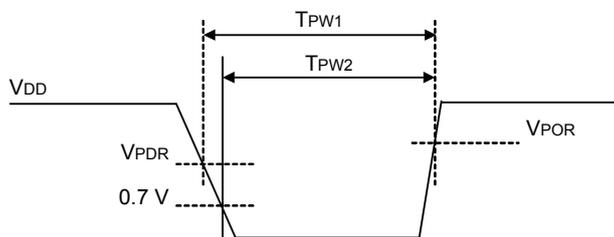
### 3.6.6 POR circuit characteristics

(TA = -40 to +105°C, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	V <sub>POR</sub>	Power supply rise time	1.47	1.51	1.55	V
	V <sub>PDR</sub>	Power supply fall time <i>Note 1</i>	1.46	1.50	1.56	V
Minimum pulse width <i>Note 2</i>	T <sub>PW1</sub>	Other than STOP/SUB HALT/SUB RUN	300			μs
	T <sub>PW2</sub>	STOP/SUB HALT/SUB RUN	300			μs

**Note 1.** However, when the operating voltage falls while the LVD is off, enter STOP mode, or enable the reset status using the external reset pin before the voltage falls below the operating voltage range shown in 3.4 AC Characteristics.

**Note 2.** Minimum time required for a POR reset when V<sub>DD</sub> exceeds below V<sub>PDR</sub>. This is also the minimum time required for a POR reset from when V<sub>DD</sub> exceeds below 0.7 V to when V<sub>DD</sub> exceeds V<sub>POR</sub> while STOP mode is entered or the main system clock is stopped through setting bit 0 (HIOSTOP) and bit 7 (MSTOP) in the clock operation status control register (CSC).



### 3.6.7 LVD circuit characteristics

#### (1) LVD Detection Voltage of Reset Mode and Interrupt Mode

(TA = -40 to +105°C, VPDR ≤ EVDD = VDD ≤ 5.5 V, VSS = 0 V)

Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Detection voltage	Supply voltage level	VLVD0	Power supply rise time	3.90	4.06	4.22	V
			Power supply fall time	3.83	3.98	4.13	V
		VLVD1	Power supply rise time	3.60	3.75	3.90	V
			Power supply fall time	3.53	3.67	3.81	V
		VLVD2	Power supply rise time	3.01	3.13	3.25	V
			Power supply fall time	2.94	3.06	3.18	V
		VLVD3	Power supply rise time	2.90	3.02	3.14	V
			Power supply fall time	2.85	2.96	3.07	V
		VLVD4	Power supply rise time	2.81	2.92	3.03	V
			Power supply fall time	2.75	2.86	2.97	V
		VLVD5	Power supply rise time	2.71	2.81	2.92	V
			Power supply fall time	2.64	2.75	2.86	V
		VLVD6	Power supply rise time	2.61	2.71	2.81	V
			Power supply fall time	2.55	2.65	2.75	V
VLVD7	Power supply rise time	2.51	2.61	2.71	V		
	Power supply fall time	2.45	2.55	2.65	V		
Minimum pulse width		tLW		300			μs
Detection delay time						300	μs

#### (2) LVD Detection Voltage of Interrupt & Reset Mode

(TA = -40 to +105°C, VPDR ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit	
Interrupt and reset mode	VLVDD0	VPOC0, VPOC1, VPOC2 = 0, 1, 1, falling reset voltage	2.64	2.75	2.86	V	
	VLVDD1	LVIS0, LVIS1 = 1, 0	Rising release reset voltage	2.81	2.92	3.03	V
			Falling interrupt voltage	2.75	2.86	2.97	V
	VLVDD2	LVIS0, LVIS1 = 0, 1	Rising release reset voltage	2.90	3.02	3.14	V
			Falling interrupt voltage	2.85	2.96	3.07	V
	VLVDD3	LVIS0, LVIS1 = 0, 0	Rising release reset voltage	3.90	4.06	4.22	V
Falling interrupt voltage			3.83	3.98	4.13	V	

### 3.6.8 Power supply voltage rising slope characteristics

(TA = -40 to +105°C, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Power supply voltage rising slope	SVDD				54	V/ms

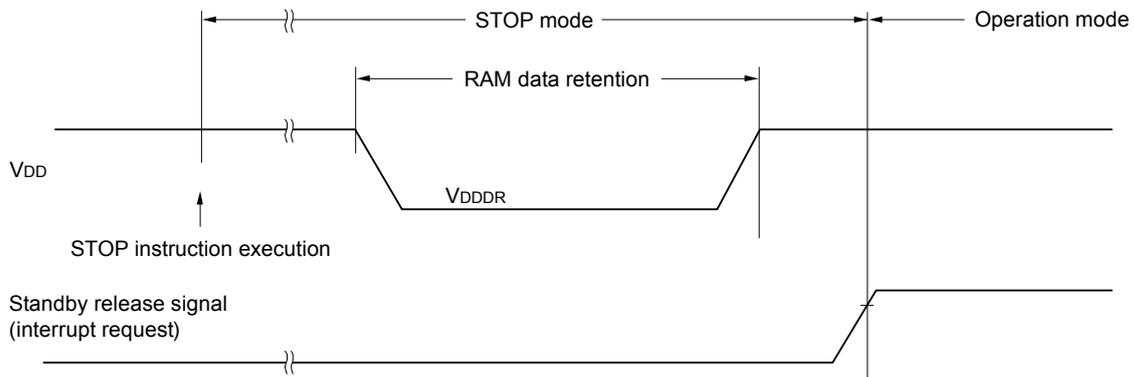
**Caution** Make sure to keep the internal reset state by the LVD circuit or an external reset until VDD reaches the operating voltage range shown in 3.4 AC Characteristics.

### 3.7 RAM Data Retention Characteristics

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Data retention supply voltage	VDDDR		1.44 Note		5.5	V

**Note** The value depends on the POR detection voltage. When the voltage drops, the RAM data is retained before a POR reset is effected, but RAM data is not retained when a POR reset is effected.



### 3.8 Flash Memory Programming Characteristics

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions		MIN.	TYP.	MAX.	Unit
System clock frequency	fCLK			1		24	MHz
Number of code flash rewrites Notes 1, 2, 3	Cerwr	Retained for 20 years	TA = 85°C	1,000			Times
Number of data flash rewrites Notes 1, 2, 3		Retained for 1 year	TA = 25°C		1,000,000		
		Retained for 5 years	TA = 85°C	100,000			
		Retained for 20 years	TA = 85°C	10,000			

**Note 1.** 1 erase + 1 write after the erase is regarded as 1 rewrite. The retaining years are until next rewrite after the rewrite.

**Note 2.** When using flash memory programmer and Renesas Electronics self-programming library

**Note 3.** These are the characteristics of the flash memory and the results obtained from reliability testing by Renesas Electronics Corporation.

### 3.9 Dedicated Flash Memory Programmer Communication (UART)

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Transfer rate		During serial programming	115,200		1,000,000	bps

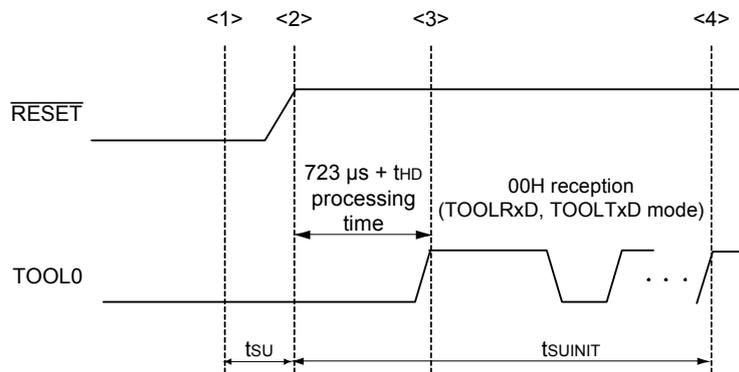
### 3.10 Timing of Entry to Flash Memory Programming Modes

(TA = -40 to +105°C, 2.4 V ≤ EVDD ≤ VDD ≤ 5.5 V, VSS = 0 V)

Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
How long from when an external reset ends until the initial communication settings are specified <sup>Note 1</sup>	tsuINIT	POR and LVD reset must end before the external reset ends.			100	ms
How long from when the TOOL0 pin is placed at the low level until an external reset ends <sup>Note 1</sup>	tsu	POR and LVD reset must end before the external reset ends.	10			μs
How long the TOOL0 pin must be kept at the low level after an external reset ends (excluding the processing time of the firmware to control the flash memory) <sup>Notes 1, 2</sup>	tHD	POR and LVD reset must end before the external reset ends.	1			ms

**Note 1.** Deassertion of the POR and LVD reset signals must precede deassertion of the pin reset signal.

**Note 2.** This excludes the flash firmware processing time (723 μs).



<1> The low level is input to the TOOL0 pin.

<2> The external reset ends (POR and LVD reset must end before the external reset ends).

<3> The TOOL0 pin is set to the high level.

<4> Setting of the flash memory programming mode by UART reception and complete the baud rate setting.

**Remark** tsuINIT: The segment shows that it is necessary to finish specifying the initial communication settings within 100 ms from when the external resets end.

tsu: How long from when the TOOL0 pin is placed at the low level until a pin reset ends

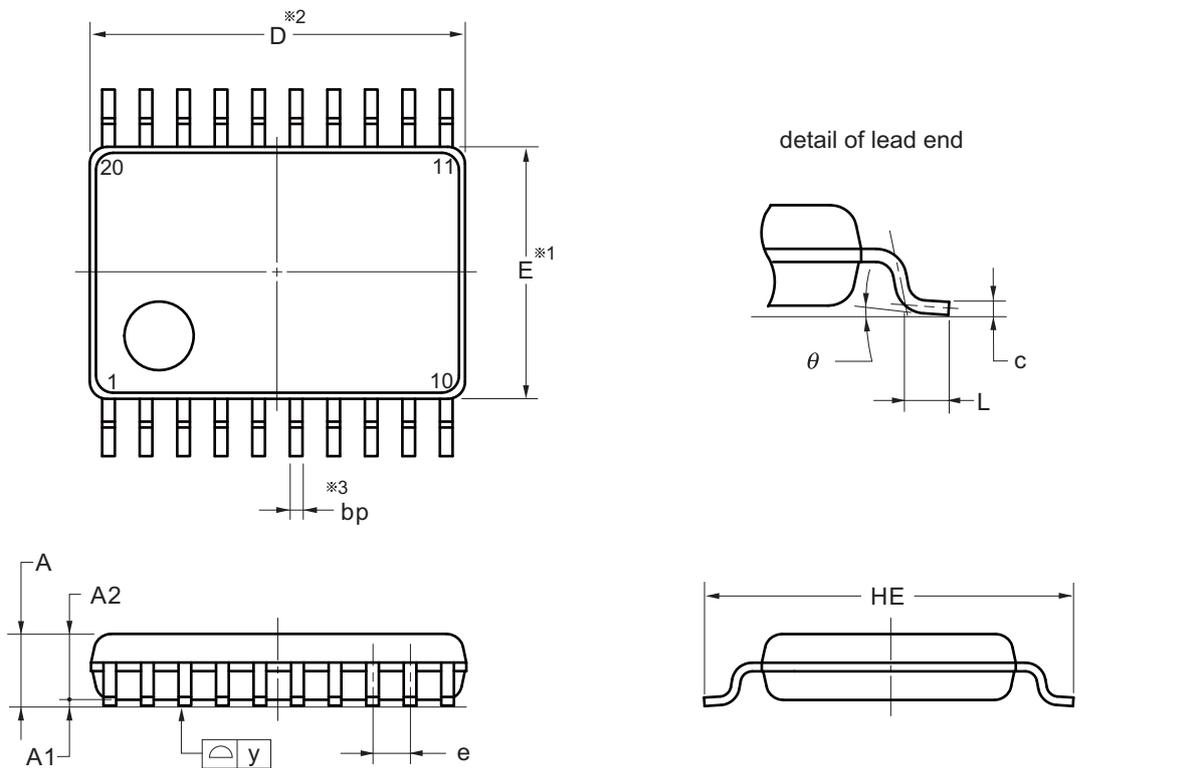
tHD: How long to keep the TOOL0 pin at the low level from when the external resets end (excluding the processing time of the firmware to control the flash memory)

## 4. PACKAGE DRAWING

### 4.1 20-pin products

R5F1056AGSP, R5F1056AASP

JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-LSSOP20-4.4x6.5-0.65	PLSP0020JB-A	P20MA-65-NAA-1	0.1



**NOTE**

1. Dimensions "※1" and "※2" do not include mold flash.
2. Dimension "※3" does not include trim offset.

(UNIT:mm)

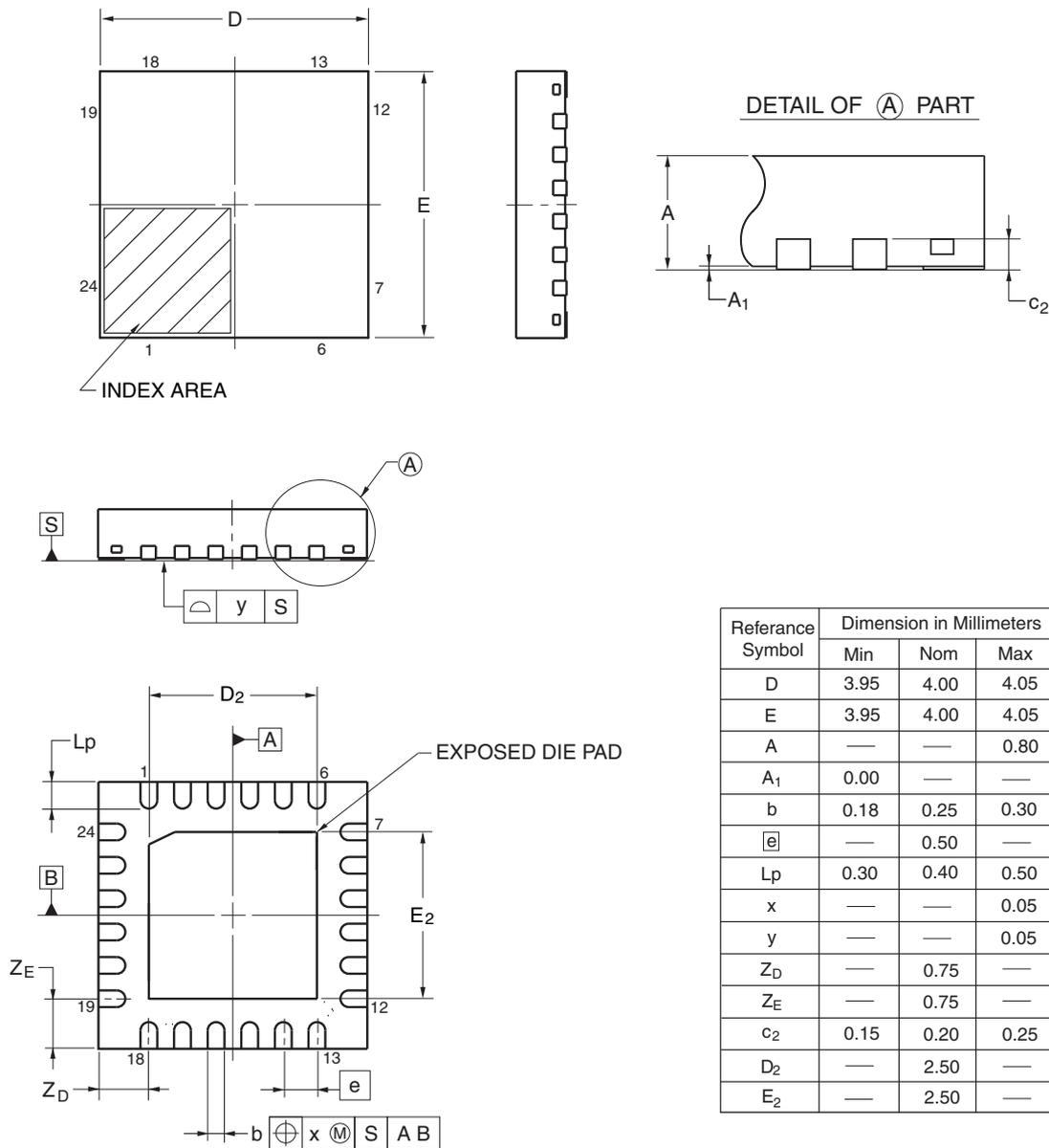
ITEM	DIMENSIONS
D	6.50±0.10
E	4.40±0.10
HE	6.40±0.20
A	1.45 MAX.
A1	0.10±0.10
A2	1.15
e	0.65±0.12
bp	0.22 <sup>+0.10</sup> <sub>-0.05</sub>
c	0.15 <sup>+0.05</sup> <sub>-0.02</sub>
L	0.50±0.20
y	0.10
θ	0° to 10°

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### 4.2 24-pin products

R5F1057AGNA, R5F1057AANA

JEITA Package code	RENESAS code	Previous code	MASS(TYP.)[g]
P-HWQFN24-4x4-0.50	PWQN0024KE-A	P24K8-50-CAB-3	0.04

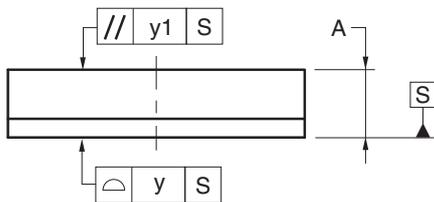
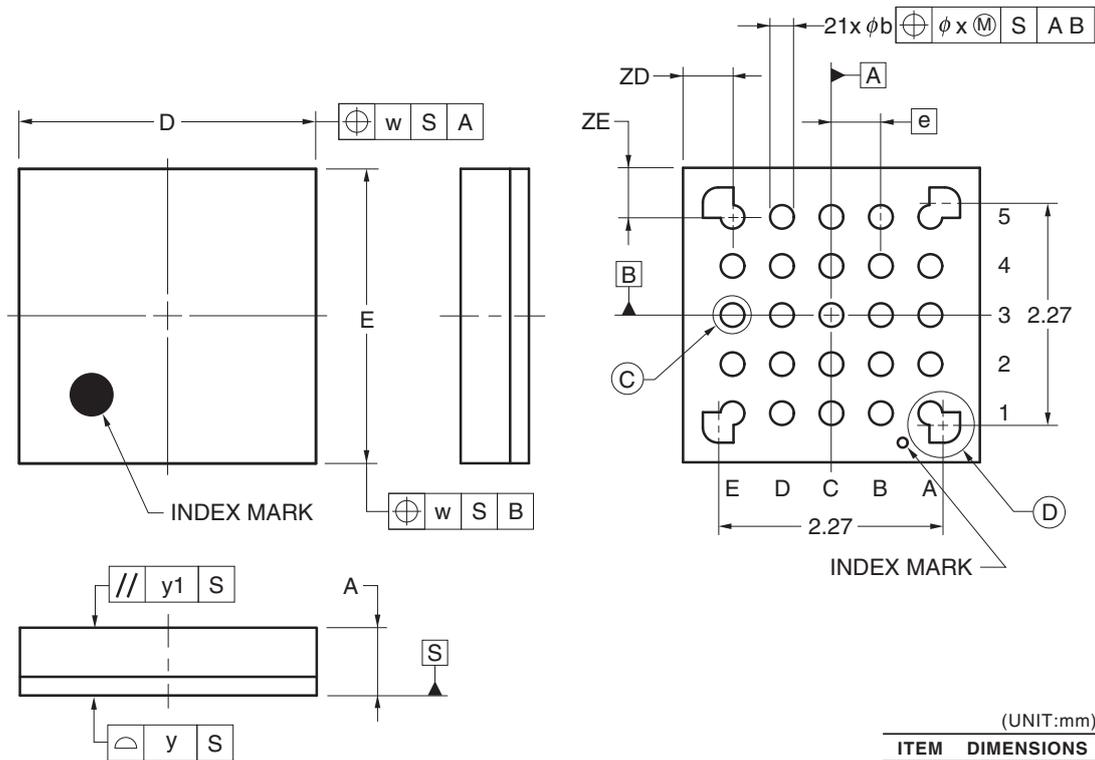


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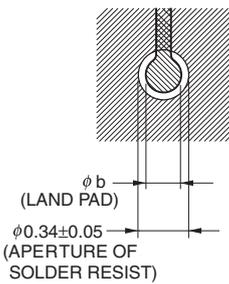
### 4.3 25-pin products

R5F1058AGLA, R5F1058AALA

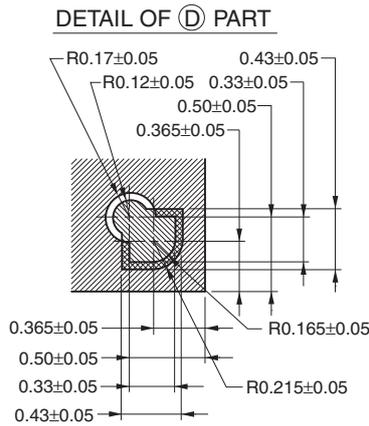
JEITA Package Code	RENESAS Code	Previous Code	MASS (TYP.) [g]
P-WFLGA25-3x3-0.50	PWLG0025KA-A	P25FC-50-2N2-2	0.01



DETAIL OF C PART



DETAIL OF D PART



(UNIT:mm)

ITEM	DIMENSIONS
D	3.00±0.10
E	3.00±0.10
w	0.20
e	0.50
A	0.69±0.07
b	0.24±0.05
x	0.05
y	0.08
y1	0.20
ZD	0.50
ZE	0.50

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## REVISION HISTORY

## RL78/G11 Datasheet

Rev.	Date	Description	
		Page	Summary
1.10	Dec 28 2016	p.4	Modification of 1.2 Ordering Information
1.00	Sep 28 2016	p.7	Modification of Pin Configuration in 1.3.3 25-pin products
		p.9	Addition of 1.5.1 20-pin products
		p.10	Addition of product name and Modification of Block Diagram in 1.5.2 24-pin, 25-pin products
		p.12	Addition of I <sup>2</sup> C bus in 1.6 Outline of Functions
		p.15	Modification of Conditions of I <sub>OH1</sub> , I <sub>OL1</sub> in 2.1 Absolute Maximum Ratings
		p.16	Modification of High-speed on-chip oscillator clock frequency accuracy and addition of D <sub>IMT</sub> , D <sub>IMV</sub> in 2.2.2 On-chip oscillator characteristics
		p.17	Modification of Caution in 2.3.1 Pin characteristics
		p.19	Modification of Input voltage, high and Input voltage, low in 2.3.1 Pin characteristics
		p.19, 20	Modification of Caution in 2.3.1 Pin characteristics
		p.22, 23, 24, 26, 27	Modification of specifications in 2.3.2 Supply current characteristics
		p.29, 30	Modification of specification in 2.4 AC Characteristics
		p.35	Modification of specifications in 2.5.1 Serial array unit (1)
		p.39	Modification of specifications in 2.5.1 Serial array unit (3)
		p.40, 42	Modification of specification in 2.5.1 Serial array unit (4)
		p.62	Addition of LP (Low-power main) mode in 2.5.2 Serial interface IICA (1)
		p.64	Addition of LP (Low-power main) mode in 2.5.2 Serial interface IICA (2)
		p.65	Addition of LP (Low-power main) mode in 2.5.2 Serial interface IICA (3)
		p.70	Modification of Conditions in 2.6.2 Temperature sensor characteristics/internal reference voltage characteristic
		p.79	Addition of description in 3 ELECTRICAL SPECIFICATIONS (TA = -40 to +105°C)
		p.82	Modification of High-speed on-chip oscillator clock frequency accuracy and addition of D <sub>IMT</sub> , D <sub>IMV</sub> in 3.2.2 On-chip oscillator characteristics
		p.83	Modification of Caution in 3.3.1 Pin characteristics
		p.85	Modification of Input voltage, high and Input voltage, low in 3.3.1 Pin characteristics
		p.85, 86	Modification of Caution in 3.3.1 Pin characteristics
p.88 to 91	Modification of specifications in 3.3.2 Supply current characteristics		
p.97	Modification of specifications and specification table in 3.5.1 Serial array unit (1)		
p.103	Modification of specifications in 3.5.1 Serial array unit (3)		
p.125	Modification of Conditions in 3.6.1 A/D converter characteristics (4)		
p.126	Modification of Conditions in 3.6.2 Temperature sensor characteristics/internal reference voltage characteristic		
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## NOTES FOR CMOS DEVICES

- (1) **VOLTAGE APPLICATION WAVEFORM AT INPUT PIN:** Waveform distortion due to input noise or a reflected wave may cause malfunction. If the input of the CMOS device stays in the area between VIL (MAX) and VIH (MIN) due to noise, etc., the device may malfunction. Take care to prevent chattering noise from entering the device when the input level is fixed, and also in the transition period when the input level passes through the area between VIL (MAX) and VIH (MIN).
- (2) **HANDLING OF UNUSED INPUT PINS:** Unconnected CMOS device inputs can be cause of malfunction. If an input pin is unconnected, it is possible that an internal input level may be generated due to noise, etc., causing malfunction. CMOS devices behave differently than Bipolar or NMOS devices. Input levels of CMOS devices must be fixed high or low by using pull-up or pull-down circuitry. Each unused pin should be connected to VDD or GND via a resistor if there is a possibility that it will be an output pin. All handling related to unused pins must be judged separately for each device and according to related specifications governing the device.
- (3) **PRECAUTION AGAINST ESD:** A strong electric field, when exposed to a MOS device, can cause destruction of the gate oxide and ultimately degrade the device operation. Steps must be taken to stop generation of static electricity as much as possible, and quickly dissipate it when it has occurred. Environmental control must be adequate. When it is dry, a humidifier should be used. It is recommended to avoid using insulators that easily build up static electricity. Semiconductor devices must be stored and transported in an anti-static container, static shielding bag or conductive material. All test and measurement tools including work benches and floors should be grounded. The operator should be grounded using a wrist strap. Semiconductor devices must not be touched with bare hands. Similar precautions need to be taken for PW boards with mounted semiconductor devices.
- (4) **STATUS BEFORE INITIALIZATION:** Power-on does not necessarily define the initial status of a MOS device. Immediately after the power source is turned ON, devices with reset functions have not yet been initialized. Hence, power-on does not guarantee output pin levels, I/O settings or contents of registers. A device is not initialized until the reset signal is received. A reset operation must be executed immediately after power-on for devices with reset functions.
- (5) **POWER ON/OFF SEQUENCE:** In the case of a device that uses different power supplies for the internal operation and external interface, as a rule, switch on the external power supply after switching on the internal power supply. When switching the power supply off, as a rule, switch off the external power supply and then the internal power supply. Use of the reverse power on/off sequences may result in the application of an overvoltage to the internal elements of the device, causing malfunction and degradation of internal elements due to the passage of an abnormal current. The correct power on/off sequence must be judged separately for each device and according to related specifications governing the device.
- (6) **INPUT OF SIGNAL DURING POWER OFF STATE :** Do not input signals or an I/O pull-up power supply while the device is not powered. The current injection that results from input of such a signal or I/O pull-up power supply may cause malfunction and the abnormal current that passes in the device at this time may cause degradation of internal elements. Input of signals during the power off state must be judged separately for each device and according to related specifications governing the device.

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#### Renesas Electronics America Inc.

2801 Scott Boulevard Santa Clara, CA 95050-2549, U.S.A.  
Tel: +1-408-588-6000, Fax: +1-408-588-6130

#### Renesas Electronics Canada Limited

9251 Yonge Street, Suite 8309 Richmond Hill, Ontario Canada L4C 9T3  
Tel: +1-905-237-2004

#### Renesas Electronics Europe Limited

Dukes Meadow, Millboard Road, Bourne End, Buckinghamshire, SL8 5FH, U.K.  
Tel: +44-1628-585-100, Fax: +44-1628-585-900

#### Renesas Electronics Europe GmbH

Arcadiastrasse 10, 40472 Düsseldorf, Germany  
Tel: +49-211-6503-0, Fax: +49-211-6503-1327

#### Renesas Electronics (China) Co., Ltd.

Room 1709, Quantum Plaza, No.27 ZhiChunLu Haidian District, Beijing 100191, P.R.China  
Tel: +86-10-8235-1155, Fax: +86-10-8235-7679

#### Renesas Electronics (Shanghai) Co., Ltd.

Unit 301, Tower A, Central Towers, 555 Langao Road, Putuo District, Shanghai, P. R. China 200333  
Tel: +86-21-2226-0888, Fax: +86-21-2226-0999

#### Renesas Electronics Hong Kong Limited

Unit 1601-1611, 16/F., Tower 2, Grand Century Place, 193 Prince Edward Road West, Mongkok, Kowloon, Hong Kong  
Tel: +852-2265-6688, Fax: +852 2886-9022

#### Renesas Electronics Taiwan Co., Ltd.

13F, No. 363, Fu Shing North Road, Taipei 10543, Taiwan  
Tel: +886-2-8175-9600, Fax: +886 2-8175-9670

#### Renesas Electronics Singapore Pte. Ltd.

80 Bendemeer Road, Unit #06-02 Hyflux Innovation Centre, Singapore 339949  
Tel: +65-6213-0200, Fax: +65-6213-0300

#### Renesas Electronics Malaysia Sdn.Bhd.

Unit 1207, Block B, Menara Amcorp, Amcorp Trade Centre, No. 18, Jln Persiaran Barat, 46050 Petaling Jaya, Selangor Darul Ehsan, Malaysia  
Tel: +60-3-7955-9390, Fax: +60-3-7955-9510

#### Renesas Electronics India Pvt. Ltd.

No.77C, 100 Feet Road, HAL II Stage, Indiranagar, Bangalore, India  
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12F., 234 Teheran-ro, Gangnam-Gu, Seoul, 135-080, Korea  
Tel: +82-2-558-3737, Fax: +82-2-558-5141